

# DDR2 SDRAM

**MT47R256M4 – 32 Meg x 4 x 8 banks**
**MT47R128M8 – 16 Meg x 8 x 8 banks**
**MT47R64M16 – 8 Meg x 16 x 8 banks**

## Features

- $V_{DD}/V_{DDQ} = +1.55V$ , 1.5–1.9V range
- Backward compatible with 1.8V DDR2
- JEDEC-standard 1.8V I/O (SSTL\_18-compatible)
- Differential data strobe (DQS, DQS#) option
- 4n-bit prefetch architecture
- Duplicate output strobe (RDQS) option for x8
- DLL to align DQ and DQS transitions with CK
- 8 internal banks for concurrent operation
- Programmable CAS latency (CL)
- Posted CAS additive latency (AL)
- WRITE latency = READ latency - 1  $t_{CK}$
- Selectable burst lengths (BL): 4 or 8
- Adjustable data-output drive strength
- 64ms, 8192-cycle refresh
- On-die termination (ODT)
- Industrial temperature (IT) option
- RoHS compliant
- Supports JEDEC clock jitter specification
- Very low power operation

## Options<sup>1</sup>

- Configuration
  - 256 Meg x 4 (32 Meg x 4 x 8 banks) 256M4
  - 128 Meg x 8 (16 Meg x 8 x 8 banks) 128M8
  - 64 Meg x 16 (8 Meg x 16 x 8 banks) 64M16
- FBGA package (Pb-free) – x16
  - 84-ball FBGA (8mm x 12.5mm) HR
  - Rev. G, H
- FBGA package (Pb-free) – x4, x8
  - 60-ball FBGA (8mm x 11.5mm) HQ
  - Rev. G
  - 60-ball FBGA (8mm x 10mm) CF
  - Rev. H
- Timing – cycle time
  - 2.5ns @ CL = 5 (DDR2-800) -25E
  - 2.5ns @ CL = 6 (DDR2-800) -25
  - 3.0ns @ CL = 4 (DDR2-667) -3E
  - 3.0ns @ CL = 5 (DDR2-667) -3
  - 3.75ns @ CL = 4 (DDR2-533) -37E
- Operating temperature
  - Commercial ( $0^{\circ}C \leq T_C \leq 85^{\circ}C$ ) None
  - Industrial ( $-40^{\circ}C \leq T_C \leq 95^{\circ}C$ ;  $-40^{\circ}C \leq T_A \leq 85^{\circ}C$ ) IT
  - Automotive ( $-40^{\circ}C \leq T_C, T_A \leq 105^{\circ}C$ ) AT
- Revision :G/:H

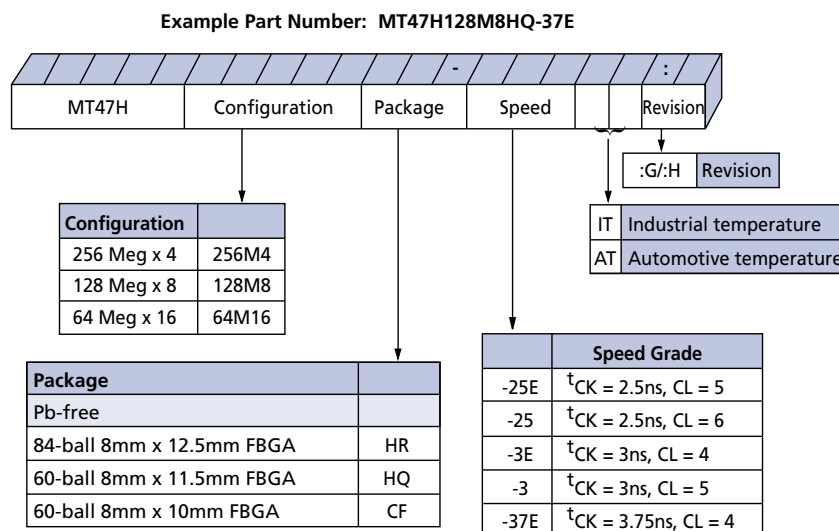
Note: 1. Not all options listed can be combined to define an offered product. Use the Part Catalog Search on [www.micron.com](http://www.micron.com) for product offerings and availability.

**Table 1: Key Timing Parameters**

| Speed Grade | Data Rate (MT/s) |        |        |        |        | $t_{RC}$ (ns) |
|-------------|------------------|--------|--------|--------|--------|---------------|
|             | CL = 3           | CL = 4 | CL = 5 | CL = 6 | CL = 7 |               |
| -25E        | 400              | 533    | 800    | 800    | n/a    | 55            |
| -25         | 400              | 533    | 667    | 800    | n/a    | 55            |
| -3E         | 400              | 667    | 667    | n/a    | n/a    | 54            |
| -3          | 400              | 533    | 667    | n/a    | n/a    | 55            |
| -37E        | 400              | 533    | n/a    | n/a    | n/a    | 55            |

**Table 2: Addressing**

| Parameter      | 256 Meg x 4          | 128 Meg x 8          | 64 Meg x 16          |
|----------------|----------------------|----------------------|----------------------|
| Configuration  | 32 Meg x 4 x 8 banks | 16 Meg x 8 x 8 banks | 8 Meg x 16 x 8 banks |
| Refresh count  | 8K                   | 8K                   | 8K                   |
| Row address    | A[13:0] (16K)        | A[13:0] (16K)        | A[12:0] (8K)         |
| Bank address   | BA[2:0] (8)          | BA[2:0] (8)          | BA[2:0] (8)          |
| Column address | A[11, 9:0] (2K)      | A[9:0] (1K)          | A[9:0] (1K)          |

**Figure 1: 1Gb DDR2 Part Numbers**


Note: 1. Not all speeds and configurations are available in all packages.

## FBGA Part Number System

Due to space limitations, FBGA-packaged components have an abbreviated part marking that is different from the part number. For a quick conversion of an FBGA code, see the FBGA Part Marking Decoder on Micron's Web site: <http://www.micron.com>.

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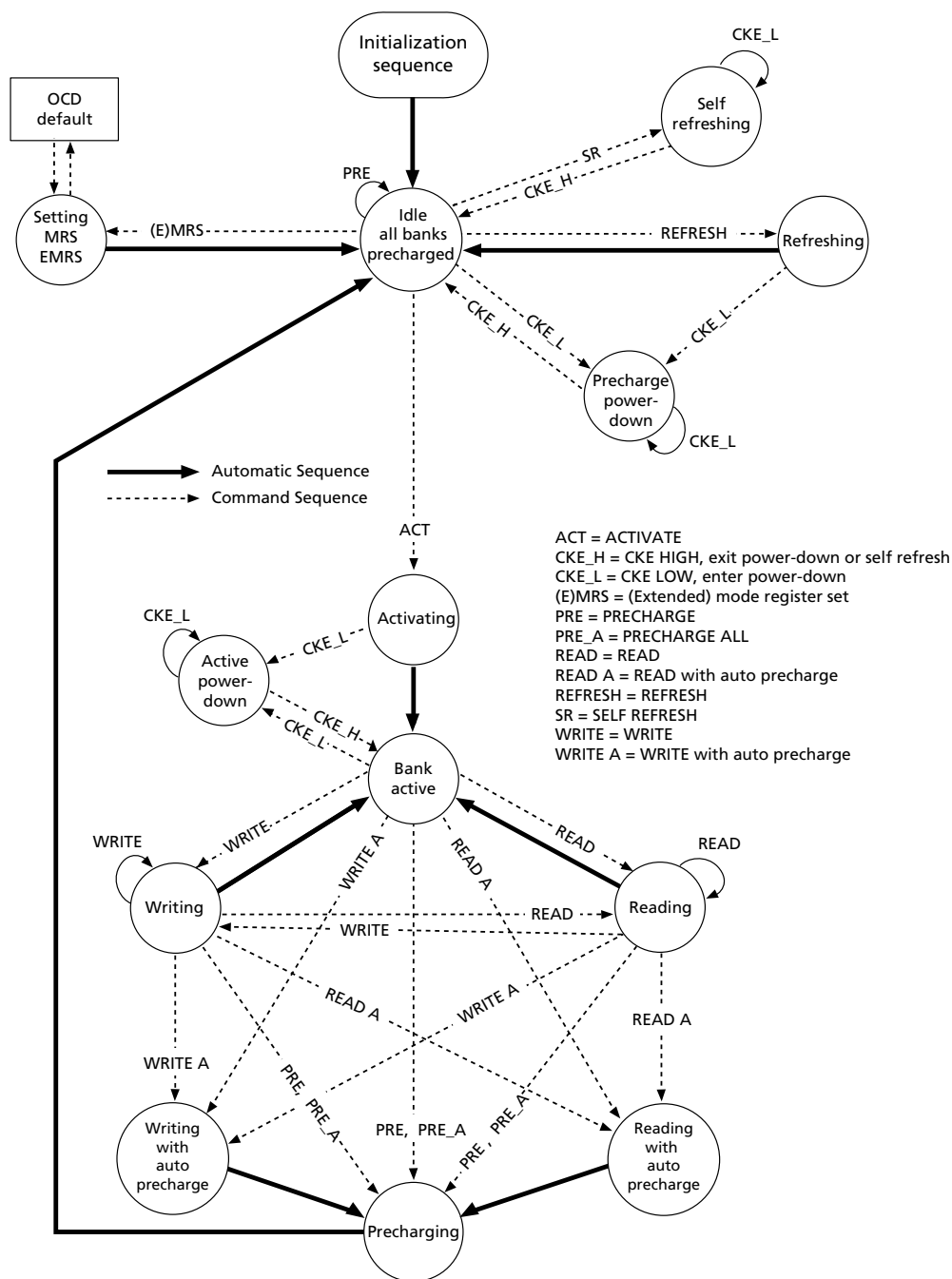
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## State Diagram

**Figure 2: Simplified State Diagram**



Note: 1. This diagram provides the basic command flow. It is not comprehensive and does not identify all timing requirements or possible command restrictions such as multibank interaction, power down, entry/exit, etc.

## Functional Description

The 1Gb 1.55V DDR2 SDRAM is a lower-voltage device and backward compatible with the 1.8V DDR2 device. The differences between the 1.55V and 1.8V DDR2 devices will be noted.

The DDR2 SDRAM uses a double data rate architecture to achieve high-speed operation. The double data rate architecture is essentially a  $4n$ -prefetch architecture, with an interface designed to transfer two data words per clock cycle at the I/O balls. A single read or write access for the DDR2 SDRAM effectively consists of a single  $4n$ -bit-wide, one-clock-cycle data transfer at the internal DRAM core and four corresponding  $n$ -bit-wide, one-half-clock-cycle data transfers at the I/O balls.

A bidirectional data strobe (DQS, DQS#) is transmitted externally, along with data, for use in data capture at the receiver. DQS is a strobe transmitted by the DDR2 SDRAM during READs and by the memory controller during WRITEs. DQS is edge-aligned with data for READs and center-aligned with data for WRITEs. The x16 offering has two data strobes, one for the lower byte (LDQS, LDQS#) and one for the upper byte (UDQS, UDQS#).

The DDR2 SDRAM operates from a differential clock (CK and CK#); the crossing of CK going HIGH and CK# going LOW will be referred to as the positive edge of CK. Commands (address and control signals) are registered at every positive edge of CK. Input data is registered on both edges of DQS, and output data is referenced to both edges of DQS as well as to both edges of CK.

Read and write accesses to the DDR2 SDRAM are burst-oriented; accesses start at a selected location and continue for a programmed number of locations in a programmed sequence. Accesses begin with the registration of an ACTIVATE command, which is then followed by a READ or WRITE command. The address bits registered coincident with the ACTIVATE command are used to select the bank and row to be accessed. The address bits registered coincident with the READ or WRITE command are used to select the bank and the starting column location for the burst access.

The DDR2 SDRAM provides for programmable read or write burst lengths of four or eight locations. DDR2 SDRAM supports interrupting a burst read of eight with another read or a burst write of eight with another write. An auto precharge function may be enabled to provide a self-timed row precharge that is initiated at the end of the burst access.

As with standard DDR SDRAM, the pipelined, multibank architecture of DDR2 SDRAM enables concurrent operation, thereby providing high, effective bandwidth by hiding row precharge and activation time.

A self refresh mode is provided, along with a power-saving, power-down mode.

All inputs are compatible with the JEDEC standard for SSTL<sub>18</sub>. All full drive-strength outputs are SSTL<sub>18</sub>-compatible.

## Industrial Temperature

The industrial temperature (IT) option, if offered, has two simultaneous requirements: ambient temperature surrounding the device cannot be less than  $-40^{\circ}\text{C}$  or greater than  $+85^{\circ}\text{C}$ , and the case temperature cannot be less than  $-40^{\circ}\text{C}$  or greater than  $+95^{\circ}\text{C}$ . JEDEC specifications require the refresh rate to double when  $T_C$  exceeds  $+85^{\circ}\text{C}$ ; this also requires use of the high-temperature self refresh option. Additionally, ODT resistance and the input/output impedance must be derated when  $T_C$  is  $< 0^{\circ}\text{C}$  or  $> +85^{\circ}\text{C}$ .

## Automotive Temperature

The automotive temperature (AT) option, if offered, has two simultaneous requirements: ambient temperature surrounding the device cannot be less than  $-40^{\circ}\text{C}$  or greater than  $+105^{\circ}\text{C}$ , and the case temperature cannot be less than  $-40^{\circ}\text{C}$  or greater than  $+105^{\circ}\text{C}$ . JEDEC specifications require the refresh rate to double when  $T_C$  exceeds  $+85^{\circ}\text{C}$ ; this also requires use of the high-temperature self refresh option. Additionally, ODT resistance and the input/output impedance must be derated when  $T_C$  is  $< 0^{\circ}\text{C}$  or  $> +85^{\circ}\text{C}$ .

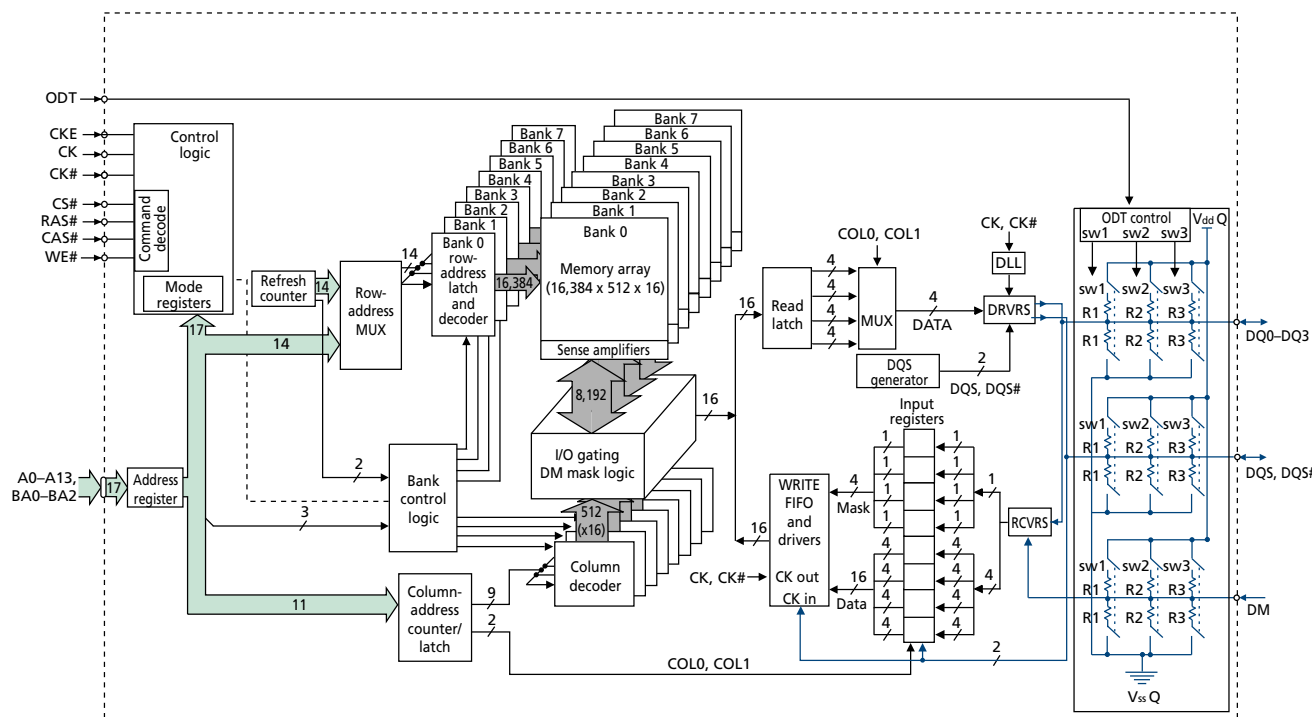
## General Notes

- The functionality and the timing specifications discussed in this data sheet are for the DLL-enabled mode of operation.
- Throughout the data sheet, the various figures and text refer to DQs as “DQ.” The DQ term is to be interpreted as any and all DQ collectively, unless specifically stated otherwise. Additionally, the x16 is divided into 2 bytes: the lower byte and the upper byte. For the lower byte (DQ0–DQ7), DM refers to LDM and DQS refers to LDQS. For the upper byte (DQ8–DQ15), DM refers to UDM and DQS refers to UDQS.
- Complete functionality is described throughout the document, and any page or diagram may have been simplified to convey a topic and may not be inclusive of all requirements.
- Any specific requirement takes precedence over a general statement.

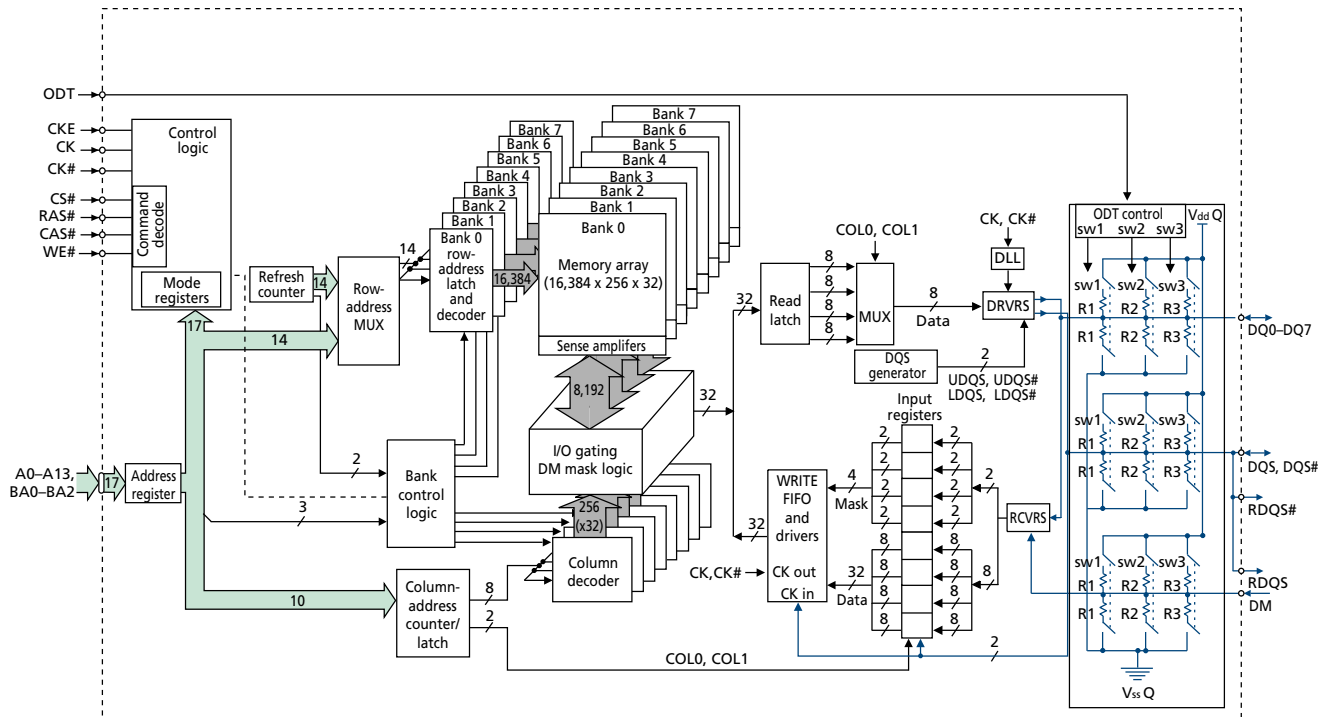
## Functional Block Diagrams

The DDR2 SDRAM is a high-speed CMOS, dynamic random access memory. It is internally configured as a multibank DRAM.

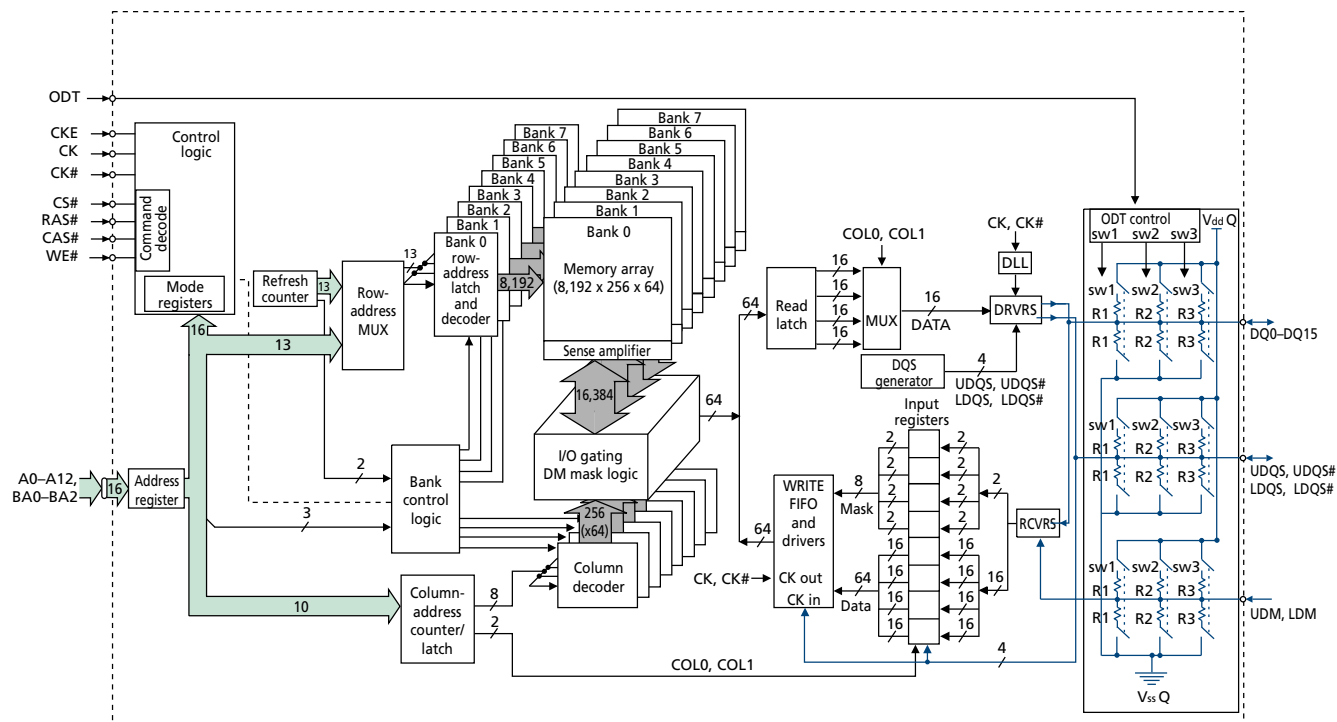
**Figure 3: 256 Meg x 4 Functional Block Diagram**



**Figure 4: 128 Meg x 8 Functional Block Diagram**

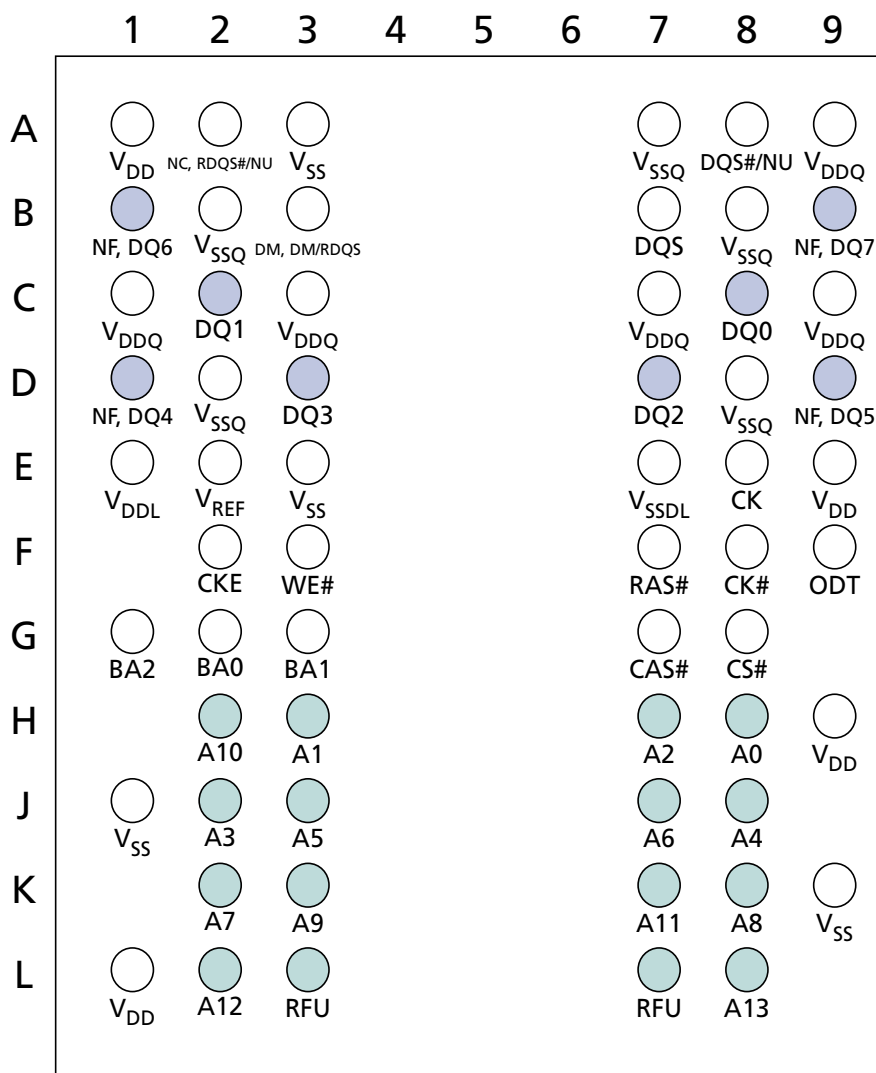


**Figure 5: 64 Meg x 16 Functional Block Diagram**



## Ball Assignments and Descriptions

**Figure 6: 60-Ball FBGA – x4, x8 Ball Assignments (Top View)**



**Figure 7: 84-Ball FBGA – x16 Ball Assignments (Top View)**

|   | 1                                                                                                   | 2                                                                                                  | 3                                                                                                  | 4 | 5 | 6 | 7                                                                                                     | 8                                                                                                    | 9                                                                                                     |
|---|-----------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------|---|---|---|-------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------|
| A |  V <sub>DD</sub>   |  NC               |  V <sub>SS</sub>  |   |   |   |  V <sub>SSQ</sub>  |  UDQS#/NU         |  V <sub>DDQ</sub>  |
| B |  DQ14              |  V <sub>SSQ</sub> |  UDM              |   |   |   |  UDQS              |  V <sub>SSQ</sub> |  DQ15              |
| C |  V <sub>DDQ</sub>  |  DQ9              |  V <sub>DDQ</sub> |   |   |   |  V <sub>DDQ</sub>  |  DQ8              |  V <sub>DDQ</sub>  |
| D |  DQ12              |  V <sub>SSQ</sub> |  DQ11             |   |   |   |  DQ10              |  V <sub>SSQ</sub> |  DQ13              |
| E |  V <sub>DD</sub>   |  NC               |  V <sub>SS</sub>  |   |   |   |  V <sub>SSQ</sub>  |  LDQS#/NU         |  V <sub>DDQ</sub>  |
| F |  DQ6               |  V <sub>SSQ</sub> |  LDM              |   |   |   |  LDQS              |  V <sub>SSQ</sub> |  DQ7               |
| G |  V <sub>DDQ</sub>  |  DQ1              |  V <sub>DDQ</sub> |   |   |   |  V <sub>DDQ</sub>  |  DQ0              |  V <sub>DDQ</sub>  |
| H |  DQ4               |  V <sub>SSQ</sub> |  DQ3              |   |   |   |  DQ2               |  V <sub>SSQ</sub> |  DQ5               |
| J |  V <sub>DDL</sub>  |  V <sub>REF</sub> |  V <sub>SS</sub>  |   |   |   |  V <sub>SSDL</sub> |  CK               |  V <sub>DD</sub>   |
| K |                                                                                                     |  CKE            |  WE#            |   |   |   |  RAS#            |  CK#            |  ODT             |
| L |  BA2             |  BA0            |  BA1            |   |   |   |  CAS#            |  CS#            |                                                                                                       |
| M |                                                                                                     |  A10            |  A1             |   |   |   |  A2              |  A0             |  V <sub>DD</sub> |
| N |  V <sub>SS</sub> |  A3             |  A5             |   |   |   |  A6              |  A4             |                                                                                                       |
| P |                                                                                                     |  A7             |  A9             |   |   |   |  A11             |  A8             |  V <sub>SS</sub> |
| R |  V <sub>DD</sub> |  A12            |  RFU            |   |   |   |  RFU             |  RFU            |                                                                                                       |

**Table 3: FBGA 84-Ball – x16 and 60-Ball – x4, x8 Descriptions**

| Symbol                                         | Type  | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|------------------------------------------------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| A[12:0] (x16)<br>A[13:0] (x4, x8)              | Input | <b>Address inputs:</b> Provide the row address for ACTIVATE commands, and the column address and auto precharge bit (A10) for READ/WRITE commands, to select one location out of the memory array in the respective bank. A10 sampled during a PRECHARGE command determines whether the PRECHARGE applies to one bank (A10 LOW, bank selected by BA[2:0] or all banks (A10 HIGH). The address inputs also provide the op-code during a LOAD MODE command.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| BA[2:0]                                        | Input | <b>Bank address inputs:</b> BA[2:0] define to which bank an ACTIVATE, READ, WRITE, or PRECHARGE command is being applied. BA[2:0] define which mode register, including MR, EMR, EMR(2), and EMR(3), is loaded during the LOAD MODE command.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
| CK, CK#                                        | Input | <b>Clock:</b> CK and CK# are differential clock inputs. All address and control input signals are sampled on the crossing of the positive edge of CK and negative edge of CK#. Output data (DQ and DQS/DQS#) is referenced to the crossings of CK and CK#.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| CKE                                            | Input | <b>Clock enable:</b> CKE (registered HIGH) activates and CKE (registered LOW) deactivates clocking circuitry on the DDR2 SDRAM. The specific circuitry that is enabled/disabled is dependent on the DDR2 SDRAM configuration and operating mode. CKE LOW provides precharge power-down and SELF REFRESH operations (all banks idle), or ACTIVATE power-down (row active in any bank). CKE is synchronous for power-down entry, power-down exit, output disable, and for self refresh entry. CKE is asynchronous for self refresh exit. Input buffers (excluding CK, CK#, CKE, and ODT) are disabled during power-down. Input buffers (excluding CKE) are disabled during self refresh. CKE is an SSTL_18 input but will detect a LVCMOS LOW level after V <sub>DD</sub> is applied during first power-up. After V <sub>REF</sub> has become stable during the power-on and initialization sequence, it must be maintained for proper operation of the CKE receiver. For proper SELF REFRESH operation, V <sub>REF</sub> must be maintained. |
| CS#                                            | Input | <b>Chip select:</b> CS# enables (registered LOW) and disables (registered HIGH) the command decoder. All commands are masked when CS# is registered high. CS# provides for external bank selection on systems with multiple ranks. CS# is considered part of the command code.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| LDM, UDM, DM                                   | Input | <b>Input data mask:</b> DM is an input mask signal for write data. Input data is masked when DM is sampled HIGH along with that input data during a WRITE access. DM is sampled on both edges of DQS. Although DM balls are input-only, the DM loading is designed to match that of DQ and DQS balls. LDM is DM for lower byte DQ[7:0] and UDM is DM for upper byte DQ[15:8].                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
| ODT                                            | Input | <b>On-die termination:</b> ODT (registered HIGH) enables termination resistance internal to the DDR2 SDRAM. When enabled, ODT is only applied to each of the following balls: DQ[15:0], LDM, UDM, LDQS, LDQS#, UDQS, and UDQS# for the x16; DQ[7:0], DQS, DQS#, RDQS, RDQS#, and DM for the x8; DQ0–DQ3, DQS, DQS#, and DM for the x4. The ODT input will be ignored if disabled via the LOAD MODE command.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
| RAS#, CAS#, WE#                                | Input | <b>Command inputs:</b> RAS#, CAS#, and WE# (along with CS#) define the command being entered.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
| DQ[15:0] (x16)<br>DQ[3:0] (x4)<br>DQ[7:0] (x8) | I/O   | <b>Data input/output:</b> Bidirectional data bus for 64 Meg x 16.<br>Bidirectional data bus for 256 Meg x 4.<br>Bidirectional data bus for 128 Meg x 8.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |

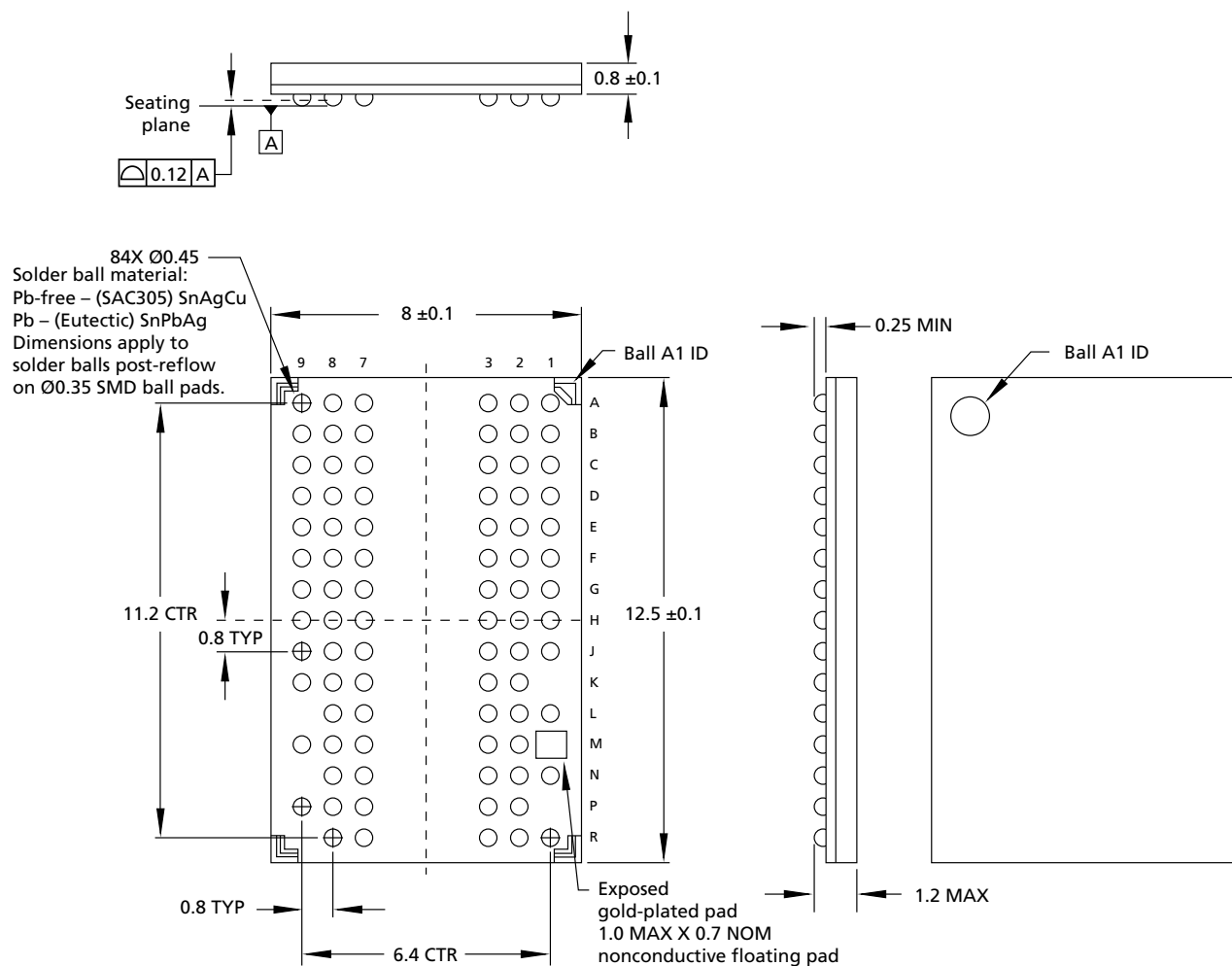
**Table 3: FBGA 84-Ball – x16 and 60-Ball – x4, x8 Descriptions (Continued)**

| Symbol            | Type   | Description                                                                                                                                                                                                                                                                                                                                                                                |
|-------------------|--------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| DQS, DQS#         | I/O    | <b>Data strobe:</b> Output with read data, input with write data for source synchronous operation. Edge-aligned with read data, center-aligned with write data. DQS# is only used when differential data strobe mode is enabled via the LOAD MODE command.                                                                                                                                 |
| LDQS, LDQS#       | I/O    | <b>Data strobe for lower byte:</b> Output with read data, input with write data for source synchronous operation. Edge-aligned with read data, center-aligned with write data. LDQS# is only used when differential data strobe mode is enabled via the LOAD MODE command.                                                                                                                 |
| UDQS, UDQS#       | I/O    | <b>Data strobe for upper byte:</b> Output with read data, input with write data for source synchronous operation. Edge-aligned with read data, center-aligned with write data. UDQS# is only used when differential data strobe mode is enabled via the LOAD MODE command.                                                                                                                 |
| RDQS, RDQS#       | Output | <b>Redundant data strobe:</b> For x8 only. RDQS is enabled/disabled via the LOAD MODE command to the extended mode register (EMR). When RDQS is enabled, RDQS is output with read data only and is ignored during write data. When RDQS is disabled, ball B3 becomes data mask (see DM ball). RDQS# is only used when RDQS is enabled <i>and</i> differential data strobe mode is enabled. |
| V <sub>DD</sub>   | Supply | <b>Power supply:</b> 1.55V, –0.05V, +0.35V                                                                                                                                                                                                                                                                                                                                                 |
| V <sub>DDQ</sub>  | Supply | <b>DQ power supply:</b> 1.55V, –0.05V, +0.35V. Isolated on the device for improved noise immunity.                                                                                                                                                                                                                                                                                         |
| V <sub>DDL</sub>  | Supply | <b>DLL power supply:</b> 1.55V, –0.05V, +0.35V                                                                                                                                                                                                                                                                                                                                             |
| V <sub>REF</sub>  | Supply | SSTL_18 reference voltage (V <sub>DDQ</sub> /2).                                                                                                                                                                                                                                                                                                                                           |
| V <sub>SS</sub>   | Supply | Ground.                                                                                                                                                                                                                                                                                                                                                                                    |
| V <sub>SSDL</sub> | Supply | <b>DLL ground:</b> Isolated on the device from V <sub>SS</sub> and V <sub>SSQ</sub> .                                                                                                                                                                                                                                                                                                      |
| V <sub>SSQ</sub>  | Supply | <b>DQ ground:</b> Isolated on the device for improved noise immunity.                                                                                                                                                                                                                                                                                                                      |
| NC                | –      | <b>No connect:</b> These balls should be left unconnected.                                                                                                                                                                                                                                                                                                                                 |
| NF                | –      | <b>No function:</b> x8: these balls are used as DQ4–DQ7; x4: they are no function.                                                                                                                                                                                                                                                                                                         |
| NU                | –      | <b>Not used:</b> For x16 only. If EMR(E10) = 0, A8 and E8 are UDQS# and LDQS#. If EMR(E10) = 1, then A8 and E8 are not used.                                                                                                                                                                                                                                                               |
| NU                | –      | <b>Not used:</b> For x8 only. If EMR(E10) = 0, A2 and E8 are RDQS# and DQS#. If EMR(E10) = 1, then A2 and E8 are not used.                                                                                                                                                                                                                                                                 |
| RFU               | –      | <b>Reserved for future use:</b> Row address bits A13 (x16 only), A14, and A15.                                                                                                                                                                                                                                                                                                             |

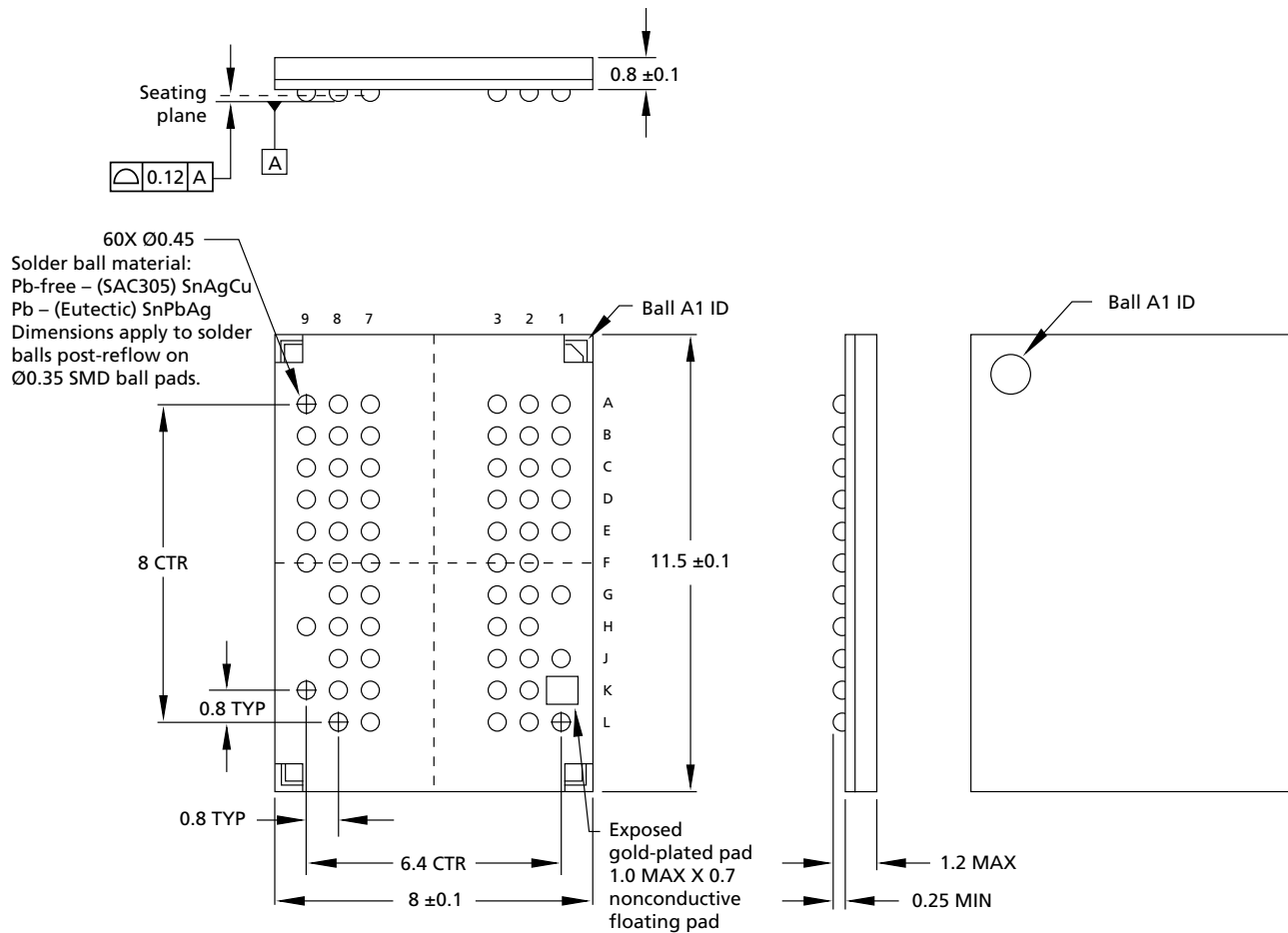
## Packaging

### Package Dimensions

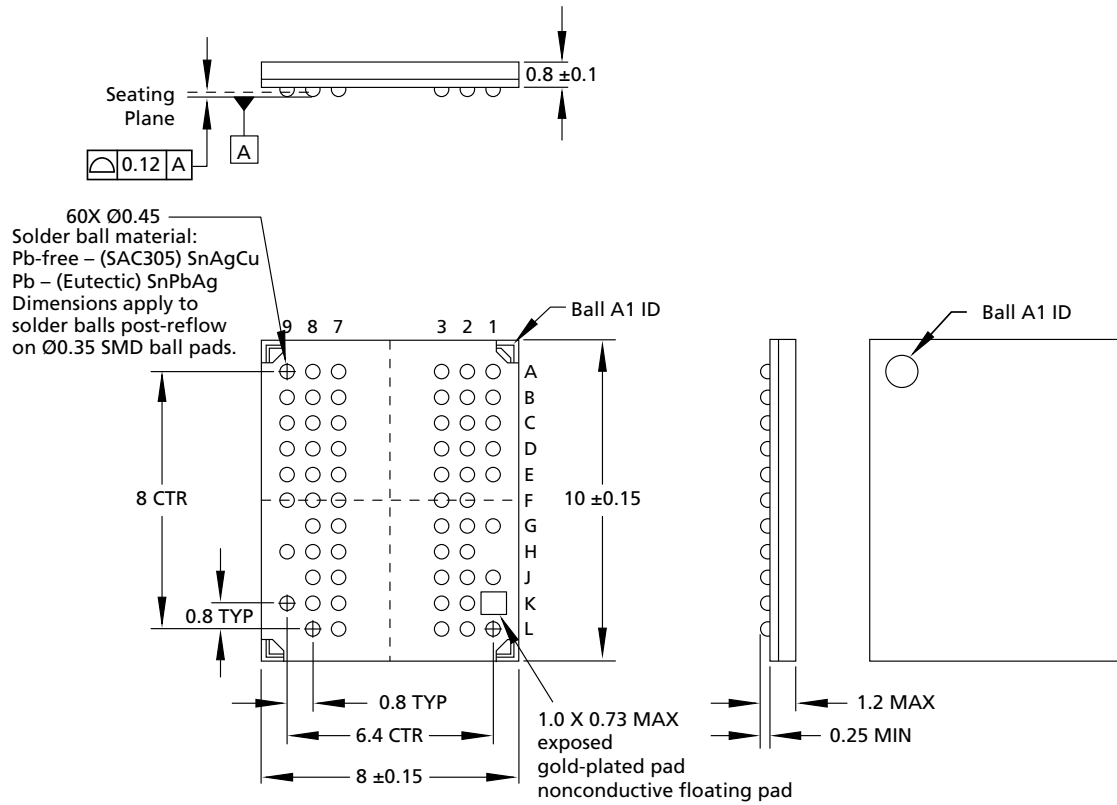
**Figure 8: 84-Ball FBGA Package (8mm x 12.5mm) – x16**



Note: 1. All dimensions are in millimeters.

**Figure 9: 60-Ball FBGA Package (8mm x 11.5mm) – x4, x8**


Note: 1. All dimensions are in millimeters.

**Figure 10: 60-Ball FBGA (8mm x 10mm) – x4, x8**


Note: 1. All dimensions are in millimeters.

## FBGA Package Capacitance

**Table 4: Input Capacitance**

| Parameter                                                                                  | Symbol    | Min | Max  | Units | Notes |
|--------------------------------------------------------------------------------------------|-----------|-----|------|-------|-------|
| Input capacitance: CK, CK#                                                                 | $C_{CK}$  | 1.0 | 2.0  | pF    | 1     |
| Delta input capacitance: CK, CK#                                                           | $C_{DCK}$ | –   | 0.25 | pF    | 2, 3  |
| Input capacitance: Address balls, bank address balls, CS#, RAS#, CAS#, WE#, CKE, ODT       | $C_I$     | 1.0 | 2.0  | pF    | 1, 4  |
| Delta input capacitance: Address balls, bank address balls, CS#, RAS#, CAS#, WE#, CKE, ODT | $C_{DI}$  | –   | 0.25 | pF    | 2, 3  |
| Input/output capacitance: DQ, DQS, DM, NF                                                  | $C_{IO}$  | 2.5 | 4.0  | pF    | 1, 5  |
| Delta input/output capacitance: DQ, DQS, DM, NF                                            | $C_{DIO}$ | –   | 0.5  | pF    | 2, 3  |

- Notes:
1. This parameter is sampled.  $V_{DD} = +1.8V \pm 0.1V$ ,  $V_{DDQ} = +1.8V \pm 0.1V$ ,  $V_{REF} = V_{SS}$ ,  $f = 100$  MHz,  $T_C = 25^\circ C$ ,  $V_{OUT(DC)} = V_{DDQ}/2$ ,  $V_{OUT}$  (peak-to-peak) = 0.1V. DM input is grouped with I/O balls, reflecting the fact that they are matched in loading.
  2. The capacitance per ball group will not differ by more than this maximum amount for any given device.
  3.  $\Delta C$  are not pass/fail parameters; they are targets.
  4. Reduce MAX limit by 0.25pF for -25, -25E, and -187E speed devices.
  5. Reduce MAX limit by 0.5pF for -3, -3E, -25, -25E, and -187E speed devices.

## Electrical Specifications – Absolute Ratings

Stresses greater than those listed may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions outside those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

**Table 5: Absolute Maximum DC Ratings**

| Parameter                                                                                                     | Symbol                             | Min  | Max | Units | Notes |
|---------------------------------------------------------------------------------------------------------------|------------------------------------|------|-----|-------|-------|
| V <sub>DD</sub> supply voltage relative to V <sub>SS</sub>                                                    | V <sub>DD</sub>                    | –1.0 | 2.3 | V     | 1     |
| V <sub>DDQ</sub> supply voltage relative to V <sub>SSQ</sub>                                                  | V <sub>DDQ</sub>                   | –0.5 | 2.3 | V     | 1, 2  |
| V <sub>DDL</sub> supply voltage relative to V <sub>SSL</sub>                                                  | V <sub>DDL</sub>                   | –0.5 | 2.3 | V     | 1     |
| Voltage on any ball relative to V <sub>SS</sub>                                                               | V <sub>IN</sub> , V <sub>OUT</sub> | –0.5 | 2.3 | V     | 3     |
| Input leakage current; any input 0V ≤ V <sub>IN</sub> ≤ V <sub>DD</sub> ; all other balls not under test = 0V | I <sub>I</sub>                     | –5   | 5   | μA    |       |
| Output leakage current; 0V ≤ V <sub>OUT</sub> ≤ V <sub>DDQ</sub> ; DQ and ODT disabled                        | I <sub>OZ</sub>                    | –5   | 5   | μA    |       |
| V <sub>REF</sub> leakage current; V <sub>REF</sub> = Valid V <sub>REF</sub> level                             | I <sub>VREF</sub>                  | –2   | 2   | μA    |       |

- Notes:
1. V<sub>DD</sub>, V<sub>DDQ</sub>, and V<sub>DDL</sub> must be within 300mV of each other at all times; this is not required when power is ramping down.
  2. V<sub>REF</sub> ≤ 0.6 × V<sub>DDQ</sub>; however, V<sub>REF</sub> may be ≥ V<sub>DDQ</sub> provided that V<sub>REF</sub> ≤ 300mV.
  3. Voltage on any I/O may not exceed voltage on V<sub>DDQ</sub>.

## Temperature and Thermal Impedance

It is imperative that the DDR2 SDRAM device's temperature specifications, shown in Table 6 (page 23), be maintained in order to ensure the junction temperature is in the proper operating range to meet data sheet specifications. An important step in maintaining the proper junction temperature is using the device's thermal impedances correctly. The thermal impedances are listed in Table 7 (page 24) for the applicable and available die revision and packages.

Incorrectly using thermal impedances can produce significant errors. Read Micron technical note TN-00-08, “[Thermal Applications](#)” prior to using the thermal impedances listed in Table 7 (page 24). For designs that are expected to last several years and require the flexibility to use several DRAM die shrinks, consider using final target theta values (rather than existing values) to account for increased thermal impedances from the die size reduction.

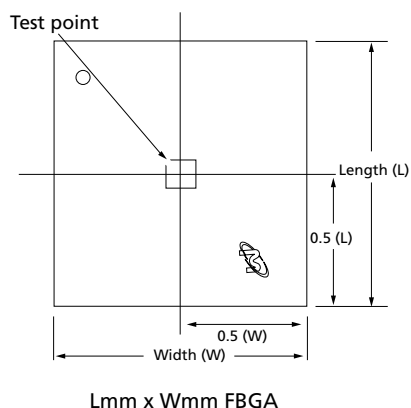
The DDR2 SDRAM device's safe junction temperature range can be maintained when the T<sub>C</sub> specification is not exceeded. In applications where the device's ambient temperature is too high, use of forced air and/or heat sinks may be required in order to satisfy the case temperature specifications.

**Table 6: Temperature Limits**

| Parameter                         | Symbol    | Min | Max | Units | Notes   |
|-----------------------------------|-----------|-----|-----|-------|---------|
| Storage temperature               | $T_{STG}$ | -55 | 150 | °C    | 1       |
| Operating temperature: commercial | $T_C$     | 0   | 85  | °C    | 2, 3    |
| Operating temperature: industrial | $T_C$     | -40 | 95  | °C    | 2, 3, 4 |
|                                   | $T_A$     | -40 | 85  | °C    | 4, 5    |

- Notes:
1. MAX storage case temperature  $T_{STG}$  is measured in the center of the package, as shown in Figure 11. This case temperature limit is allowed to be exceeded briefly during package reflow, as noted in Micron technical note TN-00-15, "Recommended Soldering Parameters."
  2. MAX operating case temperature  $T_C$  is measured in the center of the package, as shown in Figure 11.
  3. Device functionality is not guaranteed if the device exceeds maximum  $T_C$  during operation.
  4. Both temperature specifications must be satisfied.
  5. Operating ambient temperature surrounding the package.

**Figure 11: Example Temperature Test Point Location**



**Table 7: Thermal Impedance**

| Die Revision   | Package | Substrate (pcb) | $\theta_{JA}$ (°C/W)<br>Airflow = 0m/s | $\theta_{JA}$ (°C/W)<br>Airflow = 1m/s | $\theta_{JA}$ (°C/W)<br>Airflow = 2m/s | $\theta_{JB}$ (°C/W) | $\theta_{JC}$ (°C/W) |
|----------------|---------|-----------------|----------------------------------------|----------------------------------------|----------------------------------------|----------------------|----------------------|
| G <sup>1</sup> | 60-ball | 2-layer         | 66.5                                   | 49.6                                   | 43.1                                   | 30.3                 | 5.9                  |
|                |         | 4-layer         | 49.2                                   | 40.4                                   | 36.4                                   | 30                   |                      |
|                | 84-ball | 2-layer         | 60.2                                   | 44.5                                   | 39.3                                   | 26.1                 | 5.6                  |
|                |         | 4-layer         | 44                                     | 35.7                                   | 32.8                                   | 26.1                 |                      |
| H <sup>1</sup> | 60-ball | 2-layer         | 72.5                                   | 55.5                                   | 49.5                                   | 35.6                 | 5.7                  |
|                |         | 4-layer         | 54.5                                   | 45.7                                   | 42.3                                   | 35.2                 |                      |
|                | 84-ball | 2-layer         | 68.8                                   | 52.0                                   | 46.5                                   | 32.5                 | 5.6                  |
|                |         | 4-layer         | 51.3                                   | 42.7                                   | 39.6                                   | 32.3                 |                      |

Note: 1. Thermal resistance data is based on a number of samples from multiple lots and should be viewed as a typical number.

## Electrical Specifications – I<sub>DD</sub> Parameters

### I<sub>DD</sub> Specifications and Conditions

**Table 8: General I<sub>DD</sub> Parameters**

| I <sub>DD</sub> Parameters                        | -25E                                    | -25    | -3E    | -3     | -37E   | Units           |
|---------------------------------------------------|-----------------------------------------|--------|--------|--------|--------|-----------------|
| CL (I <sub>DD</sub> )                             | 5                                       | 6      | 4      | 5      | 4      | t <sub>CK</sub> |
| t <sub>RCD</sub> (I <sub>DD</sub> )               | 12.5                                    | 15     | 12     | 15     | 15     | ns              |
| t <sub>RC</sub> (I <sub>DD</sub> )                | 57.5                                    | 60     | 57     | 60     | 60     | ns              |
| t <sub>RRD</sub> (I <sub>DD</sub> ) - x4/x8 (1KB) | 7.5                                     | 7.5    | 7.5    | 7.5    | 7.5    | ns              |
| t <sub>RRD</sub> (I <sub>DD</sub> ) - x16 (2KB)   | 10                                      | 10     | 10     | 10     | 10     | ns              |
| t <sub>CK</sub> (I <sub>DD</sub> )                | 2.5                                     | 2.5    | 3      | 3      | 3.75   | ns              |
| t <sub>RAS MIN</sub> (I <sub>DD</sub> )           | 45                                      | 45     | 45     | 45     | 45     | ns              |
| t <sub>RAS MAX</sub> (I <sub>DD</sub> )           | 70,000                                  | 70,000 | 70,000 | 70,000 | 70,000 | ns              |
| t <sub>RP</sub> (I <sub>DD</sub> )                | 12.5                                    | 15     | 12     | 15     | 15     | ns              |
| t <sub>RFC</sub> (I <sub>DD</sub> - 256Mb)        | 75                                      | 75     | 75     | 75     | 75     | ns              |
| t <sub>RFC</sub> (I <sub>DD</sub> - 512Mb)        | 105                                     | 105    | 105    | 105    | 105    | ns              |
| t <sub>RFC</sub> (I <sub>DD</sub> - 1Gb)          | 127.5                                   | 127.5  | 127.5  | 127.5  | 127.5  | ns              |
| t <sub>RFC</sub> (I <sub>DD</sub> - 2Gb)          | 195                                     | 195    | 195    | 195    | 195    | ns              |
| t <sub>FAW</sub> (I <sub>DD</sub> ) - x4/x8 (1KB) | Defined by pattern in Table 9 (page 26) |        |        |        |        | ns              |
| t <sub>FAW</sub> (I <sub>DD</sub> ) - x16 (2KB)   | Defined by pattern in Table 9 (page 26) |        |        |        |        | ns              |

## I<sub>DD7</sub> Conditions

The detailed timings are shown below for I<sub>DD7</sub>. Where general I<sub>DD</sub> parameters in Table 8 (page 25) conflict with pattern requirements of Table 9, then Table 9 requirements take precedence.

**Table 9: I<sub>DD7</sub> Timing Patterns (8-Bank Interleave READ Operation)**

| Speed Grade                              | I <sub>DD7</sub> Timing Patterns                                                                |
|------------------------------------------|-------------------------------------------------------------------------------------------------|
| Timing patterns for 8-bank x4/x8 devices |                                                                                                 |
| -37E                                     | A0 RA0 A1 RA1 A2 RA2 A3 RA3 D D A4 RA4 A5 RA5 A6 RA6 A7 RA7 D D                                 |
| -3                                       | A0 RA0 D A1 RA1 D A2 RA2 D A3 RA3 D D A4 RA4 D A5 RA5 D A6 RA6 D A7 RA7 D D                     |
| -3E                                      | A0 RA0 D A1 RA1 D A2 RA2 D A3 RA3 D D A4 RA4 D A5 RA5 D A6 RA6 D A7 RA7 D D                     |
| -25                                      | A0 RA0 D A1 RA1 D A2 RA2 D A3 RA3 D D D A4 RA4 D A5 RA5 D A6 RA6 D A7 RA7 D D D                 |
| -25E                                     | A0 RA0 D A1 RA1 D A2 RA2 D A3 RA3 D D D A4 RA4 D A5 RA5 D A6 RA6 D A7 RA7 D D D                 |
| Timing patterns for 8-bank x16 devices   |                                                                                                 |
| -37E                                     | A0 RA0 D A1 RA1 D A2 RA2 D A3 RA3 D D D A4 RA4 D A5 RA5 D A6 RA6 D A7 RA7 D D D                 |
| -3                                       | A0 RA0 D D A1 RA1 D D A2 RA2 D D A3 RA3 D D D A4 RA4 D D A5 RA5 D D A6 RA6 D D A7 RA7 D D D     |
| -3E                                      | A0 RA0 D D A1 RA1 D D A2 RA2 D D A3 RA3 D D D A4 RA4 D D A5 RA5 D D A6 RA6 D D A7 RA7 D D D     |
| -25                                      | A0 RA0 D D A1 RA1 D D A2 RA2 D D A3 RA3 D D D D A4 RA4 D D A5 RA5 D D A6 RA6 D D A7 RA7 D D D D |
| -25E                                     | A0 RA0 D D A1 RA1 D D A2 RA2 D D A3 RA3 D D D D A4 RA4 D D A5 RA5 D D A6 RA6 D D A7 RA7 D D D D |

- Notes:
1. A = active; RA = read auto precharge; D = deselect.
  2. All banks are being interleaved at <sup>t</sup>RC (I<sub>DD</sub>) without violating <sup>t</sup>RRD (I<sub>DD</sub>) using a BL = 4.
  3. Control and address bus inputs are stable during deselections.

**Table 10: DDR2 I<sub>DD</sub> Specifications and Conditions (Die Revision G)**

Notes: 1–7 apply to the entire table

| Parameter/Condition                                                                                                                                                                                                                                                                                                                                                               | Symbol             | Configuration         | V <sub>DD</sub> | -25E/-25 | -3E/-3 | -37E | Units |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------|-----------------------|-----------------|----------|--------|------|-------|
| <b>Operating one bank active-precharge current:</b> $t_{CK} = t_{CK}(I_{DD})$ , $t_{RC} = t_{RC}(I_{DD})$ , $t_{RAS} = t_{RAS\ MIN}(I_{DD})$ ; CKE is HIGH, CS# is HIGH between valid commands; Address bus inputs are switching; Data bus inputs are switching                                                                                                                   | I <sub>DD0</sub>   | x4, x8                | 1.9             | 90       | 85     | 70   | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 70       | 65     | 60   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    | x16                   | 1.9             | 150      | 135    | 110  |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 120      | 105    | 95   |       |
| <b>Operating one bank active-read-precharge current:</b> I <sub>OUT</sub> = 0mA; BL = 4, CL = CL(I <sub>DD</sub> ), AL = 0; $t_{CK} = t_{CK}(I_{DD})$ , $t_{RC} = t_{RC}(I_{DD})$ , $t_{RAS} = t_{RAS\ MIN}(I_{DD})$ , $t_{RCD} = t_{RCD}(I_{DD})$ ; CKE is HIGH, CS# is HIGH between valid commands; Address bus inputs are switching; Data pattern is same as I <sub>DD4W</sub> | I <sub>DD1</sub>   | x4, x8                | 1.9             | 110      | 100    | 95   | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 80       | 75     | 70   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    | x16                   | 1.9             | 175      | 130    | 120  |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 130      | 100    | 90   |       |
| <b>Precharge power-down current:</b> All banks idle; $t_{CK} = t_{CK}(I_{DD})$ ; CKE is LOW; Other control and address bus inputs are stable; Data bus inputs are floating                                                                                                                                                                                                        | I <sub>DD2P</sub>  | x4, x8, x16           | 1.9             | 7        | 7      | 7    | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 7        | 7      | 7    |       |
| <b>Precharge quiet standby current:</b> All banks idle; $t_{CK} = t_{CK}(I_{DD})$ ; CKE is HIGH, CS# is HIGH; Other control and address bus inputs are stable; Data bus inputs are floating                                                                                                                                                                                       | I <sub>DD2Q</sub>  | x4, x8                | 1.9             | 50       | 40     | 40   | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 30       | 25     | 25   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    | x16                   | 1.9             | 75       | 65     | 45   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 45       | 40     | 30   |       |
| <b>Precharge standby current:</b> All banks idle; $t_{CK} = t_{CK}(I_{DD})$ ; CKE is HIGH, CS# is HIGH; Other control and address bus inputs are switching; Data bus inputs are switching                                                                                                                                                                                         | I <sub>DD2N</sub>  | x4, x8                | 1.9             | 50       | 40     | 40   | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 35       | 30     | 30   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    | x16                   | 1.9             | 80       | 70     | 50   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 55       | 50     | 40   |       |
| <b>Active power-down current:</b> All banks open; $t_{CK} = t_{CK}(I_{DD})$ ; CKE is LOW; Other control and address bus inputs are stable; Data bus inputs are floating                                                                                                                                                                                                           | I <sub>DD3Pf</sub> | Fast exit<br>MR12 = 0 | 1.9             | 40       | 30     | 30   | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 20       | 18     | 18   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   | I <sub>DD3Ps</sub> | Slow exit<br>MR12 = 1 | 1.9             | 10       | 10     | 10   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 7        | 7      | 7    |       |
| <b>Active standby current:</b> All banks open; $t_{CK} = t_{CK}(I_{DD})$ , $t_{RAS} = t_{RAS\ MAX}(I_{DD})$ , $t_{RP} = t_{RP}(I_{DD})$ ; CKE is HIGH, CS# is HIGH between valid commands; Other control and address bus inputs are switching; Data bus inputs are switching                                                                                                      | I <sub>DD3N</sub>  | x4, x8                | 1.9             | 60       | 55     | 45   | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 40       | 35     | 30   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    | x16                   | 1.9             | 85       | 75     | 60   |       |
|                                                                                                                                                                                                                                                                                                                                                                                   |                    |                       | 1.6             | 60       | 55     | 40   |       |

**Table 10: DDR2 I<sub>DD</sub> Specifications and Conditions (Die Revision G) (Continued)**

Notes: 1–7 apply to the entire table

| Parameter/Condition                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          | Symbol            | Configuration | V <sub>DD</sub> | -25E/-25 | -3E/-3 | -37E | Units |
|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|---------------|-----------------|----------|--------|------|-------|
| <b>Operating burst write current:</b> All banks open, continuous burst writes; BL = 4, CL = CL (I <sub>DD</sub> ), AL = 0; t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ), t <sub>RAS</sub> = t <sub>RAS</sub> MAX (I <sub>DD</sub> ), t <sub>RP</sub> = t <sub>RP</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH between valid commands; Address bus inputs are switching; Data bus inputs are switching                                                                                                                                                                                                                          | I <sub>DD4W</sub> | x4            | 1.9             | 145      | 120    | 110  | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 120      | 95     | 85   |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   | x8            | 1.9             | 160      | 135    | 125  |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 130      | 110    | 95   |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   | x16           | 1.9             | 315      | 200    | 180  |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 255      | 165    | 140  |       |
| <b>Operating burst read current:</b> All banks open, continuous burst reads, I <sub>OUT</sub> = 0mA; BL = 4, CL = CL (I <sub>DD</sub> ), AL = 0; t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ), t <sub>RAS</sub> = t <sub>RAS</sub> MAX (I <sub>DD</sub> ), t <sub>RP</sub> = t <sub>RP</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH between valid commands; Address bus inputs are switching; Data bus inputs are switching                                                                                                                                                                                                    | I <sub>DD4R</sub> | x4            | 1.9             | 145      | 120    | 110  | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 120      | 95     | 80   |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   | x8            | 1.9             | 160      | 135    | 125  |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 130      | 110    | 90   |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   | x16           | 1.9             | 320      | 220    | 180  |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 260      | 180    | 140  |       |
| <b>Burst refresh current:</b> t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ); REFRESH command at every t <sub>RFC</sub> (I <sub>DD</sub> ) interval; CKE is HIGH, CS# is HIGH between valid commands; Other control and address bus inputs are switching; Data bus inputs are switching                                                                                                                                                                                                                                                                                                                                                | I <sub>DD5</sub>  | x4, x8        | 1.9             | 235      | 215    | 210  | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 190      | 180    | 175  |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   | x16           | 1.9             | 280      | 270    | 250  |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 225      | 220    | 210  |       |
| <b>Self refresh current:</b> CK and CK# at 0V; CKE ≤ 0.2V; Other control and address bus inputs are floating; Data bus inputs are floating                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   | I <sub>DD6</sub>  | x4, x8, x16   | 1.9             | 7        | 7      | 7    | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 7        | 7      | 7    |       |
| <b>Operating bank interleave read current:</b> All bank interleaving reads, I <sub>OUT</sub> = 0mA; BL = 4, CL = CL (I <sub>DD</sub> ), AL = t <sub>RCD</sub> (I <sub>DD</sub> ) - 1 × t <sub>CK</sub> (I <sub>DD</sub> ); t <sub>CK</sub> = t <sub>CK</sub> (I <sub>DD</sub> ), t <sub>RC</sub> = t <sub>RC</sub> (I <sub>DD</sub> ), t <sub>RRD</sub> = t <sub>RRD</sub> (I <sub>DD</sub> ), t <sub>RCD</sub> = t <sub>RCD</sub> (I <sub>DD</sub> ); CKE is HIGH, CS# is HIGH between valid commands; Address bus inputs are stable during deselects; Data bus inputs are switching; See I <sub>DD7</sub> Conditions (page 26) for details | I <sub>DD7</sub>  | x4, x8        | 1.9             | 335      | 280    | 270  | mA    |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 250      | 225    | 220  |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   | x16           | 1.9             | 440      | 350    | 330  |       |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |                   |               | 1.6             | 330      | 280    | 270  |       |

- Notes:
1. I<sub>DD</sub> specifications are tested after the device is properly initialized. 0°C ≤ T<sub>C</sub> ≤ +85°C.
  2. V<sub>DD</sub> = +1.8V ±0.1V, V<sub>DDQ</sub> = +1.8V ±0.1V, V<sub>DDL</sub> = +1.8V ±0.1V, V<sub>REF</sub> = V<sub>DDQ</sub>/2.
  3. I<sub>DD</sub> parameters are specified with ODT disabled.
  4. Data bus consists of DQ, DM, DQS, DQS#, RDQS, RDQS#, LDQS, LDQS#, UDQS, and UDQS#. I<sub>DD</sub> values must be met with all combinations of EMR bits 10 and 11.
  5. Definitions for I<sub>DD</sub> conditions:

**LOW**

$$V_{IN} \leq V_{IL(AC)max}$$

**HIGH**

$$V_{IN} \geq V_{IH(AC)min}$$

**Stable** Inputs stable at a HIGH or LOW level

**Floating** Inputs at  $V_{REF} = V_{DDQ}/2$

**Switching** Inputs changing between HIGH and LOW every other clock cycle (once per two clocks) for address and control signals

**Switching** Inputs changing between HIGH and LOW every other data transfer (once per clock) for DQ signals, not including masks or strobes

6. I<sub>DD1</sub>, I<sub>DD4R</sub>, and I<sub>DD7</sub> require A12 in EMR to be enabled during testing.
7. The following I<sub>DD</sub> values must be derated (I<sub>DD</sub> limits increase) on IT-option and AT-option devices when operated outside of the range  $0^{\circ}\text{C} \leq T_C \leq 85^{\circ}\text{C}$ :

**When** I<sub>DD2P</sub> and I<sub>DD3P(SLOW)</sub> must be derated by 4%; I<sub>DD4R</sub> and I<sub>DD5W</sub> must be derated by 2%; and I<sub>DD6</sub> and I<sub>DD7</sub> must be derated by 7%  
**T<sub>C</sub> ≤ 0°C**

**When** I<sub>DD0</sub>, I<sub>DD1</sub>, I<sub>DD2N</sub>, I<sub>DD2Q</sub>, I<sub>DD3N</sub>, I<sub>DD3P(FAST)</sub>, I<sub>DD4R</sub>, I<sub>DD4W</sub>, and I<sub>DD5W</sub> must be derated by 2%; I<sub>DD2P</sub> must be derated by 20%; I<sub>DD3P(SLOW)</sub> must be derated by 30%; and I<sub>DD6</sub> must be derated by 80% (I<sub>DD6</sub> will increase by this amount if  $T_C < 85^{\circ}\text{C}$  and the 2X refresh option is still enabled)  
**T<sub>C</sub> ≥ 85°C**

## AC Timing Operating Specifications

**Table 11: AC Operating Specifications and Conditions**

Not all speed grades listed may be supported for this device; refer to the title page for speeds supported; Notes: 1–5 apply to the entire table;  
 $V_{DDQ} = +1.5\text{--}1.9\text{V}$ ,  $V_{DD} = +1.5\text{--}1.9\text{V}$

| AC Characteristics          |                                |                       |                                                                                                                                                                                    | -25E                                                                                                                                                                               |      | -25  |      | -3E  |      | -3   |      | -37E |      | Units           | Notes      |    |
|-----------------------------|--------------------------------|-----------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|------|------|------|------|------|------|-----------------|------------|----|
| Parameter                   |                                | Symbol                | Min                                                                                                                                                                                | Max                                                                                                                                                                                | Min  | Max  | Min  | Max  | Min  | Max  | Min  | Max  |      |                 |            |    |
| Clock                       | Clock cycle time               | CL = 6                | t <sub>CK</sub> (avg)                                                                                                                                                              | 2.5                                                                                                                                                                                | 8.0  | 2.5  | 8.0  | –    | –    | –    | –    | –    | –    | ns              | 6, 7, 8, 9 |    |
|                             |                                | CL = 5                | t <sub>CK</sub> (avg)                                                                                                                                                              | 2.5                                                                                                                                                                                | 8.0  | 3.0  | 8.0  | 3.0  | 8.0  | 3.0  | 8.0  | –    | –    |                 |            |    |
|                             |                                | CL = 4                | t <sub>CK</sub> (avg)                                                                                                                                                              | 3.75                                                                                                                                                                               | 8.0  | 3.75 | 8.0  | 3.0  | 8.0  | 3.75 | 8.0  | 3.75 | 8.0  |                 |            |    |
|                             |                                | CL = 3                | t <sub>CK</sub> (avg)                                                                                                                                                              | 5.0                                                                                                                                                                                | 8.0  | 5.0  | 8.0  | 5.0  | 8.0  | 5.0  | 8.0  | 5.0  | 8.0  |                 |            |    |
|                             | CK high-level width            |                       | t <sub>CH</sub> (avg)                                                                                                                                                              | 0.48                                                                                                                                                                               | 0.52 | 0.48 | 0.52 | 0.48 | 0.52 | 0.48 | 0.52 | 0.48 | 0.52 | t <sub>CK</sub> | 10         |    |
|                             | CK low-level width             |                       | t <sub>CL</sub> (avg)                                                                                                                                                              | 0.48                                                                                                                                                                               | 0.52 | 0.48 | 0.52 | 0.48 | 0.52 | 0.48 | 0.52 | 0.48 | 0.52 | t <sub>CK</sub> |            |    |
|                             | Half clock period              |                       | t <sub>HP</sub>                                                                                                                                                                    | MIN = lesser of t <sub>CH</sub> and t <sub>CL</sub><br>MAX = n/a                                                                                                                   |      |      |      |      |      |      |      |      |      |                 | ps         | 11 |
|                             | Absolute t <sub>CK</sub>       |                       | t <sub>CK</sub> (abs)                                                                                                                                                              | MIN = t <sub>CK</sub> (AVG) MIN + t <sub>JITper</sub> (MIN)<br>MAX = t <sub>CK</sub> (AVG) MAX + t <sub>JITper</sub> (MAX)                                                         |      |      |      |      |      |      |      |      |      |                 | ps         |    |
|                             | Absolute CK high-level width   |                       | t <sub>CH</sub> (abs)                                                                                                                                                              | MIN = t <sub>CK</sub> (AVG) MIN × t <sub>CH</sub> (AVG) MIN + t <sub>JITdty</sub> (MIN)<br>MAX = t <sub>CK</sub> (AVG) MAX × t <sub>CH</sub> (AVG) MAX + t <sub>JITdty</sub> (MAX) |      |      |      |      |      |      |      |      |      |                 | ps         |    |
| Absolute CK low-level width |                                | t <sub>CL</sub> (abs) | MIN = t <sub>CK</sub> (AVG) MIN × t <sub>CL</sub> (AVG) MIN + t <sub>JITdty</sub> (MIN)<br>MAX = t <sub>CK</sub> (AVG) MAX × t <sub>CL</sub> (AVG) MAX + t <sub>JITdty</sub> (MAX) |                                                                                                                                                                                    |      |      |      |      |      |      |      |      |      | ps              |            |    |
| Clock Jitter                | Period jitter                  |                       | t <sub>JITper</sub>                                                                                                                                                                | –100                                                                                                                                                                               | 100  | –100 | 100  | –125 | 125  | –125 | 125  | –125 | 125  | ps              | 12         |    |
|                             | Half period                    |                       | t <sub>JITdty</sub>                                                                                                                                                                | –100                                                                                                                                                                               | 100  | –100 | 100  | –125 | 125  | –125 | 125  | –125 | 125  | ps              | 13         |    |
|                             | Cycle to cycle                 |                       | t <sub>JITcc</sub>                                                                                                                                                                 | 200                                                                                                                                                                                |      | 200  |      | 250  |      | 250  |      | 250  |      | ps              | 14         |    |
|                             | Cumulative error, 2 cycles     |                       | t <sub>ERR<sub>2per</sub></sub>                                                                                                                                                    | –150                                                                                                                                                                               | 150  | –150 | 150  | –175 | 175  | –175 | 175  | –175 | 175  | ps              | 15         |    |
|                             | Cumulative error, 3 cycles     |                       | t <sub>ERR<sub>3per</sub></sub>                                                                                                                                                    | –175                                                                                                                                                                               | 175  | –175 | 175  | –225 | 225  | –225 | 225  | –225 | 225  | ps              | 15         |    |
|                             | Cumulative error, 4 cycles     |                       | t <sub>ERR<sub>4per</sub></sub>                                                                                                                                                    | –200                                                                                                                                                                               | 200  | –200 | 200  | –250 | 250  | –250 | 250  | –250 | 250  | ps              | 15         |    |
|                             | Cumulative error, 5 cycles     |                       | t <sub>ERR<sub>5per</sub></sub>                                                                                                                                                    | –200                                                                                                                                                                               | 200  | –200 | 200  | –250 | 250  | –250 | 250  | –250 | 250  | ps              | 15, 16     |    |
|                             | Cumulative error, 6–10 cycles  |                       | t <sub>ERR<sub>6–10per</sub></sub>                                                                                                                                                 | –300                                                                                                                                                                               | 300  | –300 | 300  | –350 | 350  | –350 | 350  | –350 | 350  | ps              | 15, 16     |    |
|                             | Cumulative error, 11–50 cycles |                       | t <sub>ERR<sub>11–50per</sub></sub>                                                                                                                                                | –450                                                                                                                                                                               | 450  | –450 | 450  | –450 | 450  | –450 | 450  | –450 | 450  | ps              | 15         |    |

**Table 11: AC Operating Specifications and Conditions (Continued)**

Not all speed grades listed may be supported for this device; refer to the title page for speeds supported; Notes: 1–5 apply to the entire table;  
 $V_{DDQ} = +1.5\text{--}1.9\text{V}$ ,  $V_{DD} = +1.5\text{--}1.9\text{V}$

| AC Characteristics |                                       |                              | -25E                                                           |      | -25  |      | -3E  |      | -3   |      | -37E |      | Units           | Notes          |
|--------------------|---------------------------------------|------------------------------|----------------------------------------------------------------|------|------|------|------|------|------|------|------|------|-----------------|----------------|
| Parameter          |                                       | Symbol                       | Min                                                            | Max  | Min  | Max  | Min  | Max  | Min  | Max  | Min  | Max  |                 |                |
| Data Strobe-Out    | DQS output access time from CK/CK#    | <sup>t</sup> DQSCK           | −350                                                           | +350 | −350 | +350 | −400 | +400 | −400 | +400 | −450 | +450 | ps              | 19             |
|                    | DQS read preamble                     | <sup>t</sup> RPRE            | MIN = 0.9 × <sup>t</sup> CK<br>MAX = 1.1 × <sup>t</sup> CK     |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 17, 18, 19     |
|                    | DQS read postamble                    | <sup>t</sup> RPST            | MIN = 0.4 × <sup>t</sup> CK<br>MAX = 0.6 × <sup>t</sup> CK     |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 17, 18, 19, 20 |
|                    | CK/CK# to DQS Low-Z                   | <sup>t</sup> LZ <sub>1</sub> | MIN = <sup>t</sup> AC (MIN)<br>MAX = <sup>t</sup> AC (MAX)     |      |      |      |      |      |      |      |      |      | ps              | 19, 21, 22     |
| Data Strobe-In     | DQS rising edge to CK rising edge     | <sup>t</sup> DQSS            | MIN = −0.25 × <sup>t</sup> CK<br>MAX = +0.25 × <sup>t</sup> CK |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 18             |
|                    | DQS input-high pulse width            | <sup>t</sup> DQSH            | MIN = 0.35 × <sup>t</sup> CK<br>MAX = n/a                      |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 18             |
|                    | DQS input-low pulse width             | <sup>t</sup> DQSL            | MIN = 0.35 × <sup>t</sup> CK<br>MAX = n/a                      |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 18             |
|                    | DQS falling to CK rising: setup time  | <sup>t</sup> DSS             | MIN = 0.2 × <sup>t</sup> CK<br>MAX = n/a                       |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 18             |
|                    | DQS falling from CK rising: hold time | <sup>t</sup> DSH             | MIN = 0.2 × <sup>t</sup> CK<br>MAX = n/a                       |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 18             |
|                    | Write preamble setup time             | <sup>t</sup> WPRES           | MIN = 0<br>MAX = n/a                                           |      |      |      |      |      |      |      |      |      | ps              | 23, 24         |
|                    | DQS write preamble                    | <sup>t</sup> WPRE            | MIN = 0.35 × <sup>t</sup> CK<br>MAX = n/a                      |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 18             |
|                    | DQS write postamble                   | <sup>t</sup> WPST            | MIN = 0.4 × <sup>t</sup> CK<br>MAX = 0.6 × <sup>t</sup> CK     |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK | 18, 25         |
|                    | WRITE command to first DQS transition | –                            | MIN = WL - <sup>t</sup> DQSS<br>MAX = WL + <sup>t</sup> DQSS   |      |      |      |      |      |      |      |      |      | <sup>t</sup> CK |                |

**Table 11: AC Operating Specifications and Conditions (Continued)**

Not all speed grades listed may be supported for this device; refer to the title page for speeds supported; Notes: 1–5 apply to the entire table;  
 $V_{DDQ} = +1.5-1.9V$ ,  $V_{DD} = +1.5-1.9V$

| AC Characteristics |                                                          |                   | -25E                                                                |      | -25  |      | -3E  |      | -3   |      | -37E |      | Units           | Notes      |
|--------------------|----------------------------------------------------------|-------------------|---------------------------------------------------------------------|------|------|------|------|------|------|------|------|------|-----------------|------------|
| Parameter          | Symbol                                                   | Min               | Max                                                                 | Min  | Max  | Min  | Max  | Min  | Max  | Min  | Max  |      |                 |            |
| Data-Out           | DQ output access time from CK/CK#                        | $t^{\text{AC}}$   | −400                                                                | +400 | −400 | +400 | −450 | +450 | −450 | +450 | −500 | +500 | ps              | 19         |
|                    | DQS−DQ skew, DQS to last DQ valid, per group, per access | $t^{\text{DQSQ}}$ | −                                                                   | 200  | −    | 200  | −    | 240  | −    | 240  | −    | 300  | ps              | 26, 27     |
|                    | DQ hold from next DQS strobe                             | $t^{\text{QHS}}$  | −                                                                   | 300  | −    | 300  | −    | 340  | −    | 340  | −    | 400  | ps              | 28         |
|                    | DQ−DQS hold, DQS to first DQ not valid                   | $t^{\text{QH}}$   | MIN = $t^{\text{HP}}$ - $t^{\text{QHS}}$<br>MAX = n/a               |      |      |      |      |      |      |      |      |      | ps              | 26, 27, 28 |
|                    | CK/CK# to DQ, DQS High-Z                                 | $t^{\text{HZ}}$   | MIN = n/a<br>MAX = $t^{\text{AC}}$ (MAX)                            |      |      |      |      |      |      |      |      |      | ps              | 19, 21, 29 |
|                    | CK/CK# to DQ Low-Z                                       | $t^{\text{LZ}}_2$ | MIN = $2 \times t^{\text{AC}}$ (MIN)<br>MAX = $t^{\text{AC}}$ (MAX) |      |      |      |      |      |      |      |      |      | ps              | 19, 21, 22 |
|                    | Data valid output window                                 | DVW               | MIN = $t^{\text{QH}}$ - $t^{\text{DQSQ}}$<br>MAX = n/a              |      |      |      |      |      |      |      |      |      | ns              | 26, 27     |
| Data-In            | DQ and DM input setup time to DQS                        | $t^{\text{DSb}}$  | 50                                                                  | −    | 50   | −    | 100  | −    | 100  | −    | 100  | −    | ps              | 26, 30, 31 |
|                    | DQ and DM input hold time to DQS                         | $t^{\text{DHb}}$  | 125                                                                 | −    | 125  | −    | 175  | −    | 175  | −    | 225  | −    | ps              | 26, 30, 31 |
|                    | DQ and DM input setup time to DQS                        | $t^{\text{DSa}}$  | 250                                                                 | −    | 250  | −    | 300  | −    | 300  | −    | 350  | −    | ps              | 26, 30, 31 |
|                    | DQ and DM input hold time to DQS                         | $t^{\text{DHa}}$  | 250                                                                 | −    | 250  | −    | 300  | −    | 300  | −    | 350  | −    | ps              | 26, 30, 31 |
|                    | DQ and DM input pulse width                              | $t^{\text{DIPW}}$ | MIN = $0.35 \times t^{\text{CK}}$<br>MAX = n/a                      |      |      |      |      |      |      |      |      |      | $t^{\text{CK}}$ | 18, 32     |

**Table 11: AC Operating Specifications and Conditions (Continued)**

Not all speed grades listed may be supported for this device; refer to the title page for speeds supported; Notes: 1–5 apply to the entire table;  
 $V_{DDQ} = +1.5\text{--}1.9\text{V}$ ,  $V_{DD} = +1.5\text{--}1.9\text{V}$

| AC Characteristics                  |                                              |                  | -25E                              |      | -25                               |      | -3E                               |      | -3                                |      | -37E                              |       | Units           | Notes           |            |
|-------------------------------------|----------------------------------------------|------------------|-----------------------------------|------|-----------------------------------|------|-----------------------------------|------|-----------------------------------|------|-----------------------------------|-------|-----------------|-----------------|------------|
| Parameter                           |                                              | Symbol           | Min                               | Max  | Min                               | Max  | Min                               | Max  | Min                               | Max  | Min                               | Max   |                 |                 |            |
| Command and Address                 | Input setup time                             |                  | <sup>t</sup> ISb                  | 175  | –                                 | 175  | –                                 | 200  | –                                 | 200  | –                                 | 250   | –               | ps              | 31, 33     |
|                                     | Input hold time                              |                  | <sup>t</sup> IHb                  | 250  | –                                 | 250  | –                                 | 275  | –                                 | 275  | –                                 | 375   | –               | ps              | 31, 33     |
|                                     | Input setup time                             |                  | <sup>t</sup> ISa                  | 375  | –                                 | 375  | –                                 | 400  | –                                 | 400  | –                                 | 500   | –               | ps              | 31, 33     |
|                                     | Input hold time                              |                  | <sup>t</sup> IHa                  | 375  | –                                 | 375  | –                                 | 400  | –                                 | 400  | –                                 | 500   | –               | ps              | 31, 33     |
|                                     | Input pulse width                            |                  | <sup>t</sup> IPW                  | 0.6  | –                                 | 0.6  | –                                 | 0.6  | –                                 | 0.6  | –                                 | 0.6   | –               | <sup>t</sup> CK | 18, 32     |
|                                     | ACTIVATE-to- ACTIVATE delay, same bank       |                  | <sup>t</sup> RC                   | 55   | –                                 | 55   | –                                 | 54   | –                                 | 55   | –                                 | 55    | –               | ns              | 18, 34     |
|                                     | ACTIVATE-to-READ or WRITE delay              |                  | <sup>t</sup> RCD                  | 12.5 | –                                 | 15   | –                                 | 12   | –                                 | 15   | –                                 | 15    | –               | ns              | 18         |
|                                     | ACTIVATE-to- PRE-CHARGE delay                |                  | <sup>t</sup> RAS                  | 40   | 70K                               | 40   | 70K                               | 40   | 70K                               | 40   | 70K                               | 40    | 70K             | ns              | 18, 34, 35 |
|                                     | PRECHARGE period                             |                  | <sup>t</sup> RP                   | 12.5 | –                                 | 15   | –                                 | 12   | –                                 | 15   | –                                 | 15    | –               | ns              | 18, 36     |
|                                     | PRECHARGE ALL period                         | <1Gb             | <sup>t</sup> RPA                  | 12.5 | –                                 | 15   | –                                 | 12   | –                                 | 15   | –                                 | 15    | –               | ns              | 18, 36     |
|                                     |                                              | ≥1Gb             | <sup>t</sup> RPA                  | 15   | –                                 | 17.5 | –                                 | 15   | –                                 | 18   | –                                 | 18.75 | –               | ns              | 18, 36     |
|                                     | ACTIVATE -to- ACTIVATE delay differ-ent bank | x4, x8           | <sup>t</sup> RRD                  | 7.5  | –                                 | 7.5  | –                                 | 7.5  | –                                 | 7.5  | –                                 | 7.5   | –               | ns              | 18, 37     |
|                                     |                                              | x16              | <sup>t</sup> RRD                  | 10   | –                                 | 10   | –                                 | 10   | –                                 | 10   | –                                 | 10    | –               | ns              | 18, 37     |
|                                     | 4-bank activate period (≥1Gb)                | x4, x8           | <sup>t</sup> FAW                  | 35   | –                                 | 35   | –                                 | 37.5 | –                                 | 37.5 | –                                 | 37.5  | –               | ns              | 18, 38     |
|                                     |                                              | x16              | <sup>t</sup> FAW                  | 45   | –                                 | 45   | –                                 | 50   | –                                 | 50   | –                                 | 50    | –               | ns              | 18, 38     |
|                                     | Internal READ-to-PRE-CHARGE delay            |                  | <sup>t</sup> RTP                  | 7.5  | –                                 | 7.5  | –                                 | 7.5  | –                                 | 7.5  | –                                 | 7.5   | –               | ns              | 18, 37, 39 |
|                                     | CAS#-to-CAS# delay                           |                  | <sup>t</sup> CCD                  | 2    | –                                 | 2    | –                                 | 2    | –                                 | 2    | –                                 | 2     | –               | <sup>t</sup> CK | 18         |
|                                     | Write recovery time                          |                  | <sup>t</sup> WR                   | 15   | –                                 | 15   | –                                 | 15   | –                                 | 15   | –                                 | 15    | –               | ns              | 18, 37     |
| Write AP recovery + pre-charge time |                                              | <sup>t</sup> DAL | <sup>t</sup> WR + <sup>t</sup> RP | –    | <sup>t</sup> WR + <sup>t</sup> RP | –    | <sup>t</sup> WR + <sup>t</sup> RP | –    | <sup>t</sup> WR + <sup>t</sup> RP | –    | <sup>t</sup> WR + <sup>t</sup> RP | –     | ns              | 40              |            |
| Internal WRITE-to-READ delay        |                                              | <sup>t</sup> WTR | 7.5                               | –    | 7.5                               | –    | 7.5                               | –    | 7.5                               | –    | 7.5                               | –     | ns              | 18, 37          |            |
| LOAD MODE cycle time                |                                              | <sup>t</sup> MRD | 2                                 | –    | 2                                 | –    | 2                                 | –    | 2                                 | –    | 2                                 | –     | <sup>t</sup> CK | 18              |            |

**Table 11: AC Operating Specifications and Conditions (Continued)**

Not all speed grades listed may be supported for this device; refer to the title page for speeds supported; Notes: 1–5 apply to the entire table;  
 $V_{DDQ} = +1.5\text{--}1.9\text{V}$ ,  $V_{DD} = +1.5\text{--}1.9\text{V}$

| AC Characteristics             |                                                                         |                      |                                                           | -25E                                                |     | -25    |     | -3E    |     | -3     |     | -37E   |     | Units    | Notes    |        |
|--------------------------------|-------------------------------------------------------------------------|----------------------|-----------------------------------------------------------|-----------------------------------------------------|-----|--------|-----|--------|-----|--------|-----|--------|-----|----------|----------|--------|
| Parameter                      |                                                                         | Symbol               | Min                                                       | Max                                                 | Min | Max    | Min | Max    | Min | Max    | Min | Max    |     |          |          |        |
| Refresh                        | REFRESH-to-ACTIVATE or to -REFRESH interval                             | 256Mb                | $t_{RFC}$                                                 | 75                                                  | –   | 75     | –   | 75     | –   | 75     | –   | 75     | –   | ns       | 18, 41   |        |
|                                |                                                                         | 512Mb                |                                                           | 105                                                 | –   | 105    | –   | 105    | –   | 105    | –   |        |     |          |          |        |
|                                |                                                                         | 1Gb                  |                                                           | 127.5                                               | –   | 127.5  | –   | 127.5  | –   | 127.5  | –   |        |     |          |          |        |
|                                |                                                                         | 2Gb                  |                                                           | 197.5                                               | –   | 197.5  | –   | 197.5  | –   | 197.5  | –   |        |     |          |          |        |
|                                | Average periodic refresh (commercial)                                   |                      | $t_{REFI}$                                                | –                                                   | 7.8 | –      | 7.8 | –      | 7.8 | –      | 7.8 | –      | 7.8 | $\mu s$  | 18, 41   |        |
|                                | Average periodic refresh (industrial)                                   |                      | $t_{REFI_{IT}}$                                           | –                                                   | 3.9 | –      | 3.9 | –      | 3.9 | –      | 3.9 | –      | 3.9 | $\mu s$  | 18, 41   |        |
|                                | Average periodic re-fresh (automotive)                                  |                      | $t_{REFI_{AT}}$                                           | –                                                   | 3.9 | –      | 3.9 | –      | 3.9 | –      | 3.9 | –      | 3.9 | $\mu s$  | 18, 41   |        |
| CKE LOW to CK, CK# uncertainty |                                                                         | $t_{DELAY}$          | MIN limit = $t_{IS} + t_{CK} + t_{IH}$<br>MAX limit = n/a |                                                     |     |        |     |        |     |        |     |        |     | ns       | 42       |        |
| Self Refresh                   | Exit SELF REFRESH to nonREAD command                                    |                      | $t_{XSNR}$                                                | MIN limit = $t_{RFC}$ (MIN) + 10<br>MAX limit = n/a |     |        |     |        |     |        |     |        |     |          | ns       |        |
|                                | Exit SELF REFRESH to READ command                                       |                      | $t_{XSRD}$                                                | MIN limit = 200<br>MAX limit = n/a                  |     |        |     |        |     |        |     |        |     |          | $t_{CK}$ | 18     |
|                                | Exit SELF REFRESH timing reference                                      |                      | $t_{ISXR}$                                                | MIN limit = $t_{IS}$<br>MAX limit = n/a             |     |        |     |        |     |        |     |        |     |          | ps       | 33, 43 |
| Power-Down                     | Exit active power-down to READ command                                  | MR12 = 0<br>MR12 = 1 | $t_{XARD}$                                                | 2                                                   | –   | 2      | –   | 2      | –   | 2      | –   | 2      | –   | $t_{CK}$ | 18       |        |
|                                |                                                                         |                      |                                                           | 8 - AL                                              | –   | 8 - AL | –   | 7 - AL | –   | 7 - AL | –   | 6 - AL | –   | $t_{CK}$ | 18       |        |
|                                | Exit precharge power-down and active power-down to any non-READ command |                      | $t_{XP}$                                                  | 2                                                   | –   | 2      | –   | 2      | –   | 2      | –   | 2      | –   | $t_{CK}$ | 18       |        |
|                                | CKE MIN HIGH/LOW time                                                   |                      | $t_{CKE}$                                                 | MIN = 3<br>MAX = n/a                                |     |        |     |        |     |        |     |        |     | $t_{CK}$ | 18, 44   |        |

**Table 11: AC Operating Specifications and Conditions (Continued)**

Not all speed grades listed may be supported for this device; refer to the title page for speeds supported; Notes: 1–5 apply to the entire table;  
 $V_{DDQ} = +1.5\text{--}1.9\text{V}$ ,  $V_{DD} = +1.5\text{--}1.9\text{V}$

| AC Characteristics |                                 |                    | -25E                                                                                               |     | -25 |     | -3E                                                              |     | -3  |     | -37E                                                               |   | Units           | Notes  |
|--------------------|---------------------------------|--------------------|----------------------------------------------------------------------------------------------------|-----|-----|-----|------------------------------------------------------------------|-----|-----|-----|--------------------------------------------------------------------|---|-----------------|--------|
| Parameter          | Symbol                          | Min                | Max                                                                                                | Min | Max | Min | Max                                                              | Min | Max | Min | Max                                                                |   |                 |        |
| ODT                | ODT to power-down entry latency | <sup>t</sup> ANPD  | 3                                                                                                  | –   | 3   | –   | 3                                                                | –   | 3   | –   | 3                                                                  | – | <sup>t</sup> CK | 18     |
|                    | ODT power-down exit latency     | <sup>t</sup> AXPD  | 10                                                                                                 | –   | 10  | –   | 8                                                                | –   | 8   | –   | 8                                                                  | – | <sup>t</sup> CK | 18     |
|                    | ODT turn-on delay               | <sup>t</sup> AOND  | 2                                                                                                  |     |     |     |                                                                  |     |     |     |                                                                    |   | <sup>t</sup> CK | 18     |
|                    | ODT turn-off delay              | <sup>t</sup> AOFD  | 2.5                                                                                                |     |     |     |                                                                  |     |     |     |                                                                    |   | <sup>t</sup> CK | 18, 45 |
|                    | ODT turn-on                     | <sup>t</sup> AON   | MIN = <sup>t</sup> AC (MIN)<br>MAX = <sup>t</sup> AC (MAX) + 600                                   |     |     |     | MIN = <sup>t</sup> AC (MIN)<br>MAX = <sup>t</sup> AC (MAX) + 700 |     |     |     | MIN = <sup>t</sup> AC (MIN)<br>MAX = <sup>t</sup> AC (MAX) + 1,000 |   | ps              | 19, 46 |
|                    | ODT turn-off                    | <sup>t</sup> AOF   | MIN = <sup>t</sup> AC (MIN)<br>MAX = <sup>t</sup> AC (MAX) + 600                                   |     |     |     |                                                                  |     |     |     |                                                                    |   | ps              | 47, 48 |
|                    | ODT turn-on (power-down mode)   | <sup>t</sup> AONPD | MIN = <sup>t</sup> AC (MIN) + 2,000<br>MAX = 2 × <sup>t</sup> CK + <sup>t</sup> AC (MAX) + 1,000   |     |     |     |                                                                  |     |     |     |                                                                    |   | ps              | 49     |
|                    | ODT turn-off (power-down mode)  | <sup>t</sup> AOFPD | MIN = <sup>t</sup> AC (MIN) + 2,000<br>MAX = 2.5 × <sup>t</sup> CK + <sup>t</sup> AC (MAX) + 1,000 |     |     |     |                                                                  |     |     |     |                                                                    |   | ps              |        |
|                    | ODT enable from MRS command     | <sup>t</sup> MOD   | MIN = 12<br>MAX = n/a                                                                              |     |     |     |                                                                  |     |     |     |                                                                    |   | ns              | 18, 50 |

- Notes:
1. All voltages are referenced to  $V_{SS}$ .
  2. Tests for AC timing,  $I_{DD}$ , and electrical AC and DC characteristics may be conducted at nominal reference/supply voltage levels, but the related specifications and the operation of the device are warranted for the full voltage range specified. ODT is disabled for all measurements that are not ODT-specific.
  3. Outputs measured with equivalent load (see Output Electrical Characteristics and Operating Conditions (page 44)).
  4. AC timing and  $I_{DD}$  tests may use a  $V_{IL}$ -to- $V_{IH}$  swing of up to 1.0V in the test environment, and parameter specifications are guaranteed for the specified AC input levels under normal use conditions. The slew rate for the input signals used to test the device is 1.0 V/ns for signals in the range between  $V_{IL(AC)}$  and  $V_{IH(AC)}$ . Slew rates other than 1.0 V/ns may require the timing parameters to be derated as specified.
  5. The AC and DC input level specifications are as defined in the SSTL\_18 standard (that is, the receiver will effectively switch as a result of the signal crossing the AC input level and will remain in that state as long as the signal does not ring back above [below] the DC input LOW [HIGH] level).
  6. CK and CK# input slew rate is referenced at 1 V/ns (2 V/ns if measured differentially).
  7. Operating frequency is only allowed to change during self refresh mode (see Figure 78 (page 120)), precharge power-down mode, or system reset condition (see (page 0)). SSC allows for small deviations in operating frequency, provided the SSC guidelines are satisfied.
  8. The clock's  $t_{CK}^{(AVG)}$  is the average clock over any 200 consecutive clocks and  $t_{CK}^{(AVG)} \text{ MIN}$  is the smallest clock rate allowed (except for a deviation due to allowed clock jitter). Input clock jitter is allowed provided it does not exceed values specified. Also, the jitter must be of a random Gaussian distribution in nature.
  9. Spread spectrum is not included in the jitter specification values. However, the input clock can accommodate spread spectrum at a sweep rate in the range 8–60 kHz with an additional one percent  $t_{CK}^{(AVG)}$ ; however, the spread spectrum may not use a clock rate below  $t_{CK}^{(AVG)} \text{ MIN}$  or above  $t_{CK}^{(AVG)} \text{ MAX}$ .
  10. MIN ( $t_{CL}$ ,  $t_{CH}$ ) refers to the smaller of the actual clock LOW time and the actual clock HIGH time driven to the device. The clock's half period must also be of a Gaussian distribution;  $t_{CH}^{(AVG)}$  and  $t_{CL}^{(AVG)}$  must be met with or without clock jitter and with or without duty cycle jitter.  $t_{CH}^{(AVG)}$  and  $t_{CL}^{(AVG)}$  are the average of any 200 consecutive CK falling edges.  $t_{CH}$  limits may be exceeded if the duty cycle jitter is small enough that the absolute half period limits ( $t_{CH}^{[ABS]}$ ,  $t_{CL}^{[ABS]}$ ) are not violated.
  11.  $t_{HP}^{(MIN)}$  is the lesser of  $t_{CL}$  and  $t_{CH}$  actually applied to the device CK and CK# inputs; thus,  $t_{HP}^{(MIN)} \geq \text{the lesser of } t_{CL}^{(ABS)} \text{ MIN and } t_{CH}^{(ABS)} \text{ MIN}$ .
  12. The period jitter ( $t_{JITper}$ ) is the maximum deviation in the clock period from the average or nominal clock allowed in either the positive or negative direction. JEDEC specifies tighter jitter numbers during DLL locking time. During DLL lock time, the jitter values should be 20 percent less than those noted in the table (DLL locked).
  13. The half-period jitter ( $t_{JITdty}$ ) applies to either the high pulse of clock or the low pulse of clock; however, the two cumulatively can not exceed  $t_{JITper}$ .
  14. The cycle-to-cycle jitter ( $t_{JITcc}$ ) is the amount the clock period can deviate from one cycle to the next. JEDEC specifies tighter jitter numbers during DLL locking time. During DLL lock time, the jitter values should be 20 percent less than those noted in the table (DLL locked).
  15. The cumulative jitter error ( $t_{ERR_{nper}}$ ), where  $n$  is 2, 3, 4, 5, 6–10, or 11–50 is the amount of clock time allowed to consecutively accumulate away from the average clock over any number of clock cycles.
  16. JEDEC specifies using  $t_{ERR_{6-10per}}$  when derating clock-related output timing (see notes 19 and 48). Micron requires less derating by allowing  $t_{ERR_{5per}}$  to be used.
  17. This parameter is not referenced to a specific voltage level but is specified when the device output is no longer driving ( $t_{RPST}$ ) or beginning to drive ( $t_{RPRE}$ ).

18. The inputs to the DRAM must be aligned to the associated clock, that is, the actual clock that latches it in. However, the input timing (in ns) references to the  $t_{CK}^{(AVG)}$  when determining the required number of clocks. The following input parameters are determined by taking the specified percentage times the  $t_{CK}^{(AVG)}$  rather than  $t_{CK}$ :  $t_{IPW}$ ,  $t_{DIPW}$ ,  $t_{DQSS}$ ,  $t_{DQSH}$ ,  $t_{DQSL}$ ,  $t_{DSS}$ ,  $t_{DSH}$ ,  $t_{WPST}$ , and  $t_{WPRE}$ .
19. The DRAM output timing is aligned to the nominal or average clock. Most output parameters must be derated by the actual jitter error when input clock jitter is present; this will result in each parameter becoming larger. The following parameters are required to be derated by subtracting  $t_{ERR_{5per,max}}$ :  $t_{AC}^{(MIN)}$ ,  $t_{DQCK}^{(MIN)}$ ,  $t_{LZ_{DQS}}^{(MIN)}$ ,  $t_{LZ_{DQ}}^{(MIN)}$ ,  $t_{AON}^{(MIN)}$ ; while the following parameters are required to be derated by subtracting  $t_{ERR_{5per}}^{(MIN)}$ :  $t_{AC}^{(MAX)}$ ,  $t_{DQCK}^{(MAX)}$ ,  $t_{HZ}^{(MAX)}$ ,  $t_{LZ_{DQS}}^{(MAX)}$ ,  $t_{LZ_{DQ}}^{(MAX)}$ ,  $t_{AON}^{(MAX)}$ . The parameter  $t_{RPRE}^{(MIN)}$  is derated by subtracting  $t_{JITper}^{(MAX)}$ , while  $t_{RPRE}^{(MAX)}$  is derated by subtracting  $t_{JITper}^{(MIN)}$ . The parameter  $t_{RPST}^{(MIN)}$  is derated by subtracting  $t_{JITdty}^{(MAX)}$ , while  $t_{RPST}^{(MAX)}$  is derated by subtracting  $t_{JITdty}^{(MIN)}$ . Output timings that require  $t_{ERR_{5per}}$  derating can be observed to have offsets relative to the clock; however, the total window will not degrade.
20. When DQS is used single-ended, the minimum limit is reduced by 100ps.
21.  $t_{HZ}$  and  $t_{LZ}$  transitions occur in the same access time windows as valid data transitions. These parameters are not referenced to a specific voltage level, but specify when the device output is no longer driving ( $t_{HZ}$ ) or begins driving ( $t_{LZ}$ ).
22.  $t_{LZ}^{(MIN)}$  will prevail over a  $t_{DQCK}^{(MIN)} + t_{RPRE}^{(MAX)}$  condition.
23. This is not a device limit. The device will operate with a negative value, but system performance could be degraded due to bus turnaround.
24. It is recommended that DQS be valid (HIGH or LOW) on or before the WRITE command. The case shown (DQS going from High-Z to logic LOW) applies when no WRITES were previously in progress on the bus. If a previous WRITE was in progress, DQS could be HIGH during this time, depending on  $t_{DQSS}$ .
25. The intent of the "Don't Care" state after completion of the postamble is that the DQS-driven signal should either be HIGH, LOW, or High-Z, and that any signal transition within the input switching region must follow valid input requirements. That is, if DQS transitions HIGH (above  $V_{IH(DC)min}$ ), then it must not transition LOW (below  $V_{IH(DC)}$ ) prior to  $t_{DQSH}^{(MIN)}$ .
26. Referenced to each output group: x4 = DQS with DQ0–DQ3; x8 = DQS with DQ0–DQ7; x16 = LDQS with DQ0–DQ7; and UDQS with DQ8–DQ15.
27. The data valid window is derived by achieving other specifications:  $t_{HP}$  ( $t_{CK}/2$ ),  $t_{DQSQ}$ , and  $t_{QH}$  ( $t_{QH} = t_{HP} - t_{QHS}$ ). The data valid window derates in direct proportion to the clock duty cycle and a practical data valid window can be derived.
28.  $t_{QH} = t_{HP} - t_{QHS}$ ; the worst case  $t_{QH}$  would be the lesser of  $t_{CL}^{(ABS)} MAX$  or  $t_{CH}^{(ABS)} MAX$  times  $t_{CK}^{(ABS)} MIN - t_{QHS}$ . Minimizing the amount of  $t_{CH}^{(AVG)}$  offset and value of  $t_{JITdty}$  will provide a larger  $t_{QH}$ , which in turn will provide a larger valid data out window.
29. This maximum value is derived from the referenced test load.  $t_{HZ}^{(MAX)}$  will prevail over  $t_{DQCK}^{(MAX)} + t_{RPST}^{(MAX)}$  condition.
30. The values listed are for the differential DQS strobe (DQS and DQS#) with a differential slew rate of 2 V/ns (1 V/ns for each signal). There are two sets of values listed:  $t_{DS_a}$ ,  $t_{DH_a}$  and  $t_{DS_b}$ ,  $t_{DH_b}$ . The  $t_{DS_a}$ ,  $t_{DH_a}$  values (for reference only) are equivalent to the baseline values of  $t_{DS_b}$ ,  $t_{DH_b}$  at  $V_{REF}$  when the slew rate is 2 V/ns, differentially. The baseline values,  $t_{DS_b}$ ,  $t_{DH_b}$ , are the JEDEC-defined values, referenced from the logic trip points.  $t_{DS_b}$  is referenced from  $V_{IH(AC)}$  for a rising signal and  $V_{IL(AC)}$  for a falling signal, while  $t_{DH_b}$  is referenced from  $V_{IL(DC)}$  for a rising signal and  $V_{IH(DC)}$  for a falling signal. If the differential DQS slew rate is not equal to 2 V/ns, then the baseline values must be derated by adding the values from Table 30 (page 58) and Table 31 (page 59). If the DQS differential strobe feature is not enabled, then the DQS strobe is single-ended and the baseline values must be derated using Table 32 (page 60). Single-ended DQS data timing is referenced at DQS crossing  $V_{REF}$ . The correct timing values for a single-ended DQS

strobe are listed in Table 33 (page 60)–Table 35 (page 61) on Table 33 (page 60), Table 34 (page 61), and Table 35 (page 61); listed values are already derated for slew rate variations and converted from baseline values to  $V_{REF}$  values.

31.  $V_{IL}/V_{IH}$  DDR2 overshoot/undershoot. See AC Overshoot/Undershoot Specification (page 51).
32. For each input signal—not the group collectively.
33. There are two sets of values listed for command/address:  $t_{IS_a}$ ,  $t_{IH_a}$  and  $t_{IS_b}$ ,  $t_{IH_b}$ . The  $t_{IS_a}$ ,  $t_{IH_a}$  values (for reference only) are equivalent to the baseline values of  $t_{IS_b}$ ,  $t_{IH_b}$  at  $V_{REF}$  when the slew rate is 1 V/ns. The baseline values,  $t_{IS_b}$ ,  $t_{IH_b}$ , are the JEDEC-defined values, referenced from the logic trip points.  $t_{IS_b}$  is referenced from  $V_{IH(AC)}$  for a rising signal and  $V_{IL(AC)}$  for a falling signal, while  $t_{IH_b}$  is referenced from  $V_{IL(DC)}$  for a rising signal and  $V_{IH(DC)}$  for a falling signal. If the command/address slew rate is not equal to 1 V/ns, then the baseline values must be derated by adding the values from Table 28 (page 54) and Table 29 (page 55).
34. This is applicable to READ cycles only. WRITE cycles generally require additional time due to  $t_{WR}$  during auto precharge.
35. READs and WRITEs with auto precharge are allowed to be issued before  $t_{RAS}$  (MIN) is satisfied because  $t_{RAS}$  lockout feature is supported in DDR2 SDRAM.
36. When a single-bank PRECHARGE command is issued,  $t_{RP}$  timing applies.  $t_{RPA}$  timing applies when the PRECHARGE (ALL) command is issued, regardless of the number of banks open. For 8-bank devices ( $\geq 1\text{Gb}$ ),  $t_{RPA}$  (MIN) =  $t_{RP}$  (MIN) +  $t_{CK}$  (AVG) (Table 11 (page 30) lists  $t_{RP}$  [MIN] +  $t_{CK}$  [AVG] MIN).
37. This parameter has a two clock minimum requirement at any  $t_{CK}$ .
38. The  $t_{FAW}$  (MIN) parameter applies to all 8-bank DDR2 devices. No more than four bank-ACTIVATE commands may be issued in a given  $t_{FAW}$  (MIN) period.  $t_{RRD}$  (MIN) restriction still applies.
39. The minimum internal READ-to-PRECHARGE time. This is the time from which the last 4-bit prefetch begins to when the PRECHARGE command can be issued. A 4-bit prefetch is when the READ command internally latches the READ so that data will output CL later. This parameter is only applicable when  $t_{RTP}/(2 \times t_{CK}) > 1$ , such as frequencies faster than 533 MHz when  $t_{RTP} = 7.5\text{ns}$ . If  $t_{RTP}/(2 \times t_{CK}) \leq 1$ , then equation AL + BL/2 applies.  $t_{RAS}$  (MIN) has to be satisfied as well. The DDR2 SDRAM will automatically delay the internal PRECHARGE command until  $t_{RAS}$  (MIN) has been satisfied.
40.  $t_{DAL} = (nWR) + (t_{RP}/t_{CK})$ . Each of these terms, if not already an integer, should be rounded up to the next integer.  $t_{CK}$  refers to the application clock period;  $nWR$  refers to the  $t_{WR}$  parameter stored in the MR9–MR11. For example, -37E at  $t_{CK} = 3.75\text{ns}$  with  $t_{WR}$  programmed to four clocks would have  $t_{DAL} = 4 + (15\text{ns}/3.75\text{ns}) \text{ clocks} = 4 + (4) \text{ clocks} = 8 \text{ clocks}$ .
41. The refresh period is 64ms (commercial) or 32ms (industrial and automotive). This equates to an average refresh rate of 7.8125 $\mu\text{s}$  (commercial) or 3.9607 $\mu\text{s}$  (industrial and automotive). To ensure all rows of all banks are properly refreshed, 8,192 REFRESH commands must be issued every 64ms (commercial) or 32ms (industrial and automotive). The JEDEC  $t_{RFC}$  MAX of 70,000ns is not required as bursting of AUTO REFRESH commands is allowed.
42.  $t_{DELAY}$  is calculated from  $t_{IS} + t_{CK} + t_{IH}$  so that CKE registration LOW is guaranteed prior to CK, CK# being removed in a system RESET condition (see (page 0)).
43.  $t_{ISXR}$  is equal to  $t_{IS}$  and is used for CKE setup time during self refresh exit, as shown in Figure 68 (page 112).
44.  $t_{CKE}$  (MIN) of three clocks means CKE must be registered on three consecutive positive clock edges. CKE must remain at the valid input level the entire time it takes to achieve the three clocks of registration. Thus, after any CKE transition, CKE may not transition from its valid level during the time period of  $t_{IS} + 2 \times t_{CK} + t_{IH}$ .
45. The half-clock of  $t_{AOFD}$ 's 2.5  $t_{CK}$  assumes a 50/50 clock duty cycle. This half-clock value must be derated by the amount of half-clock duty cycle error. For example, if the clock

- duty cycle was 47/53,  $t_{AOFD}$  would actually be 2.5 - 0.03, or 2.47, for  $t_{AOF}$  (MIN) and 2.5 + 0.03, or 2.53, for  $t_{AOF}$  (MAX).
46. ODT turn-on time  $t_{AON}$  (MIN) is when the device leaves High-Z and ODT resistance begins to turn on. ODT turn-on time  $t_{AON}$  (MAX) is when the ODT resistance is fully on. Both are measured from  $t_{AOND}$ .
  47. ODT turn-off time  $t_{AOF}$  (MIN) is when the device starts to turn off ODT resistance. ODT turn off time  $t_{AOF}$  (MAX) is when the bus is in High-Z. Both are measured from  $t_{AOFD}$ .
  48. Half-clock output parameters must be derated by the actual  $t_{ERR_{5per}}$  and  $t_{JITdy}$  when input clock jitter is present; this will result in each parameter becoming larger. The parameter  $t_{AOF}$  (MIN) is required to be derated by subtracting both  $t_{ERR_{5per}}$  (MAX) and  $t_{JITdy}$  (MAX). The parameter  $t_{AOF}$  (MAX) is required to be derated by subtracting both  $t_{ERR_{5perx}}$  (MIN) and  $t_{JITdy}$  (MIN).
  49. The -187E maximum limit is  $2 \times t_{CK} + t_{AC}$  (MAX) + 1,000 but it will likely be  $3 \times t_{CK} + t_{AC}$  (MAX) + 1,000 in the future.
  50. Should use 8  $t_{CK}$  for backward compatibility.

## AC and DC Operating Conditions

**Table 12: Recommended DC Operating Conditions (SSTL\_18)**

All voltages referenced to  $V_{SS}$

| Parameter                        | Symbol        | Min                   | Nom                   | Max                   | Units | Notes |
|----------------------------------|---------------|-----------------------|-----------------------|-----------------------|-------|-------|
| Supply voltage                   | $V_{DD}$      | 1.5                   | 1.55                  | 1.9                   | V     | 1, 2  |
| $V_{DDL}$ supply voltage         | $V_{DDL}$     | 1.5                   | 1.55                  | 1.9                   | V     | 2, 3  |
| I/O supply voltage               | $V_{DDQ}$     | 1.5                   | 1.55                  | 1.9                   | V     | 2, 3  |
| I/O reference voltage            | $V_{REF(DC)}$ | $0.49 \times V_{DDQ}$ | $0.50 \times V_{DDQ}$ | $0.51 \times V_{DDQ}$ | V     | 4     |
| I/O termination voltage (system) | $V_{TT}$      | $V_{REF(DC)} - 40$    | $V_{REF(DC)}$         | $V_{REF(DC)} + 40$    | mV    | 5     |

- Notes:
1.  $V_{DD}$  and  $V_{DDQ}$  must track each other. If  $V_{DD} < 1.7V$ , then  $V_{DD} - 0.05V \leq V_{DDQ} \leq V_{DD}$ ; else  $V_{DD} - 0.1V \leq V_{DDQ} \leq V_{DD}$ .
  2.  $V_{SSQ} = V_{SSL} = V_{SS}$ .
  3.  $V_{DDQ}$  tracks with  $V_{DD}$ ;  $V_{DDL}$  tracks with  $V_{DD}$ .
  4.  $V_{REF}$  is expected to equal  $V_{DDQ}/2$  of the transmitting device and to track variations in the DC level of the same. Peak-to-peak noise (noncommon mode) on  $V_{REF}$  may not exceed  $\pm 1\%$  of the DC value. Peak-to-peak AC noise on  $V_{REF}$  may not exceed  $\pm 2\%$  of  $V_{REF(DC)}$ . This measurement is to be taken at the nearest  $V_{REF}$  bypass capacitor.
  5.  $V_{TT}$  is not applied directly to the device.  $V_{TT}$  is a system supply for signal termination resistors, is expected to be set equal to  $V_{REF}$ , and must track variations in the DC level of  $V_{REF}$ .

## ODT DC Electrical Characteristics

**Table 13: ODT DC Electrical Characteristics**

All voltages are referenced to  $V_{SS}$ ; 1.55V DDR2 SDRAM has NOM and MAX limit increase by 8% when  $V_{DD}$  is less than 1.7V.  $V_{DD} = +1.5V$  to  $+1.9V$ ,  $V_{DDQ} = +1.5V$  to  $+1.9V$ . If  $V_{DD} < 1.7V$  then  $V_{DD} - 0.05V \leq V_{DDQ} \leq V_{DD}$ ; else  $V_{DD} - 0.1V \leq V_{DDQ} \leq V_{DD}$ .

| Parameter                                                                         | Symbol                | Voltage Min | Min | Nom | Max | Units | Notes |
|-----------------------------------------------------------------------------------|-----------------------|-------------|-----|-----|-----|-------|-------|
| R <sub>TT</sub> effective impedance value for 75Ω setting<br>EMR (A6, A2) = 0, 1  | R <sub>TT1(EFF)</sub> | 1.7V        | 60  | 75  | 90  | Ω     | 1, 2  |
|                                                                                   |                       | 1.5V        | 60  | 80  | 98  | Ω     |       |
| R <sub>TT</sub> effective impedance value for 150Ω setting<br>EMR (A6, A2) = 1, 0 | R <sub>TT2(EFF)</sub> | 1.7V        | 120 | 150 | 180 | Ω     | 1, 2  |
|                                                                                   |                       | 1.5V        | 120 | 160 | 195 | Ω     |       |
| R <sub>TT</sub> effective impedance value for 50Ω setting<br>EMR (A6, A2) = 1, 1  | R <sub>TT3(EFF)</sub> | 1.7V        | 40  | 50  | 60  | Ω     | 1, 2  |
|                                                                                   |                       | 1.5V        | 40  | 55  | 65  | Ω     |       |
| Deviation of VM with respect to $V_{DDQ}/2$                                       | ΔVM                   | –           | –6  | –   | 6   | %     | 3     |

Notes: 1. R<sub>TT1(EFF)</sub> and R<sub>TT2(EFF)</sub> are determined by separately applying  $V_{IH(AC)}$  and  $V_{IL(DC)}$  to the ball being tested, and then measuring current,  $I(V_{IH(AC)})$ , and  $I(V_{IL(AC)})$ , respectively.

$$R_{TT(EFF)} = \frac{V_{IH(AC)} - V_{IL(AC)}}{I(V_{IH(AC)}) - I(V_{IL(AC)})}$$

- Minimum IT and AT device values are derated by six percent when the devices operate between  $-40^{\circ}\text{C}$  and  $0^{\circ}\text{C}$  ( $T_C$ ).
- Measure voltage (VM) at tested ball with no load.

$$\Delta VM = \left( \frac{2 \times VM}{V_{DDQ}} - 1 \right) \times 100$$

## Input Electrical Characteristics and Operating Conditions

**Table 14: Input DC Logic Levels**

All voltages are referenced to  $V_{SS}$

| Parameter                    | Symbol       | Min                 | Max                 | Units |
|------------------------------|--------------|---------------------|---------------------|-------|
| Input high (logic 1) voltage | $V_{IH(DC)}$ | $V_{REF(DC)} + 125$ | $V_{DDQ}^1$         | mV    |
| Input low (logic 0) voltage  | $V_{IL(DC)}$ | -300                | $V_{REF(DC)} - 125$ | mV    |

Note: 1.  $V_{DDQ} + 300\text{mV}$  allowed provided 1.9V is not exceeded.

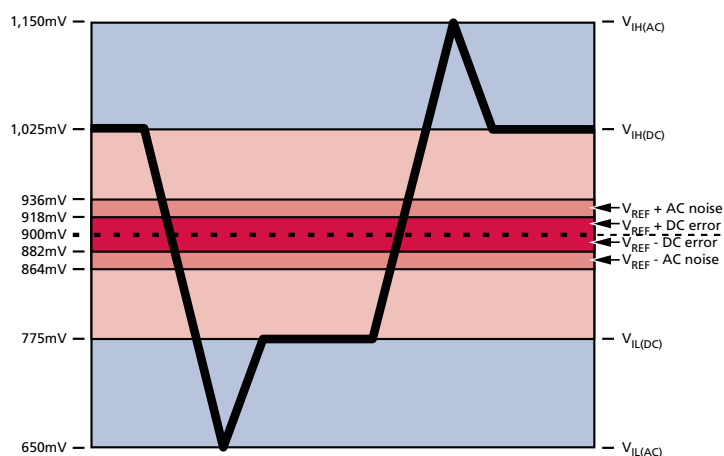
**Table 15: Input AC Logic Levels**

All voltages are referenced to  $V_{SS}$

| Parameter                                            | Symbol       | Min                 | Max                      | Units |
|------------------------------------------------------|--------------|---------------------|--------------------------|-------|
| Input high (logic 1) voltage (-37E/-5E)              | $V_{IH(AC)}$ | $V_{REF(DC)} + 250$ | $V_{DDQ}^1 + V_{peak}^1$ | mV    |
| Input high (logic 1) voltage (-187E/-25E/-25/-3E/-3) | $V_{IH(AC)}$ | $V_{REF(DC)} + 200$ | $V_{DDQ}^1 + V_{peak}^1$ | mV    |
| Input low (logic 0) voltage (-37E/-5E)               | $V_{IL(AC)}$ | -300                | $V_{REF(DC)} - 250$      | mV    |
| Input low (logic 0) voltage (-187E/-25E/-25/-3E/-3)  | $V_{IL(AC)}$ | -300                | $V_{REF(DC)} - 200$      | mV    |

Note: 1. Refer to AC Overshoot/Undershoot Specification (page 51).

**Figure 12: Single-Ended Input Signal Levels**



Note: 1. Numbers in diagram reflect nominal DDR2-400/DDR2-533 values.

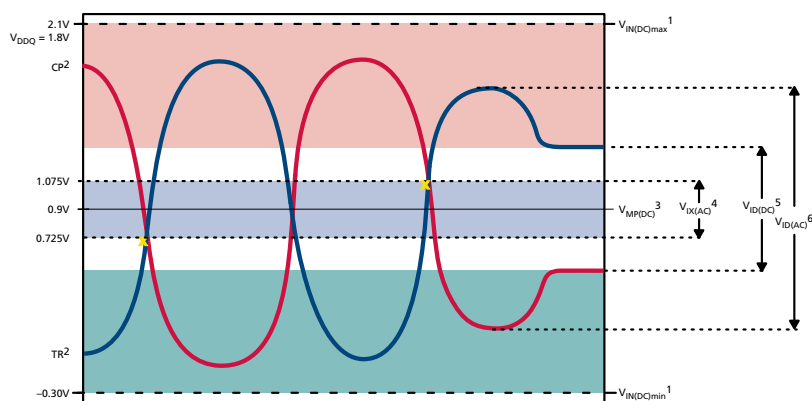
**Table 16: Differential Input Logic Levels**

All voltages referenced to  $V_{SS}$

| Parameter                           | Symbol       | Min                         | Max                         | Units | Notes |
|-------------------------------------|--------------|-----------------------------|-----------------------------|-------|-------|
| DC input signal voltage             | $V_{IN(DC)}$ | -300                        | $V_{DDQ}$                   | mV    | 1, 6  |
| DC differential input voltage       | $V_{ID(DC)}$ | 250                         | $V_{DDQ}$                   | mV    | 2, 6  |
| AC differential input voltage       | $V_{ID(AC)}$ | 500                         | $V_{DDQ}$                   | mV    | 3, 6  |
| AC differential cross-point voltage | $V_{IX(AC)}$ | $0.50 \times V_{DDQ} - 175$ | $0.50 \times V_{DDQ} + 175$ | mV    | 4     |
| Input midpoint voltage              | $V_{MP(DC)}$ | $V_{REF(DC)} - 50$          | $V_{REF(DC)} + 50$          | mV    | 5     |

- Notes:
1.  $V_{IN(DC)}$  specifies the allowable DC execution of each input of differential pair such as CK, CK#, DQS, DQS#, LDQS, LDQS#, UDQS, UDQS#, and RDQS, RDQS#.
  2.  $V_{ID(DC)}$  specifies the input differential voltage  $|V_{TR} - V_{CP}|$  required for switching, where  $V_{TR}$  is the true input (such as CK, DQS, LDQS, UDQS) level and  $V_{CP}$  is the complementary input (such as CK#, DQS#, LDQS#, UDQS#, RDQS#) level. The minimum value is equal to  $V_{IH(DC)} - V_{IL(DC)}$ . Differential input signal levels are shown in Figure 13.
  3.  $V_{ID(AC)}$  specifies the input differential voltage  $|V_{TR} - V_{CP}|$  required for switching, where  $V_{TR}$  is the true input (such as CK, DQS, LDQS, UDQS, RDQS) level and  $V_{CP}$  is the complementary input (such as CK#, DQS#, LDQS#, UDQS#, RDQS#) level. The minimum value is equal to  $V_{IH(AC)} - V_{IL(AC)}$ , as shown in Table 15 (page 41).
  4. The typical value of  $V_{IX(AC)}$  is expected to be about  $0.5 \times V_{DDQ}$  of the transmitting device and  $V_{IX(AC)}$  is expected to track variations in  $V_{DDQ}$ .  $V_{IX(AC)}$  indicates the voltage at which differential input signals must cross, as shown in Figure 13.
  5.  $V_{MP(DC)}$  specifies the input differential common mode voltage  $(V_{TR} + V_{CP})/2$  where  $V_{TR}$  is the true input (CK, DQS) level and  $V_{CP}$  is the complementary input (CK#, DQS#).  $V_{MP(DC)}$  is expected to be approximately  $0.5 \times V_{DDQ}$ .
  6.  $V_{DDQ} + 300\text{mV}$  allowed provided 1.9V is not exceeded.

**Figure 13: Differential Input Signal Levels**



- Notes:
1. TR and CP may not be more positive than  $V_{DDQ} + 0.3\text{V}$  or more negative than  $V_{SS} - 0.3\text{V}$ .
  2. TR represents the CK, DQS, RDQS, LDQS, and UDQS signals; CP represents CK#, DQS#, RDQS#, LDQS#, and UDQS# signals.
  3. This provides a minimum of  $V_{REF(DC)} - 50$  to a maximum of  $V_{REF(DC)} + 50$  and is expected to be  $V_{DDQ}/2$ .
  4. TR and CP must cross in this region.
  5. TR and CP must meet at least  $V_{ID(DC)min}$  when static and is centered around  $V_{MP(DC)}$ .
  6. TR and CP must have a minimum 500mV peak-to-peak swing.



## 1Gb: x4, x8, x16 1.55V DDR2 SDRAM Input Electrical Characteristics and Operating Conditions

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7. Numbers in diagram reflect nominal values ( $V_{DDQ} = 1.8V$ ).

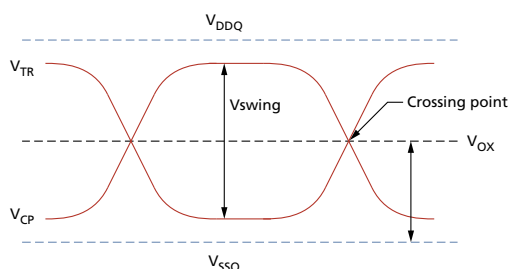
## Output Electrical Characteristics and Operating Conditions

**Table 17: Differential AC Output Parameters**

| Parameter                           | Symbol       | Min                         | Max                         | Units | Notes |
|-------------------------------------|--------------|-----------------------------|-----------------------------|-------|-------|
| AC differential cross-point voltage | $V_{OX(AC)}$ | $0.50 \times V_{DDQ} - 125$ | $0.50 \times V_{DDQ} + 125$ | mV    | 1     |
| AC differential voltage swing       | Vswing       | 1.0                         | –                           | mV    |       |

Note: 1. The typical value of  $V_{OX(AC)}$  is expected to be about  $0.5 \times V_{DDQ}$  of the transmitting device and  $V_{OX(AC)}$  is expected to track variations in  $V_{DDQ}$ .  $V_{OX(AC)}$  indicates the voltage at which differential output signals must cross.

**Figure 14: Differential Output Signal Levels**



**Table 18: Output DC Current Drive**

| Parameter                    | Symbol   | Value | Units | Notes   |
|------------------------------|----------|-------|-------|---------|
| Output MIN source DC current | $I_{OH}$ | -13.4 | mA    | 1, 2, 4 |
| Output MIN sink DC current   | $I_{OL}$ | 13.4  | mA    | 2, 3, 4 |

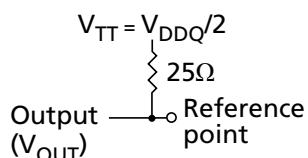
- Notes:
1. For  $I_{OH(DC)}$ ;  $V_{DDQ} = 1.7V$ ,  $V_{OUT} = 1,420mV$ .  $(V_{OUT} - V_{DDQ})/I_{OH}$  must be less than  $21\Omega$  for values of  $V_{OUT}$  between  $V_{DDQ}$  and  $V_{DDQ} - 280mV$ .
  2. For  $I_{OL(DC)}$ ;  $V_{DDQ} = 1.7V$ ,  $V_{OUT} = 280mV$ .  $V_{OUT}/I_{OL}$  must be less than  $21\Omega$  for values of  $V_{OUT}$  between  $0V$  and  $280mV$ .
  3. The DC value of  $V_{REF}$  applied to the receiving device is set to  $V_{TT}$ .
  4. The values of  $I_{OH(DC)}$  and  $I_{OL(DC)}$  are based on the conditions given in Notes 1 and 2. They are used to test device drive current capability to ensure  $V_{IHmin}$  plus a noise margin and  $V_{ILmax}$  minus a noise margin are delivered to an SSTL\_18 receiver. The actual current values are derived by shifting the desired driver operating point (see output IV curves) along a  $21\Omega$  load line to define a convenient driver current for measurement.

**Table 19: Output Characteristics**

| Parameter                      | Min                                         | Nom | Max | Units    | Notes      |
|--------------------------------|---------------------------------------------|-----|-----|----------|------------|
| Output impedance               | See Output Driver Characteristics (page 46) |     |     | $\Omega$ | 1, 2       |
| Pull-up and pull-down mismatch | 0                                           | –   | 4   | $\Omega$ | 1, 2, 3    |
| Output slew rate               | $V_{DDmin} = 1.7V$                          | 1.5 | 7   | V/ns     | 4, 5, 6, 7 |
|                                | $V_{DDmin} = 1.5V$                          | 0.8 | 7   | V/ns     | 4, 5, 6, 7 |

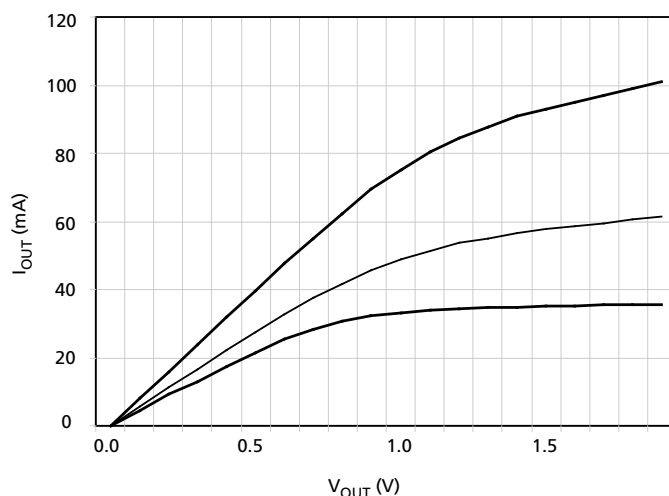
- Notes:
1. Absolute specifications:  $0^{\circ}C \leq T_C \leq +85^{\circ}C$ ;  $V_{DDQ} = +1.8V \pm 0.1V$ ,  $V_{DD} = +1.8V \pm 0.1V$ .
  2. Impedance measurement conditions for output source DC current:  $V_{DDQ} = 1.7V$ ;  $V_{OUT} = 1,420mV$ ;  $(V_{OUT} - V_{DDQ})/I_{OH}$  must be less than  $23.4\Omega$  for values of  $V_{OUT}$  between  $V_{DDQ}$  and  $V_{DDQ} - 280mV$ . The impedance measurement condition for output sink DC current:  $V_{DDQ} = 1.7V$ ;  $V_{OUT} = 280mV$ ;  $V_{OUT}/I_{OL}$  must be less than  $23.4\Omega$  for values of  $V_{OUT}$  between  $0V$  and  $280mV$ .
  3. Mismatch is an absolute value between pull-up and pull-down; both are measured at the same temperature and voltage.
  4. Output slew rate for falling and rising edges is measured between  $V_{TT} - 250mV$  and  $V_{TT} + 250mV$  for single-ended signals. For differential signals (DQS, DQS#), output slew rate is measured between  $DQS - DQS\# = -500mV$  and  $DQS\# - DQS = +500mV$ . Output slew rate is guaranteed by design but is not necessarily tested on each device.
  5. The absolute value of the slew rate as measured from  $V_{IL(DC)max}$  to  $V_{IH(DC)min}$  is equal to or greater than the slew rate as measured from  $V_{IL(AC)max}$  to  $V_{IH(AC)min}$ . This is guaranteed by design and characterization.
  6. IT and AT devices require an additional  $0.4 V/ns$  in the MAX limit when  $T_C$  is between  $-40^{\circ}C$  and  $0^{\circ}C$ .
  7. The output impedance drive curves MIN limit requires a 10% reduction when  $V_{DD}$  is between  $1.7V$  and  $1.5V$ .

**Figure 15: Output Slew Rate Load**



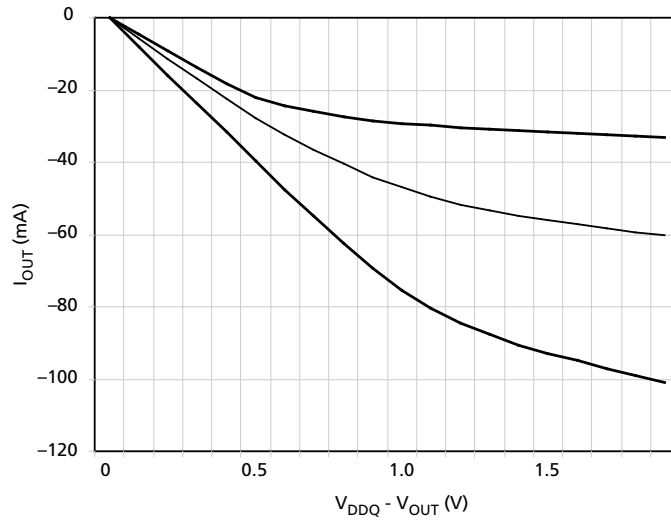
## Output Driver Characteristics

**Figure 16: Full Strength Pull-Down Characteristics**

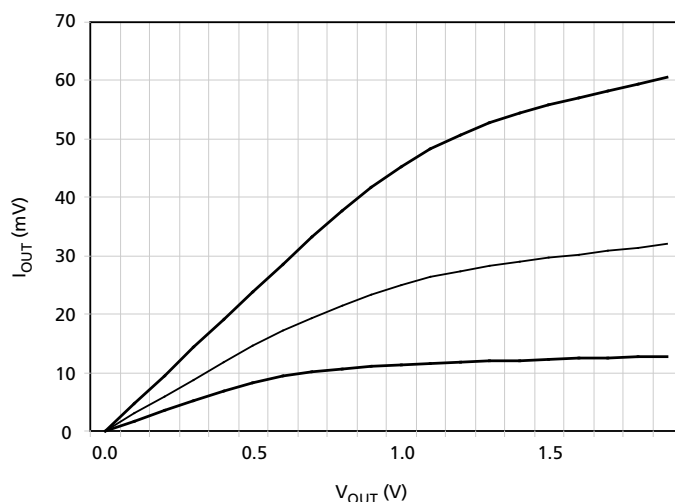


**Table 20: Full Strength Pull-Down Current (mA)**

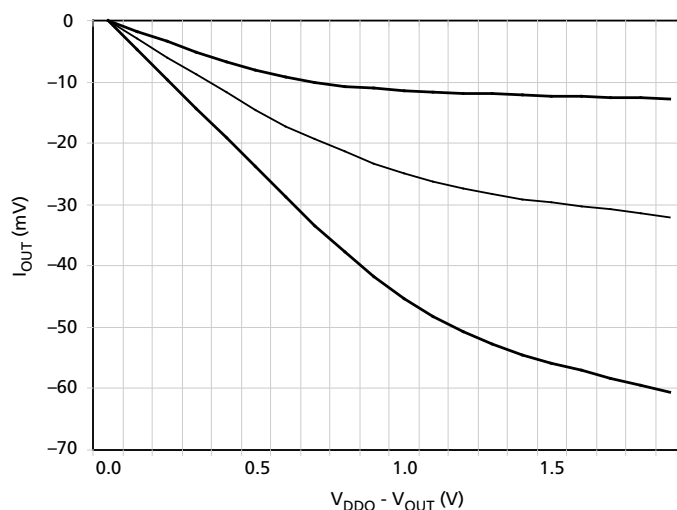
| Voltage (V) | Min   | Nom   | Max    |
|-------------|-------|-------|--------|
| 0.0         | 0.00  | 0.00  | 0.00   |
| 0.1         | 4.30  | 5.63  | 7.95   |
| 0.2         | 8.60  | 11.30 | 15.90  |
| 0.3         | 12.90 | 16.52 | 23.85  |
| 0.4         | 16.90 | 22.19 | 31.80  |
| 0.5         | 20.40 | 27.59 | 39.75  |
| 0.6         | 23.28 | 32.39 | 47.70  |
| 0.7         | 25.44 | 36.45 | 55.55  |
| 0.8         | 26.79 | 40.38 | 62.95  |
| 0.9         | 27.67 | 44.01 | 69.55  |
| 1.0         | 28.38 | 47.01 | 75.35  |
| 1.1         | 28.96 | 49.63 | 80.35  |
| 1.2         | 29.46 | 51.71 | 84.55  |
| 1.3         | 29.90 | 53.32 | 87.95  |
| 1.4         | 30.29 | 54.9  | 90.70  |
| 1.5         | 30.65 | 56.03 | 93.00  |
| 1.6         | 30.98 | 57.07 | 95.05  |
| 1.7         | 31.31 | 58.16 | 97.05  |
| 1.8         | 31.64 | 59.27 | 99.05  |
| 1.9         | 31.96 | 60.35 | 101.05 |

**Figure 17: Full Strength Pull-Up Characteristics**

**Table 21: Full Strength Pull-Up Current (mA)**

| Voltage (V) | Min    | Nom    | Max     |
|-------------|--------|--------|---------|
| 0.0         | 0.00   | 0.00   | 0.00    |
| 0.1         | -4.30  | -5.63  | -7.95   |
| 0.2         | -8.60  | -11.30 | -15.90  |
| 0.3         | -12.90 | -16.52 | -23.85  |
| 0.4         | -16.90 | -22.19 | -31.80  |
| 0.5         | -20.40 | -27.59 | -39.75  |
| 0.6         | -23.28 | -32.39 | -47.70  |
| 0.7         | -25.44 | -36.45 | -55.55  |
| 0.8         | -26.79 | -40.38 | -62.95  |
| 0.9         | -27.67 | -44.01 | -69.55  |
| 1.0         | -28.38 | -47.01 | -75.35  |
| 1.1         | -28.96 | -49.63 | -80.35  |
| 1.2         | -29.46 | -51.71 | -84.55  |
| 1.3         | -29.90 | -53.32 | -87.95  |
| 1.4         | -30.29 | -54.90 | -90.70  |
| 1.5         | -30.65 | -56.03 | -93.00  |
| 1.6         | -30.98 | -57.07 | -95.05  |
| 1.7         | -31.31 | -58.16 | -97.05  |
| 1.8         | -31.64 | -59.27 | -99.05  |
| 1.9         | -31.96 | -60.35 | -101.05 |

**Figure 18: Reduced Strength Pull-Down Characteristics**

**Table 22: Reduced Strength Pull-Down Current (mA)**

| Voltage (V) | Min   | Nom   | Max   |
|-------------|-------|-------|-------|
| 0.0         | 0.00  | 0.00  | 0.00  |
| 0.1         | 1.72  | 2.98  | 4.77  |
| 0.2         | 3.44  | 5.99  | 9.54  |
| 0.3         | 5.16  | 8.75  | 14.31 |
| 0.4         | 6.76  | 11.76 | 19.08 |
| 0.5         | 8.16  | 14.62 | 23.85 |
| 0.6         | 9.31  | 17.17 | 28.62 |
| 0.7         | 10.18 | 19.32 | 33.33 |
| 0.8         | 10.72 | 21.40 | 37.77 |
| 0.9         | 11.07 | 23.32 | 41.73 |
| 1.0         | 11.35 | 24.92 | 45.21 |
| 1.1         | 11.58 | 26.30 | 48.21 |
| 1.2         | 11.78 | 27.41 | 50.73 |
| 1.3         | 11.96 | 28.26 | 52.77 |
| 1.4         | 12.12 | 29.10 | 54.42 |
| 1.5         | 12.26 | 29.70 | 55.80 |
| 1.6         | 12.39 | 30.25 | 57.03 |
| 1.7         | 12.52 | 30.82 | 58.23 |
| 1.8         | 12.66 | 31.41 | 59.43 |
| 1.9         | 12.78 | 31.98 | 60.63 |

**Figure 19: Reduced Strength Pull-Up Characteristics**

**Table 23: Reduced Strength Pull-Up Current (mA)**

| Voltage (V) | Min    | Nom    | Max    |
|-------------|--------|--------|--------|
| 0.0         | 0.00   | 0.00   | 0.00   |
| 0.1         | -1.72  | -2.98  | -4.77  |
| 0.2         | -3.44  | -5.99  | -9.54  |
| 0.3         | -5.16  | -8.75  | -14.31 |
| 0.4         | -6.76  | -11.76 | -19.08 |
| 0.5         | -8.16  | -14.62 | -23.85 |
| 0.6         | -9.31  | -17.17 | -28.62 |
| 0.7         | -10.18 | -19.32 | -33.33 |
| 0.8         | -10.72 | -21.40 | -37.77 |
| 0.9         | -11.07 | -23.32 | -41.73 |
| 1.0         | -11.35 | -24.92 | -45.21 |
| 1.1         | -11.58 | -26.30 | -48.21 |
| 1.2         | -11.78 | -27.41 | -50.73 |
| 1.3         | -11.96 | -28.26 | -52.77 |
| 1.4         | -12.12 | -29.10 | -54.42 |
| 1.5         | -12.26 | -29.69 | -55.8  |
| 1.6         | -12.39 | -30.25 | -57.03 |
| 1.7         | -12.52 | -30.82 | -58.23 |
| 1.8         | -12.66 | -31.42 | -59.43 |
| 1.9         | -12.78 | -31.98 | -60.63 |

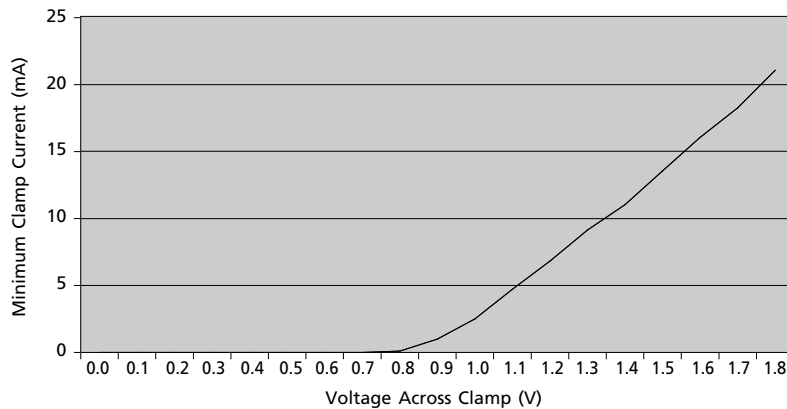
## Power and Ground Clamp Characteristics

Power and ground clamps are provided on the following input-only balls: Address balls, bank address balls, CS#, RAS#, CAS#, WE#, ODT, and CKE.

**Table 24: Input Clamp Characteristics**

| Voltage Across Clamp (V) | Minimum Power Clamp Current (mA) | Minimum Ground Clamp Current (mA) |
|--------------------------|----------------------------------|-----------------------------------|
| 0.0                      | 0.0                              | 0.0                               |
| 0.1                      | 0.0                              | 0.0                               |
| 0.2                      | 0.0                              | 0.0                               |
| 0.3                      | 0.0                              | 0.0                               |
| 0.4                      | 0.0                              | 0.0                               |
| 0.5                      | 0.0                              | 0.0                               |
| 0.6                      | 0.0                              | 0.0                               |
| 0.7                      | 0.0                              | 0.0                               |
| 0.8                      | 0.1                              | 0.1                               |
| 0.9                      | 1.0                              | 1.0                               |
| 1.0                      | 2.5                              | 2.5                               |
| 1.1                      | 4.7                              | 4.7                               |
| 1.2                      | 6.8                              | 6.8                               |
| 1.3                      | 9.1                              | 9.1                               |
| 1.4                      | 11.0                             | 11.0                              |
| 1.5                      | 13.5                             | 13.5                              |
| 1.6                      | 16.0                             | 16.0                              |
| 1.7                      | 18.2                             | 18.2                              |
| 1.8                      | 21.0                             | 21.0                              |

**Figure 20: Input Clamp Characteristics**



## AC Overshoot/Undershoot Specification

Some revisions will support the 0.9V maximum average amplitude instead of the 0.5V maximum average amplitude shown in Table 25 and Table 26.

**Table 25: Address and Control Balls**

Applies to address balls, bank address balls, CS#, RAS#, CAS#, WE#, CKE, and ODT

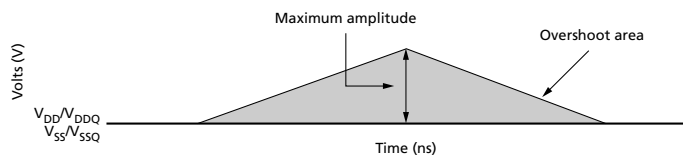
| Parameter                                                          | Specification |          |          |          |          |
|--------------------------------------------------------------------|---------------|----------|----------|----------|----------|
|                                                                    | -187E         | -25/-25E | -3/-3E   | -37E     | -5E      |
| Maximum peak amplitude allowed for overshoot area (see Figure 21)  | 0.50V         | 0.50V    | 0.50V    | 0.50V    | 0.50V    |
| Maximum peak amplitude allowed for undershoot area (see Figure 22) | 0.50V         | 0.50V    | 0.50V    | 0.50V    | 0.50V    |
| Maximum overshoot area above $V_{DD}$ (see Figure 21)              | 0.5 Vns       | 0.66 Vns | 0.80 Vns | 1.00 Vns | 1.33 Vns |
| Maximum undershoot area below $V_{SS}$ (see Figure 22)             | 0.5 Vns       | 0.66 Vns | 0.80 Vns | 1.00 Vns | 1.33 Vns |

**Table 26: Clock, Data, Strobe, and Mask Balls**

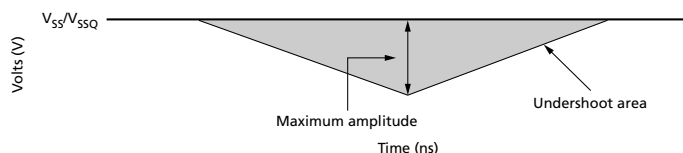
Applies to DQ, DQS, DQS#, RDQS, RDQS#, UDQS, UDQS#, LDQS, LDQS#, DM, UDM, and LDM

| Parameter                                                          | Specification |          |          |          |          |
|--------------------------------------------------------------------|---------------|----------|----------|----------|----------|
|                                                                    | -187E         | -25/-25E | -3/-3E   | -37E     | -5E      |
| Maximum peak amplitude allowed for overshoot area (see Figure 21)  | 0.50V         | 0.50V    | 0.50V    | 0.50V    | 0.50V    |
| Maximum peak amplitude allowed for undershoot area (see Figure 22) | 0.50V         | 0.50V    | 0.50V    | 0.50V    | 0.50V    |
| Maximum overshoot area above $V_{DDQ}$ (see Figure 21)             | 0.19 Vns      | 0.23 Vns | 0.23 Vns | 0.28 Vns | 0.38 Vns |
| Maximum undershoot area below $V_{SSQ}$ (see Figure 22)            | 0.19 Vns      | 0.23 Vns | 0.23 Vns | 0.28 Vns | 0.38 Vns |

**Figure 21: Overshoot**



**Figure 22: Undershoot**



**Table 27: AC Input Test Conditions**

| Parameter                                                                                                                                                   | Symbol        | Min                   | Max                   | Units | Notes         |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------|-----------------------|-----------------------|-------|---------------|
| Input setup timing measurement reference level address balls, bank address balls, CS#, RAS#, CAS#, WE#, ODT, DM, UDM, LDM, and CKE                          | $V_{RS}$      | See Note 2            |                       |       | 1, 2, 3, 4    |
| Input hold timing measurement reference level address balls, bank address balls, CS#, RAS#, CAS#, WE#, ODT, DM, UDM, LDM, and CKE                           | $V_{RH}$      | See Note 5            |                       |       | 1, 3, 4, 5    |
| Input timing measurement reference level (single-ended) DQS for x4, x8; UDQS, LDQS for x16                                                                  | $V_{REF(DC)}$ | $V_{DDQ} \times 0.49$ | $V_{DDQ} \times 0.51$ | V     | 1, 3, 4, 6    |
| Input timing measurement reference level (differential) CK, CK# for x4, x8, x16; DQS, DQS# for x4, x8; RDQS, RDQS# for x8; UDQS, UDQS#, LDQS, LDQS# for x16 | $V_{RD}$      | $V_{IX(AC)}$          |                       | V     | 1, 3, 7, 8, 9 |

- Notes:
1. All voltages referenced to  $V_{SS}$ .
  2. Input waveform setup timing ( $t_{ISb}$ ) is referenced from the input signal crossing at the  $V_{IH(AC)}$  level for a rising signal and  $V_{IL(AC)}$  for a falling signal applied to the device under test, as shown in Figure 31 (page 64).
  3. See Input Slew Rate Derating (page 53).
  4. The slew rate for single-ended inputs is measured from DC level to AC level,  $V_{IL(DC)}$  to  $V_{IH(AC)}$  on the rising edge and  $V_{IL(AC)}$  to  $V_{IH(DC)}$  on the falling edge. For signals referenced to  $V_{REF}$ , the valid intersection is where the "tangent" line intersects  $V_{REF}$ , as shown in Figure 24 (page 56), Figure 26 (page 57), Figure 28 (page 62), and Figure 30 (page 63).
  5. Input waveform hold ( $t_{IHb}$ ) timing is referenced from the input signal crossing at the  $V_{IL(DC)}$  level for a rising signal and  $V_{IH(DC)}$  for a falling signal applied to the device under test, as shown in Figure 31 (page 64).
  6. Input waveform setup timing ( $t_{DS}$ ) and hold timing ( $t_{DH}$ ) for single-ended data strobe is referenced from the crossing of DQS, UDQS, or LDQS through the  $V_{ref}$  level applied to the device under test, as shown in Figure 33 (page 65).
  7. Input waveform setup timing ( $t_{DS}$ ) and hold timing ( $t_{DH}$ ) when differential data strobe is enabled is referenced from the cross-point of DQS/DQS#, UDQS/UDQS#, or LDQS/LDQS#, as shown in Figure 32 (page 64).
  8. Input waveform timing is referenced to the crossing point level ( $V_{IX}$ ) of two input signals ( $V_{TR}$  and  $V_{CP}$ ) applied to the device under test, where  $V_{TR}$  is the true input signal and  $V_{CP}$  is the complementary input signal, as shown in Figure 34 (page 65).
  9. The slew rate for differentially ended inputs is measured from twice the DC level to twice the AC level:  $2 \times V_{IL(DC)}$  to  $2 \times V_{IH(AC)}$  on the rising edge and  $2 \times V_{IL(AC)}$  to  $2 \times V_{IH(DC)}$  on the falling edge. For example, the CK/CK# would be  $-250mV$  to  $+500mV$  for CK rising edge and would be  $+250mV$  to  $-500mV$  for CK falling edge.

## Input Slew Rate Derating

For all input signals, the total  $t_{IS}$  (setup time) and  $t_{IH}$  (hold time) required is calculated by adding the data sheet  $t_{IS}$  (base) and  $t_{IH}$  (base) value to the  $\Delta t_{IS}$  and  $\Delta t_{IH}$  derating value, respectively. Example:  $t_{IS}$  (total setup time) =  $t_{IS}$  (base) +  $\Delta t_{IS}$ .

$t_{IS}$ , the nominal slew rate for a rising signal, is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IH(AC)min}$ . Setup nominal slew rate ( $t_{IS}$ ) for a falling signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IL(AC)max}$ .

If the actual signal is always earlier than the nominal slew rate line between shaded " $V_{REF(DC)}$  to AC region," use the nominal slew rate for the derating value (Figure 23 (page 56)).

If the actual signal is later than the nominal slew rate line anywhere between the shaded " $V_{REF(DC)}$  to AC region," the slew rate of a tangent line to the actual signal from the AC level to DC level is used for the derating value (see Figure 24 (page 56)).

$t_{IH}$ , the nominal slew rate for a rising signal, is defined as the slew rate between the last crossing of  $V_{IL(DC)max}$  and the first crossing of  $V_{REF(DC)}$ .  $t_{IH}$ , nominal slew rate for a falling signal, is defined as the slew rate between the last crossing of  $V_{IH(DC)min}$  and the first crossing of  $V_{REF(DC)}$ .

If the actual signal is always later than the nominal slew rate line between shaded "DC to  $V_{REF(DC)}$  region," use the nominal slew rate for the derating value (Figure 25 (page 57)).

If the actual signal is earlier than the nominal slew rate line anywhere between shaded "DC to  $V_{REF(DC)}$  region," the slew rate of a tangent line to the actual signal from the DC level to  $V_{REF(DC)}$  level is used for the derating value (Figure 26 (page 57)).

Although the total setup time might be negative for slow slew rates (a valid input signal will not have reached  $V_{IH(AC)}/V_{IL(AC)}$  at the time of the rising clock transition), a valid input signal is still required to complete the transition and reach  $V_{IH(AC)}/V_{IL(AC)}$ .

For slew rates in between the values listed in Table 28 (page 54) and Table 29 (page 55), the derating values may be obtained by linear interpolation.

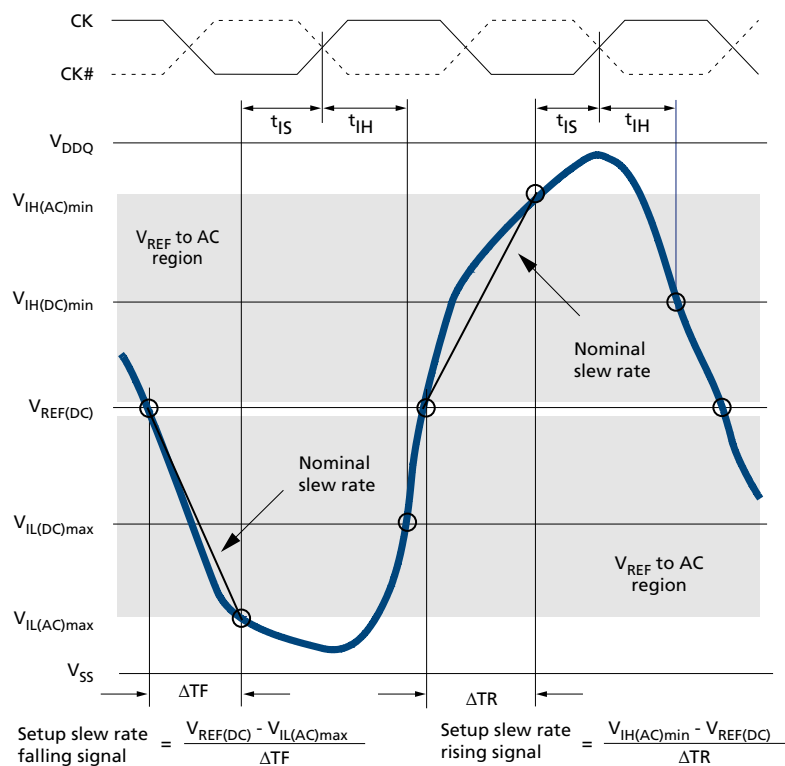
**Table 28: DDR2-400/533 Setup and Hold Time Derating Values ( $t_{IS}$  and  $t_{IH}$ )**

| Command/Address Slew Rate (V/ns) | CK, CK# Differential Slew Rate |                 |                 |                 |                 |                 | Units |
|----------------------------------|--------------------------------|-----------------|-----------------|-----------------|-----------------|-----------------|-------|
|                                  | 2.0 V/ns                       |                 | 1.5 V/ns        |                 | 1.0 V/ns        |                 |       |
|                                  | $\Delta t_{IS}$                | $\Delta t_{IH}$ | $\Delta t_{IS}$ | $\Delta t_{IH}$ | $\Delta t_{IS}$ | $\Delta t_{IH}$ |       |
| 4.0                              | +187                           | +94             | +217            | +124            | +247            | +154            | ps    |
| 3.5                              | +179                           | +89             | +209            | +119            | +239            | +149            | ps    |
| 3.0                              | +167                           | +83             | +197            | +113            | +227            | +143            | ps    |
| 2.5                              | +150                           | +75             | +180            | +105            | +210            | +135            | ps    |
| 2.0                              | +125                           | +45             | +155            | +75             | +185            | +105            | ps    |
| 1.5                              | +83                            | +21             | +113            | +51             | +143            | +81             | ps    |
| 1.0                              | 0                              | 0               | +30             | +30             | +60             | +60             | ps    |
| 0.9                              | -11                            | -14             | +19             | +16             | +49             | +46             | ps    |
| 0.8                              | -25                            | -31             | +5              | -1              | +35             | +29             | ps    |
| 0.7                              | -43                            | -54             | -13             | -24             | +17             | +6              | ps    |
| 0.6                              | -67                            | -83             | -37             | -53             | -7              | -23             | ps    |
| 0.5                              | -110                           | -125            | -80             | -95             | -50             | -65             | ps    |
| 0.4                              | -175                           | -188            | -145            | -158            | -115            | -128            | ps    |
| 0.3                              | -285                           | -292            | -255            | -262            | -225            | -232            | ps    |
| 0.25                             | -350                           | -375            | -320            | -345            | -290            | -315            | ps    |
| 0.2                              | -525                           | -500            | -495            | -470            | -465            | -440            | ps    |
| 0.15                             | -800                           | -708            | -770            | -678            | -740            | -648            | ps    |
| 0.1                              | -1,450                         | -1,125          | -1,420          | -1,095          | -1,390          | -1,065          | ps    |

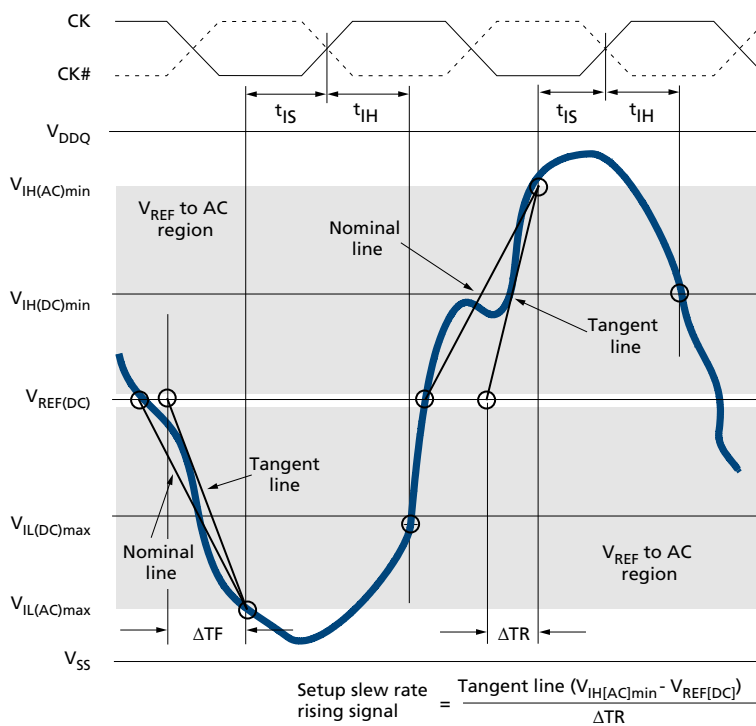
**Table 29: DDR2-667/800/1066 Setup and Hold Time Derating Values ( $t_{IS}$  and  $t_{IH}$ )**

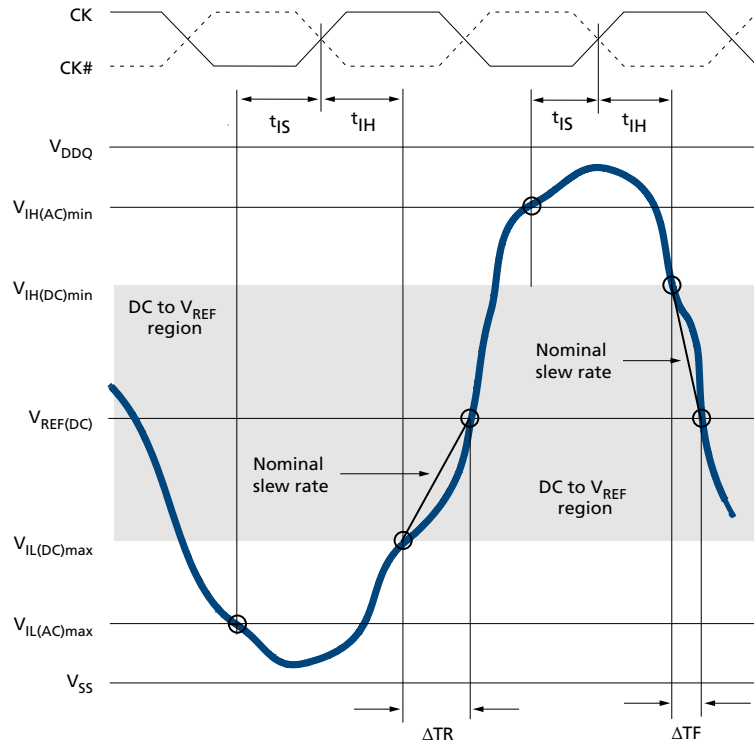
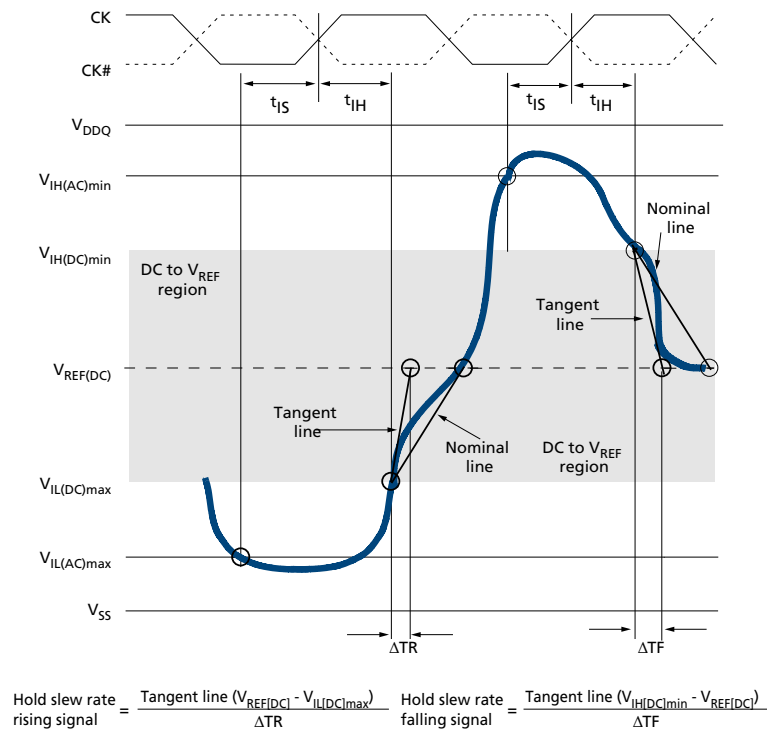
| Command/<br>Address Slew<br>Rate (V/ns) | CK, CK# Differential Slew Rate |                 |                 |                 |                 |                 | Units |
|-----------------------------------------|--------------------------------|-----------------|-----------------|-----------------|-----------------|-----------------|-------|
|                                         | 2.0 V/ns                       |                 | 1.5 V/ns        |                 | 1.0 V/ns        |                 |       |
|                                         | $\Delta t_{IS}$                | $\Delta t_{IH}$ | $\Delta t_{IS}$ | $\Delta t_{IH}$ | $\Delta t_{IS}$ | $\Delta t_{IH}$ |       |
| 4.0                                     | +150                           | +94             | +180            | +124            | +210            | +154            | ps    |
| 3.5                                     | +143                           | +89             | +173            | +119            | +203            | +149            | ps    |
| 3.0                                     | +133                           | +83             | +163            | +113            | +193            | +143            | ps    |
| 2.5                                     | +120                           | +75             | +150            | +105            | +180            | +135            | ps    |
| 2.0                                     | +100                           | +45             | +160            | +75             | +160            | +105            | ps    |
| 1.5                                     | +67                            | +21             | +97             | +51             | +127            | +81             | ps    |
| 1.0                                     | 0                              | 0               | +30             | +30             | +60             | +60             | ps    |
| 0.9                                     | -5                             | -14             | +25             | +16             | +55             | +46             | ps    |
| 0.8                                     | -13                            | -31             | +17             | -1              | +47             | +29             | ps    |
| 0.7                                     | -22                            | -54             | +8              | -24             | +38             | +6              | ps    |
| 0.6                                     | -34                            | -83             | -4              | -53             | +36             | -23             | ps    |
| 0.5                                     | -60                            | -125            | -30             | -95             | 0               | -65             | ps    |
| 0.4                                     | -100                           | -188            | -70             | -158            | -40             | -128            | ps    |
| 0.3                                     | -168                           | -292            | -138            | -262            | -108            | -232            | ps    |
| 0.25                                    | -200                           | -375            | -170            | -345            | -140            | -315            | ps    |
| 0.2                                     | -325                           | -500            | -295            | -470            | -265            | -440            | ps    |
| 0.15                                    | -517                           | -708            | -487            | -678            | -457            | -648            | ps    |
| 0.1                                     | -1,000                         | -1,125          | -970            | -1,095          | -940            | -1,065          | ps    |

**Figure 23: Nominal Slew Rate for  $t_{IS}$**



**Figure 24: Tangent Line for  $t_{IS}$**



**Figure 25: Nominal Slew Rate for  $t_{IH}$** 

**Figure 26: Tangent Line for  $t_{IH}$** 


**Table 30: DDR2-400/533  $t_{DS}$ ,  $t_{DH}$  Derating Values with Differential Strobe**

All units are shown in picoseconds

| DQ Slew Rate (V/ns) | DQS, DQS# Differential Slew Rate |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |
|---------------------|----------------------------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|
|                     | 4.0 V/ns                         |                 | 3.0 V/ns        |                 | 2.0 V/ns        |                 | 1.8 V/ns        |                 | 1.6 V/ns        |                 | 1.4 V/ns        |                 | 1.2 V/ns        |                 | 1.0 V/ns        |                 | 0.8 V/ns        |                 |
|                     | $\Delta t_{DS}$                  | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ |
| 2.0                 | 125                              | 45              | 125             | 45              | 125             | 45              | —               | —               | —               | —               | —               | —               | —               | —               | —               | —               | —               | —               |
| 1.5                 | 83                               | 21              | 83              | 21              | 83              | 21              | 95              | 33              | —               | —               | —               | —               | —               | —               | —               | —               | —               | —               |
| 1.0                 | 0                                | 0               | 0               | 0               | 0               | 0               | 12              | 12              | 24              | 24              | —               | —               | —               | —               | —               | —               | —               | —               |
| 0.9                 | —                                | —               | -11             | -14             | -11             | -14             | 1               | -2              | 13              | 10              | 25              | 22              | —               | —               | —               | —               | —               | —               |
| 0.8                 | —                                | —               | —               | —               | -25             | -31             | -13             | -19             | -1              | -7              | 11              | 5               | 23              | 17              | —               | —               | —               | —               |
| 0.7                 | —                                | —               | —               | —               | —               | —               | -31             | -42             | -19             | -30             | -7              | -18             | 5               | -6              | 17              | 6               | —               | —               |
| 0.6                 | —                                | —               | —               | —               | —               | —               | —               | —               | -43             | -59             | -31             | -47             | -19             | -35             | -7              | -23             | 5               | -11             |
| 0.5                 | —                                | —               | —               | —               | —               | —               | —               | —               | —               | —               | -74             | -89             | -62             | -77             | -50             | -65             | -38             | -53             |
| 0.4                 | —                                | —               | —               | —               | —               | —               | —               | —               | —               | —               | —               | —               | -127            | -140            | -115            | -128            | -103            | -116            |

- Notes:
- For all input signals, the total  $t_{DS}$  and  $t_{DH}$  required is calculated by adding the data sheet value to the derating value listed in Table 30.
  - $t_{DS}$  nominal slew rate for a rising signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IH(AC)min}$ .  $t_{DS}$  nominal slew rate for a falling signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IL(AC)max}$ . If the actual signal is always earlier than the nominal slew rate line between the shaded " $V_{REF(DC)}$  to AC region," use the nominal slew rate for the derating value (see Figure 27 (page 62)). If the actual signal is later than the nominal slew rate line anywhere between the shaded " $V_{REF(DC)}$  to AC region," the slew rate of a tangent line to the actual signal from the AC level to DC level is used for the derating value (see Figure 28 (page 62)).
  - $t_{DH}$  nominal slew rate for a rising signal is defined as the slew rate between the last crossing of  $V_{IL(DC)max}$  and the first crossing of  $V_{REF(DC)}$ .  $t_{DH}$  nominal slew rate for a falling signal is defined as the slew rate between the last crossing of  $V_{IH(DC)min}$  and the first crossing of  $V_{REF(DC)}$ . If the actual signal is always later than the nominal slew rate line between the shaded "DC level to  $V_{REF(DC)}$  region," use the nominal slew rate for the derating value (see Figure 29 (page 63)). If the actual signal is earlier than the nominal slew rate line anywhere between shaded "DC to  $V_{REF(DC)}$  region," the slew rate of a tangent line to the actual signal from the DC level to  $V_{REF(DC)}$  level is used for the derating value (see Figure 30 (page 63)).
  - Although the total setup time might be negative for slow slew rates (a valid input signal will not have reached  $V_{IH(AC)}/V_{IL(AC)}$  at the time of the rising clock transition), a valid input signal is still required to complete the transition and reach  $V_{IH(AC)}/V_{IL(AC)}$ .
  - For slew rates between the values listed in this table, the derating values may be obtained by linear interpolation.
  - These values are typically not subject to production test. They are verified by design and characterization.
  - Single-ended DQS requires special derating. The values in Table 32 (page 60) are the DQS single-ended slew rate derating with DQS referenced at  $V_{REF}$  and DQ referenced at the logic levels  $t_{DS_b}$  and  $t_{DH_b}$ . Converting the derated base values from DQ referenced to the AC/DC trip points to DQ referenced to  $V_{REF}$  is listed in Table 34 (page 61) and Table 35 (page 61). Table 34 provides the  $V_{REF}$ -based fully derated values for the DQ ( $t_{DS_a}$  and  $t_{DH_a}$ ) for DDR2-533. Table 35 provides the  $V_{REF}$ -based fully derated values for the DQ ( $t_{DS_a}$  and  $t_{DH_a}$ ) for DDR2-400.

**Table 31: DDR2-667/800/1066  $t_{DS}$ ,  $t_{DH}$  Derating Values with Differential Strobe**

All units are shown in picoseconds

| DQ Slew Rate (V/ns) | DQS, DQS# Differential Slew Rate |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |
|---------------------|----------------------------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|
|                     | 2.8 V/ns                         |                 | 2.4 V/ns        |                 | 2.0 V/ns        |                 | 1.8 V/ns        |                 | 1.6 V/ns        |                 | 1.4 V/ns        |                 | 1.2 V/ns        |                 | 1.0 V/ns        |                 | 0.8 V/ns        |                 |
|                     | $\Delta t_{DS}$                  | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ | $\Delta t_{DS}$ | $\Delta t_{DH}$ |
| 2.0                 | 100                              | 63              | 100             | 63              | 100             | 63              | 112             | 75              | 124             | 87              | 136             | 99              | 148             | 111             | 160             | 123             | 172             | 135             |
| 1.5                 | 67                               | 42              | 67              | 42              | 67              | 42              | 79              | 54              | 91              | 66              | 103             | 78              | 115             | 90              | 127             | 102             | 139             | 114             |
| 1.0                 | 0                                | 0               | 0               | 0               | 0               | 0               | 12              | 12              | 24              | 24              | 36              | 36              | 48              | 48              | 60              | 60              | 72              | 72              |
| 0.9                 | -5                               | -14             | -5              | -14             | -5              | -14             | 7               | -2              | 19              | 10              | 31              | 22              | 43              | 34              | 55              | 46              | 67              | 58              |
| 0.8                 | -13                              | -31             | -13             | -31             | -13             | -31             | -1              | -19             | 11              | -7              | 23              | 5               | 35              | 17              | 47              | 29              | 59              | 41              |
| 0.7                 | -22                              | -54             | -22             | -54             | -22             | -54             | -10             | -42             | 2               | -30             | 14              | -18             | 26              | -6              | 38              | 6               | 50              | 18              |
| 0.6                 | -34                              | -83             | -34             | -83             | -34             | -83             | -22             | -71             | -10             | -59             | 2               | -47             | 14              | -35             | 26              | -23             | 38              | -11             |
| 0.5                 | -60                              | -125            | -60             | -125            | -60             | -125            | -48             | -113            | -36             | -101            | -24             | -89             | -12             | -77             | 0               | -65             | 12              | -53             |
| 0.4                 | -100                             | -188            | -100            | -188            | -100            | -188            | -88             | -176            | -76             | -164            | -64             | -152            | -52             | -140            | -40             | -128            | -28             | -116            |

- Notes:
- For all input signals the total  $t_{DS}$  and  $t_{DH}$  required is calculated by adding the data sheet value to the derating value listed in Table 31.
  - $t_{DS}$  nominal slew rate for a rising signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IH(AC)min}$ .  $t_{DS}$  nominal slew rate for a falling signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IL(AC)max}$ . If the actual signal is always earlier than the nominal slew rate line between the shaded " $V_{REF(DC)}$  to AC region," use the nominal slew rate for the derating value (see Figure 27 (page 62)). If the actual signal is later than the nominal slew rate line anywhere between shaded " $V_{REF(DC)}$  to AC region," the slew rate of a tangent line to the actual signal from the AC level to DC level is used for the derating value (see Figure 28 (page 62)).
  - $t_{DH}$  nominal slew rate for a rising signal is defined as the slew rate between the last crossing of  $V_{IL(DC)max}$  and the first crossing of  $V_{REF(DC)}$ .  $t_{DH}$  nominal slew rate for a falling signal is defined as the slew rate between the last crossing of  $V_{IH(DC)min}$  and the first crossing of  $V_{REF(DC)}$ . If the actual signal is always later than the nominal slew rate line between the shaded "DC level to  $V_{REF(DC)}$  region," use the nominal slew rate for the derating value (see Figure 29 (page 63)). If the actual signal is earlier than the nominal slew rate line anywhere between the shaded "DC to  $V_{REF(DC)}$  region," the slew rate of a tangent line to the actual signal from the DC level to  $V_{REF(DC)}$  level is used for the derating value (see Figure 30 (page 63)).
  - Although the total setup time might be negative for slow slew rates (a valid input signal will not have reached  $V_{IH(AC)}/V_{IL(AC)}$  at the time of the rising clock transition), a valid input signal is still required to complete the transition and reach  $V_{IH(AC)}/V_{IL(AC)}$ .
  - For slew rates between the values listed in this table, the derating values may be obtained by linear interpolation.
  - These values are typically not subject to production test. They are verified by design and characterization.
  - Single-ended DQS requires special derating. The values in Table 32 (page 60) are the DQS single-ended slew rate derating with DQS referenced at  $V_{REF}$  and DQ referenced at the logic levels  $t_{DSb}$  and  $t_{DHb}$ . Converting the derated base values from DQ referenced to the AC/DC trip points to DQ referenced to  $V_{REF}$  is listed in Table 33 (page 60). Table 33 provides the  $V_{REF}$ -based fully derated values for the DQ ( $t_{DSa}$  and  $t_{DHa}$ ) for

DDR2-667. It is not advised to operate DDR2-800 and DDR2-1066 devices with single-ended DQS; however, Table 32 would be used with the base values.

**Table 32: Single-Ended DQS Slew Rate Derating Values Using  $t_{DS_b}$  and  $t_{DH_b}$**

Reference points indicated in bold; Derating values are to be used with base  $t_{DS_b}$ - and  $t_{DH_b}$ -specified values

| DQ (V/ns) | DQS Single-Ended Slew Rate Derated (at $V_{REF}$ ) |          |          |          |          |          |          |          |          |          |           |            |          |          |          |          |          |          |
|-----------|----------------------------------------------------|----------|----------|----------|----------|----------|----------|----------|----------|----------|-----------|------------|----------|----------|----------|----------|----------|----------|
|           | 2.0 V/ns                                           |          | 1.8 V/ns |          | 1.6 V/ns |          | 1.4 V/ns |          | 1.2 V/ns |          | 1.0 V/ns  |            | 0.8 V/ns |          | 0.6 V/ns |          | 0.4 V/ns |          |
|           | $t_{DS}$                                           | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$  | $t_{DH}$   | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ |
| 2.0       | 130                                                | 53       | 130      | 53       | 130      | 53       | 130      | 53       | 130      | 53       | 145       | 48         | 155      | 45       | 165      | 41       | 175      | 38       |
| 1.5       | 97                                                 | 32       | 97       | 32       | 97       | 32       | 97       | 32       | 97       | 32       | 112       | 27         | 122      | 24       | 132      | 20       | 142      | 17       |
| 1.0       | 30                                                 | -10      | 30       | -10      | 30       | -10      | 30       | -10      | 30       | -10      | <b>45</b> | <b>-15</b> | 55       | -18      | 65       | -22      | 75       | -25      |
| 0.9       | 25                                                 | -24      | 25       | -24      | 25       | -24      | 25       | -24      | 25       | -24      | 40        | -29        | 50       | -32      | 60       | -36      | 70       | -39      |
| 0.8       | 17                                                 | -41      | 17       | -41      | 17       | -41      | 17       | -41      | 17       | -41      | 32        | -46        | 42       | -49      | 52       | -53      | 61       | -56      |
| 0.7       | 5                                                  | -64      | 5        | -64      | 5        | -64      | 5        | -64      | 5        | -64      | 20        | -69        | 30       | -72      | 40       | -75      | 50       | -79      |
| 0.6       | -7                                                 | -93      | -7       | -93      | -7       | -93      | -7       | -93      | -7       | -93      | 8         | -98        | 18       | -102     | 28       | -105     | 38       | -108     |
| 0.5       | -28                                                | -135     | -28      | -135     | -28      | -135     | -28      | -135     | -28      | -135     | -13       | -140       | -3       | -143     | 7        | -147     | 17       | -150     |
| 0.4       | -78                                                | -198     | -78      | -198     | -78      | -198     | -78      | -198     | -78      | -198     | -63       | -203       | -53      | -206     | -43      | -210     | -33      | -213     |

**Table 33: Single-Ended DQS Slew Rate Fully Derated (DQS, DQ at  $V_{REF}$ ) at DDR2-667**

Reference points indicated in bold

| DQ (V/ns) | DQS Single-Ended Slew Rate Derated (at $V_{REF}$ ) |          |          |          |          |          |          |          |          |          |            |            |          |          |          |          |          |          |
|-----------|----------------------------------------------------|----------|----------|----------|----------|----------|----------|----------|----------|----------|------------|------------|----------|----------|----------|----------|----------|----------|
|           | 2.0 V/ns                                           |          | 1.8 V/ns |          | 1.6 V/ns |          | 1.4 V/ns |          | 1.2 V/ns |          | 1.0 V/ns   |            | 0.8 V/ns |          | 0.6 V/ns |          | 0.4 V/ns |          |
|           | $t_{DS}$                                           | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$   | $t_{DH}$   | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ | $t_{DS}$ | $t_{DH}$ |
| 2.0       | 330                                                | 291      | 330      | 291      | 330      | 291      | 330      | 291      | 330      | 291      | 345        | 286        | 355      | 282      | 365      | 29       | 375      | 276      |
| 1.5       | 330                                                | 290      | 330      | 290      | 330      | 290      | 330      | 290      | 330      | 290      | 345        | 285        | 355      | 282      | 365      | 279      | 375      | 275      |
| 1.0       | 330                                                | 290      | 330      | 290      | 330      | 290      | 330      | 290      | 330      | 290      | <b>345</b> | <b>285</b> | 355      | 282      | 365      | 278      | 375      | 275      |
| 0.9       | 347                                                | 290      | 347      | 290      | 347      | 290      | 347      | 290      | 347      | 290      | 362        | 285        | 372      | 282      | 382      | 278      | 392      | 275      |
| 0.8       | 367                                                | 290      | 367      | 290      | 367      | 290      | 367      | 290      | 367      | 290      | 382        | 285        | 392      | 282      | 402      | 278      | 412      | 275      |
| 0.7       | 391                                                | 290      | 391      | 290      | 391      | 290      | 391      | 290      | 391      | 290      | 406        | 285        | 416      | 281      | 426      | 278      | 436      | 275      |
| 0.6       | 426                                                | 290      | 426      | 290      | 426      | 290      | 426      | 290      | 426      | 290      | 441        | 285        | 451      | 282      | 461      | 278      | 471      | 275      |
| 0.5       | 472                                                | 290      | 472      | 290      | 472      | 290      | 472      | 290      | 472      | 290      | 487        | 285        | 497      | 282      | 507      | 278      | 517      | 275      |
| 0.4       | 522                                                | 289      | 522      | 289      | 522      | 289      | 522      | 289      | 522      | 289      | 537        | 284        | 547      | 281      | 557      | 278      | 567      | 274      |

**Table 34: Single-Ended DQS Slew Rate Fully Derated (DQS, DQ at  $V_{REF}$ ) at DDR2-533**

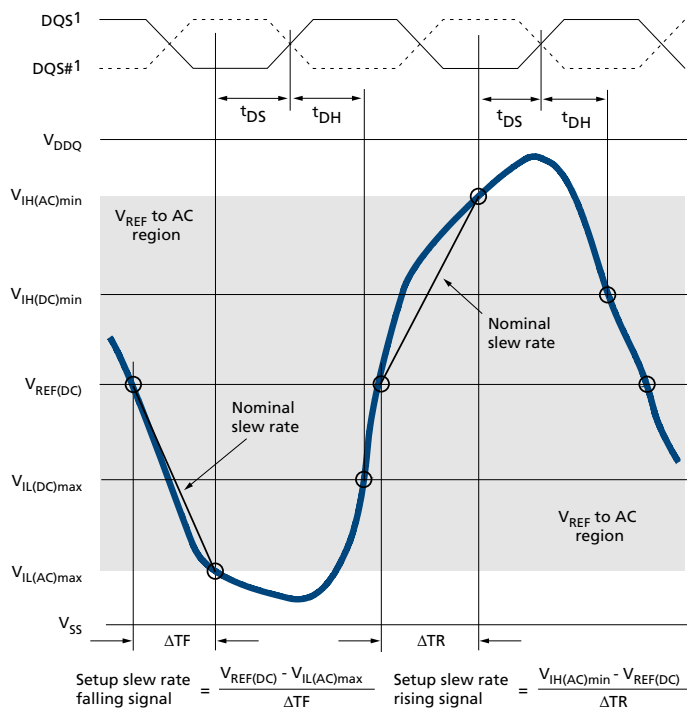
Reference points indicated in bold

| DQ (V/ns) | DQS Single-Ended Slew Rate Derated (at $V_{REF}$ ) |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |
|-----------|----------------------------------------------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|
|           | 2.0 V/ns                                           |                 | 1.8 V/ns        |                 | 1.6 V/ns        |                 | 1.4 V/ns        |                 | 1.2 V/ns        |                 | 1.0 V/ns        |                 | 0.8 V/ns        |                 | 0.6 V/ns        |                 | 0.4 V/ns        |                 |
|           | t <sub>DS</sub>                                    | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> |
| 2.0       | 355                                                | 341             | 355             | 341             | 355             | 341             | 355             | 341             | 355             | 341             | 370             | 336             | 380             | 332             | 390             | 329             | 400             | 326             |
| 1.5       | 364                                                | 340             | 364             | 340             | 364             | 340             | 364             | 340             | 364             | 340             | 379             | 335             | 389             | 332             | 399             | 329             | 409             | 325             |
| 1.0       | 380                                                | 340             | 380             | 340             | 380             | 340             | 380             | 340             | 380             | 340             | <b>395</b>      | <b>335</b>      | 405             | 332             | 415             | 328             | 425             | 325             |
| 0.9       | 402                                                | 340             | 402             | 340             | 402             | 340             | 402             | 340             | 402             | 340             | 417             | 335             | 427             | 332             | 437             | 328             | 447             | 325             |
| 0.8       | 429                                                | 340             | 429             | 340             | 429             | 340             | 429             | 340             | 429             | 340             | 444             | 335             | 454             | 332             | 464             | 328             | 474             | 325             |
| 0.7       | 463                                                | 340             | 463             | 340             | 463             | 340             | 463             | 340             | 463             | 340             | 478             | 335             | 488             | 331             | 498             | 328             | 508             | 325             |
| 0.6       | 510                                                | 340             | 510             | 340             | 510             | 340             | 510             | 340             | 510             | 340             | 525             | 335             | 535             | 332             | 545             | 328             | 555             | 325             |
| 0.5       | 572                                                | 340             | 572             | 340             | 572             | 340             | 572             | 340             | 572             | 340             | 587             | 335             | 597             | 332             | 607             | 328             | 617             | 325             |
| 0.4       | 647                                                | 339             | 647             | 339             | 647             | 339             | 647             | 339             | 647             | 339             | 662             | 334             | 672             | 331             | 682             | 328             | 692             | 324             |

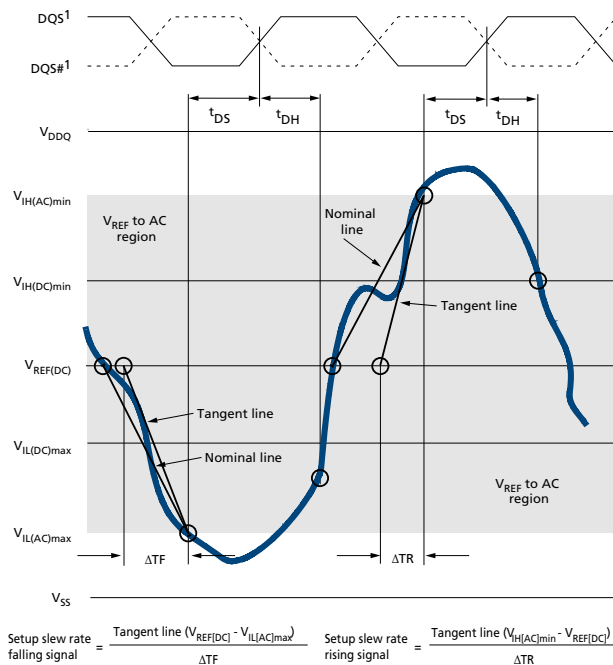
**Table 35: Single-Ended DQS Slew Rate Fully Derated (DQS, DQ at  $V_{REF}$ ) at DDR2-400**

Reference points indicated in bold

| DQ (V/ns) | DQS Single-Ended Slew Rate Derated (at $V_{REF}$ ) |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |                 |
|-----------|----------------------------------------------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|
|           | 2.0 V/ns                                           |                 | 1.8 V/ns        |                 | 1.6 V/ns        |                 | 1.4 V/ns        |                 | 1.2 V/ns        |                 | 1.0 V/ns        |                 | 0.8 V/ns        |                 | 0.6 V/ns        |                 | 0.4 V/ns        |                 |
|           | t <sub>DS</sub>                                    | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> | t <sub>DS</sub> | t <sub>DH</sub> |
| 2.0       | 405                                                | 391             | 405             | 391             | 405             | 391             | 405             | 391             | 405             | 391             | 420             | 386             | 430             | 382             | 440             | 379             | 450             | 376             |
| 1.5       | 414                                                | 390             | 414             | 390             | 414             | 390             | 414             | 390             | 414             | 390             | 429             | 385             | 439             | 382             | 449             | 379             | 459             | 375             |
| 1.0       | 430                                                | 390             | 430             | 390             | 430             | 390             | 430             | 390             | 430             | 390             | <b>445</b>      | <b>385</b>      | 455             | 382             | 465             | 378             | 475             | 375             |
| 0.9       | 452                                                | 390             | 452             | 390             | 452             | 390             | 452             | 390             | 452             | 390             | 467             | 385             | 477             | 382             | 487             | 378             | 497             | 375             |
| 0.8       | 479                                                | 390             | 479             | 390             | 479             | 390             | 479             | 390             | 479             | 390             | 494             | 385             | 504             | 382             | 514             | 378             | 524             | 375             |
| 0.7       | 513                                                | 390             | 513             | 390             | 513             | 390             | 513             | 390             | 513             | 390             | 528             | 385             | 538             | 381             | 548             | 378             | 558             | 375             |
| 0.6       | 560                                                | 390             | 560             | 390             | 560             | 390             | 560             | 390             | 560             | 390             | 575             | 385             | 585             | 382             | 595             | 378             | 605             | 375             |
| 0.5       | 622                                                | 390             | 622             | 390             | 622             | 390             | 622             | 390             | 622             | 390             | 637             | 385             | 647             | 382             | 657             | 378             | 667             | 375             |
| 0.4       | 697                                                | 389             | 697             | 389             | 697             | 389             | 697             | 389             | 697             | 389             | 712             | 384             | 722             | 381             | 732             | 378             | 742             | 374             |

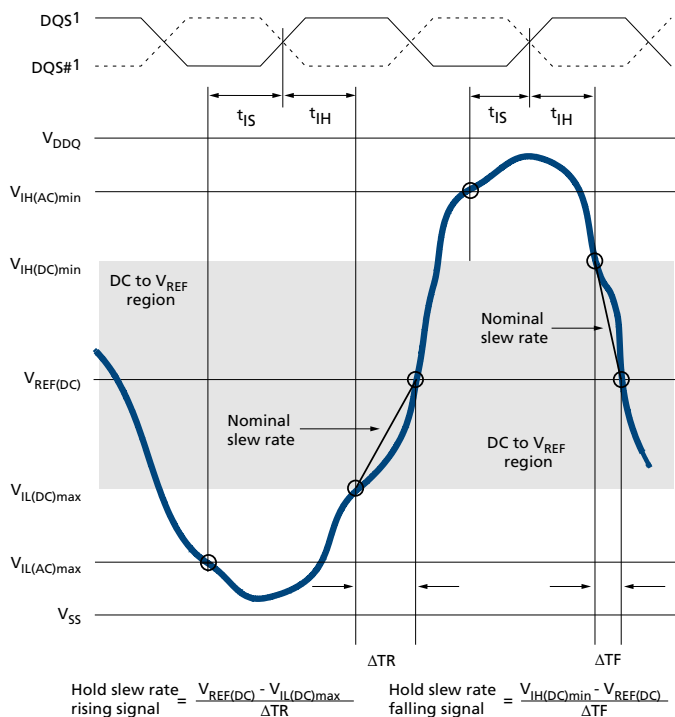
**Figure 27: Nominal Slew Rate for  $t_{DS}$** 


Note: 1. DQS, DQS# signals must be monotonic between  $V_{IL(DC)max}$  and  $V_{IH(DC)min}$ .

**Figure 28: Tangent Line for  $t_{DS}$** 


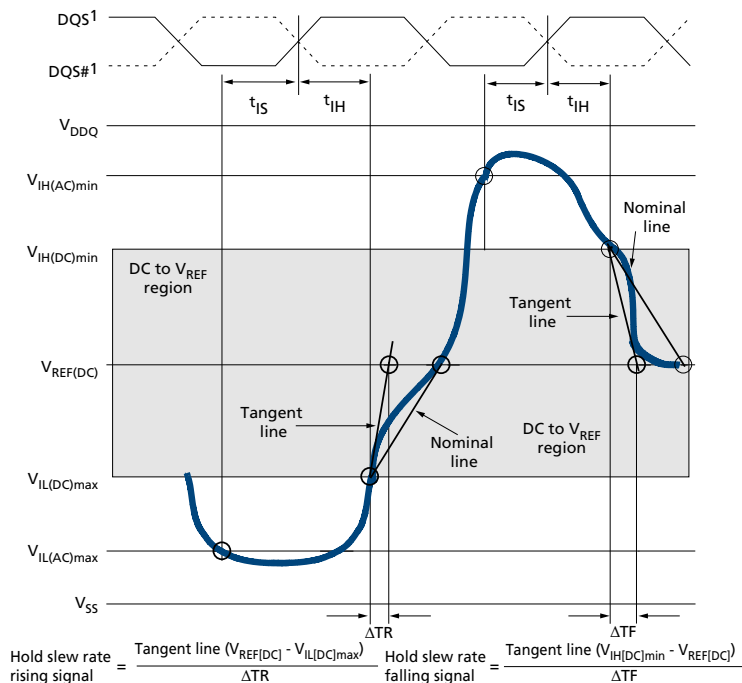
Note: 1. DQS, DQS# signals must be monotonic between  $V_{IL(DC)max}$  and  $V_{IH(DC)min}$ .

**Figure 29: Nominal Slew Rate for  $t_{DH}$**



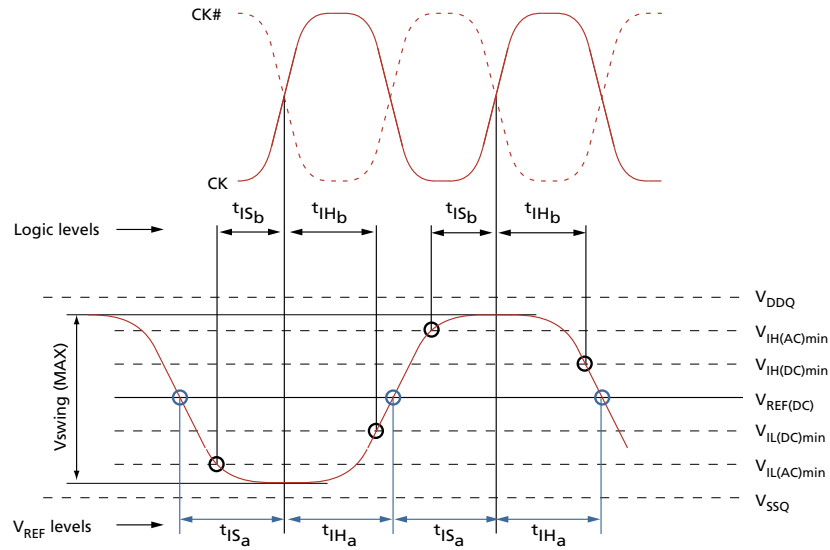
Note: 1. DQS, DQS# signals must be monotonic between  $V_{IL(DC)max}$  and  $V_{IH(DC)min}$ .

**Figure 30: Tangent Line for  $t_{DH}$**

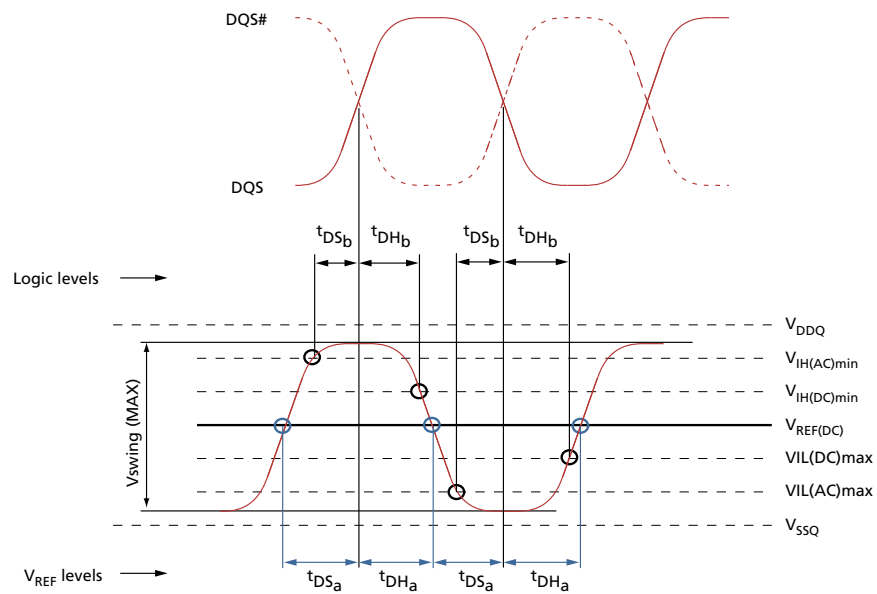


Note: 1. DQS, DQS# signals must be monotonic between  $V_{IL(DC)max}$  and  $V_{IH(DC)min}$ .

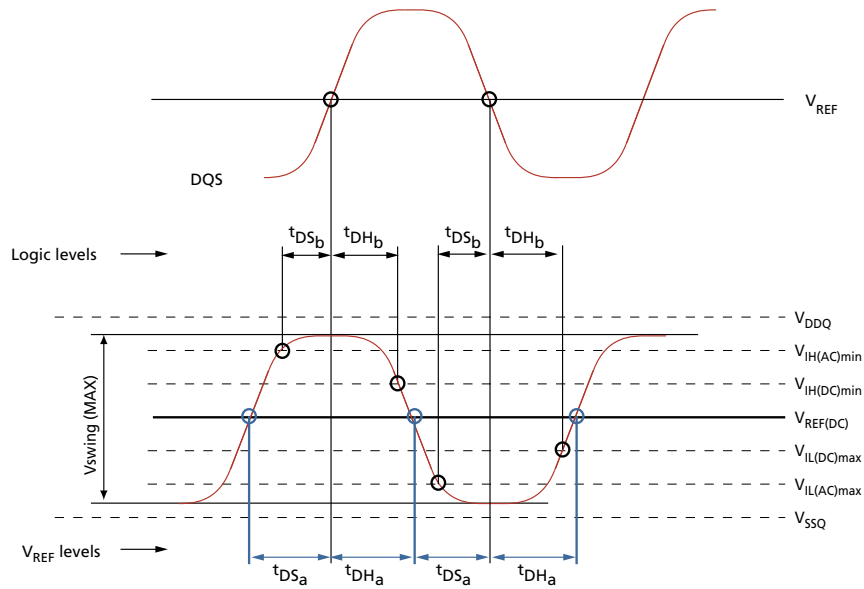
**Figure 31: AC Input Test Signal Waveform Command/Address Balls**



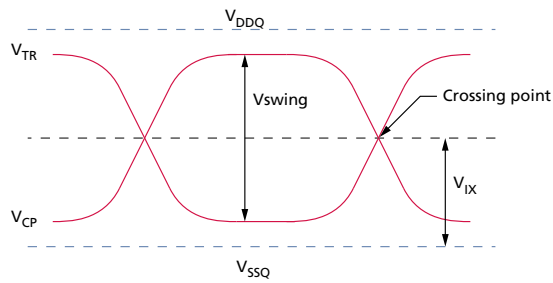
**Figure 32: AC Input Test Signal Waveform for Data with DQS, DQS# (Differential)**



**Figure 33: AC Input Test Signal Waveform for Data with DQS (Single-Ended)**



**Figure 34: AC Input Test Signal Waveform (Differential)**



## Commands

### Truth Tables

The following tables provide a quick reference of available DDR2 SDRAM commands, including CKE power-down modes and bank-to-bank commands.

**Table 36: Truth Table – DDR2 Commands**

Notes: 1–3 apply to the entire table

| Function                  | CKE            |               | CS# | RAS# | CAS# | WE# | BA2–BA0 | An–A11         | A10 | A9–A0          | Notes      |
|---------------------------|----------------|---------------|-----|------|------|-----|---------|----------------|-----|----------------|------------|
|                           | Previous Cycle | Current Cycle |     |      |      |     |         |                |     |                |            |
| LOAD MODE                 | H              | H             | L   | L    | L    | L   | BA      | OP code        |     |                | 4, 6       |
| REFRESH                   | H              | H             | L   | L    | L    | H   | X       | X              | X   | X              |            |
| SELF REFRESH entry        | H              | L             | L   | L    | L    | H   | X       | X              | X   | X              |            |
| SELF REFRESH exit         | L              | H             | H   | X    | X    | X   | X       | X              | X   | X              | 4, 7       |
|                           |                |               | L   | H    | H    | H   |         |                |     |                |            |
| Single bank PRECHARGE     | H              | H             | L   | L    | H    | L   | BA      | X              | L   | X              | 6          |
| All banks PRECHARGE       | H              | H             | L   | L    | H    | L   | X       | X              | H   | X              |            |
| Bank ACTIVATE             | H              | H             | L   | L    | H    | H   | BA      | Row address    |     |                | 4          |
| WRITE                     | H              | H             | L   | H    | L    | L   | BA      | Column address | L   | Column address | 4, 5, 6, 8 |
| WRITE with auto precharge | H              | H             | L   | H    | L    | L   | BA      | Column address | H   | Column address | 4, 5, 6, 8 |
| READ                      | H              | H             | L   | H    | L    | H   | BA      | Column address | L   | Column address | 4, 5, 6, 8 |
| READ with auto precharge  | H              | H             | L   | H    | L    | H   | BA      | Column address | H   | Column address | 4, 5, 6, 8 |
| NO OPERATION              | H              | X             | L   | H    | H    | H   | X       | X              | X   | X              |            |
| Device DESELECT           | H              | X             | H   | X    | X    | X   | X       | X              | X   | X              |            |
| Power-down entry          | H              | L             | H   | X    | X    | X   | X       | X              | X   | X              | 9          |
|                           |                |               | L   | H    | H    | H   |         |                |     |                |            |
| Power-down exit           | L              | H             | H   | X    | X    | X   | X       | X              | X   | X              | 9          |
|                           |                |               | L   | H    | H    | H   |         |                |     |                |            |

- Notes:
1. All DDR2 SDRAM commands are defined by states of CS#, RAS#, CAS#, WE#, and CKE at the rising edge of the clock.
  2. The state of ODT does not affect the states described in this table. The ODT function is not available during self refresh. See ODT Timing (page 123) for details.
  3. “X” means “H or L” (but a defined logic level) for valid  $I_{DD}$  measurements.
  4. BA2 is only applicable for densities  $\geq 1\text{Gb}$ .
  5. An  $n$  is the most significant address bit for a given density and configuration. Some larger address bits may be “Don’t Care” during column addressing, depending on density and configuration.

6. Bank addresses (BA) determine which bank is to be operated upon. BA during a LOAD MODE command selects which mode register is programmed.
7. SELF REFRESH exit is asynchronous.
8. Burst reads or writes at BL = 4 cannot be terminated or interrupted. See Figure 48 (page 92) and Figure 60 (page 103) for other restrictions and details.
9. The power-down mode does not perform any REFRESH operations. The duration of power-down is limited by the refresh requirements outlined in the AC parametric section.

**Table 37: Truth Table – Current State Bank *n* – Command to Bank *n***

Notes: 1–6 apply to the entire table

| Current State                    | CS# | RAS# | CAS# | WE# | Command/Action                                  | Notes |
|----------------------------------|-----|------|------|-----|-------------------------------------------------|-------|
| Any                              | H   | X    | X    | X   | DESELECT (NOP/continue previous operation)      |       |
|                                  | L   | H    | H    | H   | NO OPERATION (NOP/continue previous operation)  |       |
| Idle                             | L   | L    | H    | H   | ACTIVATE (select and activate row)              |       |
|                                  | L   | L    | L    | H   | REFRESH                                         | 7     |
|                                  | L   | L    | L    | L   | LOAD MODE                                       | 7     |
| Row active                       | L   | H    | L    | H   | READ (select column and start READ burst)       | 8     |
|                                  | L   | H    | L    | L   | WRITE (select column and start WRITE burst)     | 8     |
|                                  | L   | L    | H    | L   | PRECHARGE (deactivate row in bank or banks)     | 9     |
| Read (auto precharge disabled)   | L   | H    | L    | H   | READ (select column and start new READ burst)   | 8     |
|                                  | L   | H    | L    | L   | WRITE (select column and start WRITE burst)     | 8, 10 |
|                                  | L   | L    | H    | L   | PRECHARGE (start PRECHARGE)                     | 9     |
| Write (auto pre-charge disabled) | L   | H    | L    | H   | READ (select column and start READ burst)       | 8     |
|                                  | L   | H    | L    | L   | WRITE (select column and start new WRITE burst) | 8     |
|                                  | L   | L    | H    | L   | PRECHARGE (start PRECHARGE)                     | 9     |

- Notes:
1. This table applies when CKEn - 1 was HIGH and CKEn is HIGH and after t<sub>XSNR</sub> has been met (if the previous state was self refresh).
  2. This table is bank-specific, except where noted (the current state is for a specific bank and the commands shown are those allowed to be issued to that bank when in that state). Exceptions are covered in the notes below.
  3. Current state definitions:
    - Idle:** The bank has been precharged, t<sub>RP</sub> has been met, and any READ burst is complete.
    - Row active:** A row in the bank has been activated, and t<sub>RCD</sub> has been met. No data bursts/ accesses and no register accesses are in progress.
    - Read:** A READ burst has been initiated, with auto precharge disabled and has not yet terminated.
    - Write:** A WRITE burst has been initiated with auto precharge disabled and has not yet terminated.
  4. The following states must not be interrupted by a command issued to the same bank. Issue Deselect or NOP commands, or allowable commands to the other bank, on any clock edge occurring during these states. Allowable commands to the other bank are determined by its current state and this table, and according to Table 38 (page 69).

- Precharge:** Starts with registration of a PRECHARGE command and ends when  $t_{RP}$  is met. After  $t_{RP}$  is met, the bank will be in the idle state.
  - Read with auto precharge enabled:** Starts with registration of a READ command with auto precharge enabled and ends when  $t_{RP}$  has been met. After  $t_{RP}$  is met, the bank will be in the idle state.
  - Row activate:** Starts with registration of an ACTIVATE command and ends when  $t_{RCD}$  is met. After  $t_{RCD}$  is met, the bank will be in the row active state.
  - Write with auto precharge enabled:** Starts with registration of a WRITE command with auto precharge enabled and ends when  $t_{RP}$  has been met. After  $t_{RP}$  is met, the bank will be in the idle state.
5. The following states must not be interrupted by any executable command (DESELECT or NOP commands must be applied on each positive clock edge during these states):
- Refresh:** Starts with registration of a REFRESH command and ends when  $t_{RFC}$  is met. After  $t_{RFC}$  is met, the DDR2 SDRAM will be in the all banks idle state.
  - Accessing mode register:** Starts with registration of the LOAD MODE command and ends when  $t_{MRD}$  has been met. After  $t_{MRD}$  is met, the DDR2 SDRAM will be in the all banks idle state.
  - Precharge all:** Starts with registration of a PRECHARGE ALL command and ends when  $t_{RP}$  is met. After  $t_{RP}$  is met, all banks will be in the idle state.
6. All states and sequences not shown are illegal or reserved.
7. Not bank-specific; requires that all banks are idle and bursts are not in progress.
8. READs or WRITEs listed in the Command/Action column include READs or WRITEs with auto precharge enabled and READs or WRITEs with auto precharge disabled.
9. May or may not be bank-specific; if multiple banks are to be precharged, each must be in a valid state for precharging.
10. A WRITE command may be applied after the completion of the READ burst.

**Table 38: Truth Table – Current State Bank *n* – Command to Bank *m***

Notes: 1–6 apply to the entire table

| Current State                    | CS# | RAS# | CAS# | WE# | Command/Action                                  | Notes    |
|----------------------------------|-----|------|------|-----|-------------------------------------------------|----------|
| Any                              | H   | X    | X    | X   | DESELECT (NOP/continue previous operation)      |          |
|                                  | L   | H    | H    | H   | NO OPERATION (NOP/continue previous operation)  |          |
| Idle                             | X   | X    | X    | X   | Any command otherwise allowed to bank <i>m</i>  |          |
| Row active, active, or precharge | L   | L    | H    | H   | ACTIVATE (select and activate row)              |          |
|                                  | L   | H    | L    | H   | READ (select column and start READ burst)       | 7        |
|                                  | L   | H    | L    | L   | WRITE (select column and start WRITE burst)     | 7        |
|                                  | L   | L    | H    | L   | PRECHARGE                                       |          |
| Read (auto precharge disabled)   | L   | L    | H    | H   | ACTIVATE (select and activate row)              |          |
|                                  | L   | H    | L    | H   | READ (select column and start new READ burst)   | 7        |
|                                  | L   | H    | L    | L   | WRITE (select column and start WRITE burst)     | 7, 8     |
|                                  | L   | L    | H    | L   | PRECHARGE                                       |          |
| Write (auto precharge disabled)  | L   | L    | H    | H   | ACTIVATE (select and activate row)              |          |
|                                  | L   | H    | L    | H   | READ (select column and start READ burst)       | 7, 9, 10 |
|                                  | L   | H    | L    | L   | WRITE (select column and start new WRITE burst) | 7        |
|                                  | L   | L    | H    | L   | PRECHARGE                                       |          |
| Read (with auto precharge)       | L   | L    | H    | H   | ACTIVATE (select and activate row)              |          |
|                                  | L   | H    | L    | H   | READ (select column and start new READ burst)   | 7        |
|                                  | L   | H    | L    | L   | WRITE (select column and start WRITE burst)     | 7, 8     |
|                                  | L   | L    | H    | L   | PRECHARGE                                       |          |
| Write (with auto precharge)      | L   | L    | H    | H   | ACTIVATE (select and activate row)              |          |
|                                  | L   | H    | L    | H   | READ (select column and start READ burst)       | 7, 10    |
|                                  | L   | H    | L    | L   | WRITE (select column and start new WRITE burst) | 7        |
|                                  | L   | L    | H    | L   | PRECHARGE                                       |          |

- Notes:
1. This table applies when  $\text{CKEn} - 1$  was HIGH and  $\text{CKEn}$  is HIGH and after  $^t\text{XSNR}$  has been met (if the previous state was self refresh).
  2. This table describes an alternate bank operation, except where noted (the current state is for bank *n* and the commands shown are those allowed to be issued to bank *m*, assuming that bank *m* is in such a state that the given command is allowable). Exceptions are covered in the notes below.
  3. Current state definitions:

|                    |                                                                                                                                         |
|--------------------|-----------------------------------------------------------------------------------------------------------------------------------------|
| <b>Idle:</b>       | The bank has been precharged, $^t\text{RP}$ has been met, and any READ burst is complete.                                               |
| <b>Row active:</b> | A row in the bank has been activated and $^t\text{RCD}$ has been met. No data bursts/accesses and no register accesses are in progress. |
| <b>Read:</b>       | A READ burst has been initiated with auto precharge disabled and has not yet terminated.                                                |
| <b>Write:</b>      | A WRITE burst has been initiated with auto precharge disabled and has not yet terminated.                                               |

**READ with auto precharge enabled/  
WRITE with auto precharge enabled:**

The READ with auto precharge enabled or WRITE with auto precharge enabled states can each be broken into two parts: the access period and the precharge period. For READ with auto precharge, the precharge period is defined as if the same burst was executed with auto precharge disabled and then followed with the earliest possible PRECHARGE command that still accesses all of the data in the burst. For WRITE with auto precharge, the precharge period begins when  $t_{WR}$  ends, with  $t_{WR}$  measured as if auto precharge was disabled. The access period starts with registration of the command and ends where the precharge period (or  $t_{RP}$ ) begins. This device supports concurrent auto precharge such that when a READ with auto precharge is enabled or a WRITE with auto precharge is enabled, any command to other banks is allowed, as long as that command does not interrupt the read or write data transfer already in process. In either case, all other related limitations apply (contention between read data and write data must be avoided).

The minimum delay from a READ or WRITE command with auto precharge enabled to a command to a different bank is summarized in Table 39 (page 70).

4. REFRESH and LOAD MODE commands may only be issued when all banks are idle.
5. Not used.
6. All states and sequences not shown are illegal or reserved.
7. READs or WRITEs listed in the Command/Action column include READs or WRITEs with auto precharge enabled and READs or WRITEs with auto precharge disabled.
8. A WRITE command may be applied after the completion of the READ burst.
9. Requires appropriate DM.
10. The number of clock cycles required to meet  $t_{WTR}$  is either two or  $t_{WTR}/t_{CK}$ , whichever is greater.

**Table 39: Minimum Delay with Auto Precharge Enabled**

| From Command (Bank <i>n</i> ) | To Command (Bank <i>m</i> )        | Minimum Delay<br>(with Concurrent Auto Precharge) | Units    |
|-------------------------------|------------------------------------|---------------------------------------------------|----------|
| WRITE with auto precharge     | READ or READ with auto precharge   | $(CL - 1) + (BL/2) + t_{WTR}$                     | $t_{CK}$ |
|                               | WRITE or WRITE with auto precharge | $(BL/2)$                                          | $t_{CK}$ |
|                               | PRECHARGE or ACTIVATE              | 1                                                 | $t_{CK}$ |
| READ with auto precharge      | READ or READ with auto precharge   | $(BL/2)$                                          | $t_{CK}$ |
|                               | WRITE or WRITE with auto precharge | $(BL/2) + 2$                                      | $t_{CK}$ |
|                               | PRECHARGE or ACTIVATE              | 1                                                 | $t_{CK}$ |

**DESELECT**

The Deselect function (CS# HIGH) prevents new commands from being executed by the DDR2 SDRAM. The DDR2 SDRAM is effectively deselected. Operations already in progress are not affected. Deselect is also referred to as COMMAND INHIBIT.

## **NO OPERATION (NOP)**

The NO OPERATION (NOP) command is used to instruct the selected DDR2 SDRAM to perform a NOP (CS# is LOW; RAS#, CAS#, and WE are HIGH). This prevents unwanted commands from being registered during idle or wait states. Operations already in progress are not affected.

## **LOAD MODE (LM)**

The mode registers are loaded via bank address and address inputs. The bank address balls determine which mode register will be programmed. See Mode Register (MR) (page 72). The LM command can only be issued when all banks are idle, and a subsequent executable command cannot be issued until  $t_{MRD}$  is met.

## **ACTIVATE**

The ACTIVATE command is used to open (or activate) a row in a particular bank for a subsequent access. The value on the bank address inputs determines the bank, and the address inputs select the row. This row remains active (or open) for accesses until a precharge command is issued to that bank. A precharge command must be issued before opening a different row in the same bank.

## **READ**

The READ command is used to initiate a burst read access to an active row. The value on the bank address inputs determine the bank, and the address provided on address inputs A0–A<sub>i</sub> (where A<sub>i</sub> is the most significant column address bit for a given configuration) selects the starting column location. The value on input A10 determines whether or not auto precharge is used. If auto precharge is selected, the row being accessed will be precharged at the end of the read burst; if auto precharge is not selected, the row will remain open for subsequent accesses.

DDR2 SDRAM also supports the AL feature, which allows a READ or WRITE command to be issued prior to  $t_{RCD}$  (MIN) by delaying the actual registration of the READ/WRITE command to the internal device by AL clock cycles.

## **WRITE**

The WRITE command is used to initiate a burst write access to an active row. The value on the bank select inputs selects the bank, and the address provided on inputs A0–A<sub>i</sub> (where A<sub>i</sub> is the most significant column address bit for a given configuration) selects the starting column location. The value on input A10 determines whether or not auto precharge is used. If auto precharge is selected, the row being accessed will be precharged at the end of the WRITE burst; if auto precharge is not selected, the row will remain open for subsequent accesses.

DDR2 SDRAM also supports the AL feature, which allows a READ or WRITE command to be issued prior to  $t_{RCD}$  (MIN) by delaying the actual registration of the READ/WRITE command to the internal device by AL clock cycles.

Input data appearing on the DQ is written to the memory array subject to the DM input logic level appearing coincident with the data. If a given DM signal is registered LOW, the corresponding data will be written to memory; if the DM signal is registered HIGH, the corresponding data inputs will be ignored, and a WRITE will not be executed to that byte/column location (see Figure 65 (page 108)).

## **PRECHARGE**

The PRECHARGE command is used to deactivate the open row in a particular bank or the open row in all banks. The bank(s) will be available for a subsequent row activation a specified time ('RP) after the PRECHARGE command is issued, except in the case of concurrent auto precharge, where a READ or WRITE command to a different bank is allowed as long as it does not interrupt the data transfer in the current bank and does not violate any other timing parameters. After a bank has been precharged, it is in the idle state and must be activated prior to any READ or WRITE commands being issued to that bank. A PRECHARGE command is allowed if there is no open row in that bank (idle state) or if the previously open row is already in the process of precharging. However, the precharge period will be determined by the last PRECHARGE command issued to the bank.

## **REFRESH**

REFRESH is used during normal operation of the DDR2 SDRAM and is analogous to CAS#-before-RAS# (CBR) REFRESH. All banks must be in the idle mode prior to issuing a REFRESH command. This command is nonpersistent, so it must be issued each time a refresh is required. The addressing is generated by the internal refresh controller. This makes the address bits a "Don't Care" during a REFRESH command.

## **SELF REFRESH**

The SELF REFRESH command can be used to retain data in the DDR2 SDRAM, even if the rest of the system is powered down. When in the self refresh mode, the DDR2 SDRAM retains data without external clocking. All power supply inputs (including Vref) must be maintained at valid levels upon entry/exit *and* during SELF REFRESH operation.

The SELF REFRESH command is initiated like a REFRESH command except CKE is LOW. The DLL is automatically disabled upon entering self refresh and is automatically enabled upon exiting self refresh.

## **Mode Register (MR)**

The mode register is used to define the specific mode of operation of the DDR2 SDRAM. This definition includes the selection of a burst length, burst type, CAS latency, operating mode, DLL RESET, write recovery, and power-down mode, as shown in Figure 35 (page 73). Contents of the mode register can be altered by re-executing the LOAD MODE (LM) command. If the user chooses to modify only a subset of the MR variables, all variables must be programmed when the command is issued.

The MR is programmed via the LM command and will retain the stored information until it is programmed again or until the device loses power (except for bit M8, which is self-clearing). Reprogramming the mode register will not alter the contents of the memory array, provided it is performed correctly.

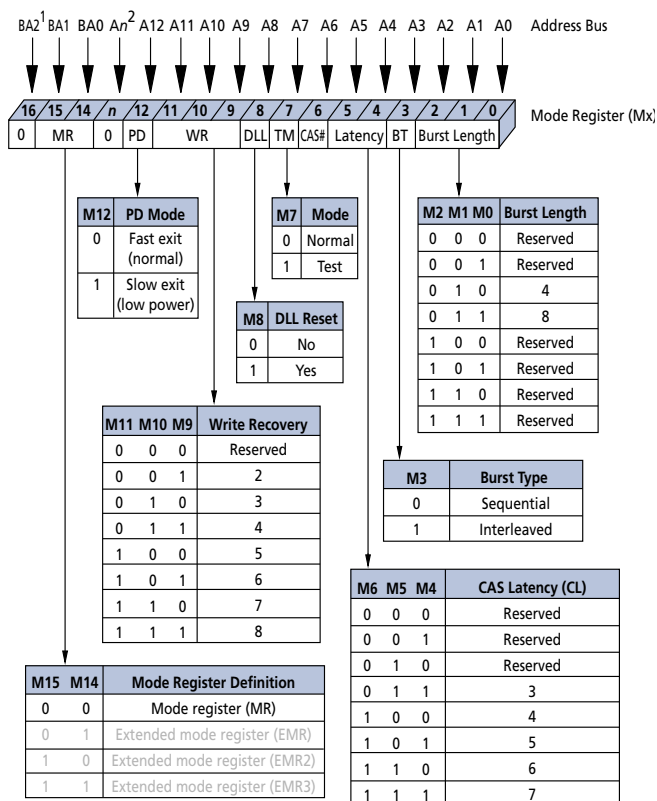
The LM command can only be issued (or reissued) when all banks are in the precharged state (idle state) and no bursts are in progress. The controller must wait the specified time 'MRD before initiating any subsequent operations such as an ACTIVATE command. Violating either of these requirements will result in an unspecified operation.

## Burst Length

Burst length is defined by bits M0–M2, as shown in Figure 35. Read and write accesses to the DDR2 SDRAM are burst-oriented, with the burst length being programmable to either four or eight. The burst length determines the maximum number of column locations that can be accessed for a given READ or WRITE command.

When a READ or WRITE command is issued, a block of columns equal to the burst length is effectively selected. All accesses for that burst take place within this block, meaning that the burst will wrap within the block if a boundary is reached. The block is uniquely selected by A2–A<sub>i</sub> when BL = 4 and by A3–A<sub>i</sub> when BL = 8 (where A<sub>i</sub> is the most significant column address bit for a given configuration). The remaining (least significant) address bit(s) is (are) used to select the starting location within the block. The programmed burst length applies to both read and write bursts.

**Figure 35: MR Definition**



- Notes:
1. M16 (BA2) is only applicable for densities  $\geq 1\text{Gb}$ , reserved for future use, and must be programmed to "0."
  2. Mode bits (M<sub>n</sub>) with corresponding address balls (A<sub>n</sub>) greater than M12 (A12) are reserved for future use and must be programmed to "0."
  3. Not all listed WR and CL options are supported in any individual speed grade.

## Burst Type

Accesses within a given burst may be programmed to be either sequential or interleaved. The burst type is selected via bit M3, as shown in Figure 35. The ordering of accesses within a burst is determined by the burst length, the burst type, and the starting column address, as shown in Table 40. DDR2 SDRAM supports 4-bit burst mode and 8-bit burst mode only. For 8-bit burst mode, full interleaved address ordering is supported; however, sequential address ordering is nibble-based.

**Table 40: Burst Definition**

| Burst Length | Starting Column Address<br>(A2, A1, A0) | Order of Accesses Within a Burst |                          |
|--------------|-----------------------------------------|----------------------------------|--------------------------|
|              |                                         | Burst Type = Sequential          | Burst Type = Interleaved |
| 4            | 0 0                                     | 0, 1, 2, 3                       | 0, 1, 2, 3               |
|              | 0 1                                     | 1, 2, 3, 0                       | 1, 0, 3, 2               |
|              | 1 0                                     | 2, 3, 0, 1                       | 2, 3, 0, 1               |
|              | 1 1                                     | 3, 0, 1, 2                       | 3, 2, 1, 0               |
| 8            | 0 0 0                                   | 0, 1, 2, 3, 4, 5, 6, 7           | 0, 1, 2, 3, 4, 5, 6, 7   |
|              | 0 0 1                                   | 1, 2, 3, 0, 5, 6, 7, 4           | 1, 0, 3, 2, 5, 4, 7, 6   |
|              | 0 1 0                                   | 2, 3, 0, 1, 6, 7, 4, 5           | 2, 3, 0, 1, 6, 7, 4, 5   |
|              | 0 1 1                                   | 3, 0, 1, 2, 7, 4, 5, 6           | 3, 2, 1, 0, 7, 6, 5, 4   |
|              | 1 0 0                                   | 4, 5, 6, 7, 0, 1, 2, 3           | 4, 5, 6, 7, 0, 1, 2, 3   |
|              | 1 0 1                                   | 5, 6, 7, 4, 1, 2, 3, 0           | 5, 4, 7, 6, 1, 0, 3, 2   |
|              | 1 1 0                                   | 6, 7, 4, 5, 2, 3, 0, 1           | 6, 7, 4, 5, 2, 3, 0, 1   |
|              | 1 1 1                                   | 7, 4, 5, 6, 3, 0, 1, 2           | 7, 6, 5, 4, 3, 2, 1, 0   |

## Operating Mode

The normal operating mode is selected by issuing a command with bit M7 set to “0,” and all other bits set to the desired values, as shown in Figure 35 (page 73). When bit M7 is “1,” no other bits of the mode register are programmed. Programming bit M7 to “1” places the DDR2 SDRAM into a test mode that is only used by the manufacturer and should *not* be used. No operation or functionality is guaranteed if M7 bit is “1.”

## DLL RESET

DLL RESET is defined by bit M8, as shown in Figure 35. Programming bit M8 to “1” will activate the DLL RESET function. Bit M8 is self-clearing, meaning it returns back to a value of “0” after the DLL RESET function has been issued.

Anytime the DLL RESET function is used, 200 clock cycles must occur before a READ command can be issued to allow time for the internal clock to be synchronized with the external clock. Failing to wait for synchronization to occur may result in a violation of the  $t_{AC}$  or  $t_{DQSCK}$  parameters.

## Write Recovery

Write recovery (WR) time is defined by bits M9–M11, as shown in Figure 35 (page 73). The WR register is used by the DDR2 SDRAM during WRITE with auto precharge operation. During WRITE with auto precharge operation, the DDR2 SDRAM delays the internal auto precharge operation by WR clocks (programmed in bits M9–M11) from the last data burst. An example of WRITE with auto precharge is shown in Figure 64 (page 107).

WR values of 2, 3, 4, 5, 6, 7, or 8 clocks may be used for programming bits M9–M11. The user is required to program the value of WR, which is calculated by dividing  $t_{WR}$  (in nanoseconds) by  $t_{CK}$  (in nanoseconds) and rounding up a noninteger value to the next integer;  $WR \text{ (cycles)} = t_{WR} \text{ (ns)} / t_{CK} \text{ (ns)}$ . Reserved states should not be used as an unknown operation or incompatibility with future versions may result.

## Power-Down Mode

Active power-down (PD) mode is defined by bit M12, as shown in Figure 35. PD mode enables the user to determine the active power-down mode, which determines performance versus power savings. PD mode bit M12 does not apply to precharge PD mode.

When bit M12 = 0, standard active PD mode, or “fast-exit” active PD mode, is enabled. The  $t_{XARD}$  parameter is used for fast-exit active PD exit timing. The DLL is expected to be enabled and running during this mode.

When bit M12 = 1, a lower-power active PD mode, or “slow-exit” active PD mode, is enabled. The  $t_{XARDS}$  parameter is used for slow-exit active PD exit timing. The DLL can be enabled but “frozen” during active PD mode because the exit-to-READ command timing is relaxed. The power difference expected between  $I_{DD3P}$  normal and  $I_{DD3P}$  low-power mode is defined in the DDR2  $I_{DD}$  Specifications and Conditions table.

## CAS Latency (CL)

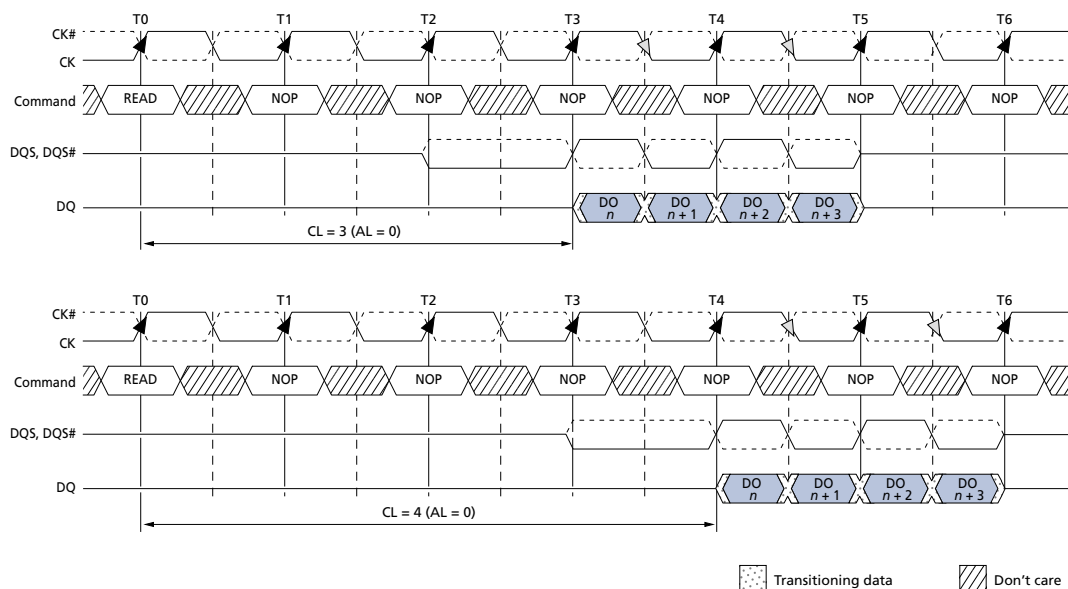
The CAS latency (CL) is defined by bits M4–M6, as shown in Figure 35 (page 73). CL is the delay, in clock cycles, between the registration of a READ command and the availability of the first bit of output data. The CL can be set to 3, 4, 5, 6, or 7 clocks, depending on the speed grade option being used.

DDR2 SDRAM does not support any half-clock latencies. Reserved states should not be used as an unknown operation otherwise incompatibility with future versions may result.

DDR2 SDRAM also supports a feature called posted CAS additive latency (AL). This feature allows the READ command to be issued prior to  $t_{RCD}(\text{MIN})$  by delaying the internal command to the DDR2 SDRAM by AL clocks. The AL feature is described in further detail in (page 0 ).

Examples of CL = 3 and CL = 4 are shown in Figure 36; both assume AL = 0. If a READ command is registered at clock edge  $n$ , and the CL is  $m$  clocks, the data will be available nominally coincident with clock edge  $n + m$  (this assumes AL = 0).

**Figure 36: CL**



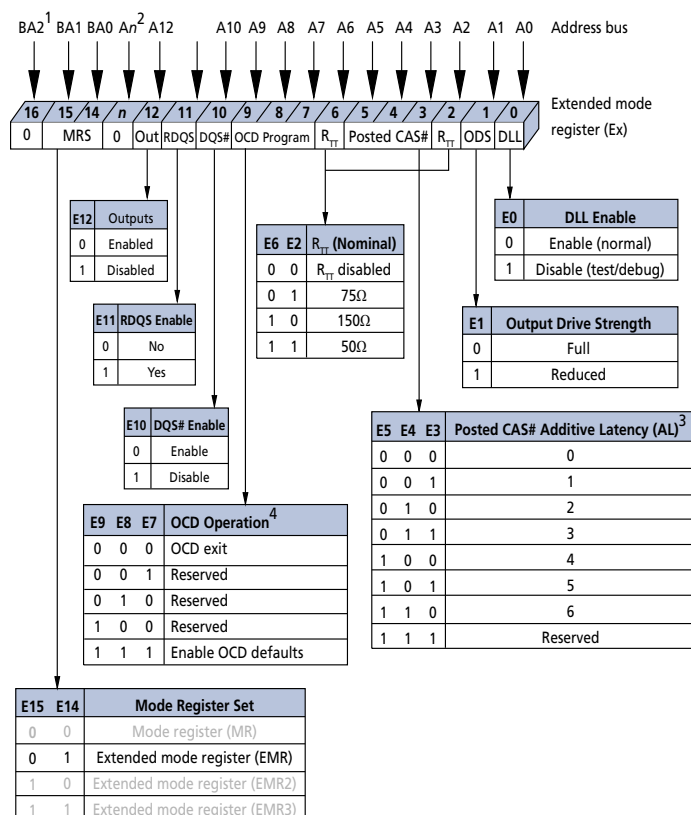
- Notes:
1. BL = 4.
  2. Posted CAS# additive latency (AL) = 0.
  3. Shown with nominal  $t_{AC}$ ,  $t_{DQSCK}$ , and  $t_{DQSQ}$ .

## Extended Mode Register (EMR)

The extended mode register controls functions beyond those controlled by the mode register; these additional functions are DLL enable/disable, output drive strength, on-die termination (ODT), posted AL, off-chip driver impedance calibration (OCD), DQS# enable/disable, RDQS/RDQS# enable/disable, and output disable/enable. These functions are controlled via the bits shown in Figure 37. The EMR is programmed via the LM command and will retain the stored information until it is programmed again or the device loses power. Reprogramming the EMR will not alter the contents of the memory array, provided it is performed correctly.

The EMR must be loaded when all banks are idle and no bursts are in progress, and the controller must wait the specified time <sup>1</sup>MRD before initiating any subsequent operation. Violating either of these requirements could result in an unspecified operation.

**Figure 37: EMR Definition**



- Notes:
1. E16 (BA2) is only applicable for densities  $\geq 1\text{Gb}$ , reserved for future use, and must be programmed to "0."
  2. Mode bits (E<sub>n</sub>) with corresponding address balls (A<sub>n</sub>) greater than E12 (A12) are reserved for future use and must be programmed to "0."
  3. Not all listed AL options are supported in any individual speed grade.
  4. As detailed in the Initialization (page 83) section notes, during initialization of the OCD operation, all three bits must be set to "1" for the OCD default state, then set to "0" before initialization is finished.

## **DLL Enable/Disable**

The DLL may be enabled or disabled by programming bit E0 during the LM command, as shown in Figure 37 (page 77). These specifications are applicable when the DLL is enabled for normal operation. DLL enable is required during power-up initialization and upon returning to normal operation after having disabled the DLL for the purpose of debugging or evaluation. Enabling the DLL should always be followed by resetting the DLL using the LM command.

The DLL is automatically disabled when entering SELF REFRESH operation and is automatically re-enabled and reset upon exit of SELF REFRESH operation.

Anytime the DLL is enabled (and subsequently reset), 200 clock cycles must occur before a READ command can be issued to allow time for the internal clock to synchronize with the external clock. Failing to wait for synchronization to occur may result in a violation of the  $t_{AC}$  or  $t_{DQSCK}$  parameters.

Anytime the DLL is disabled and the device is operated below 25 MHz, any AUTO REFRESH command should be followed by a PRECHARGE ALL command.

## **Output Drive Strength**

The output drive strength is defined by bit E1, as shown in Figure 37. The normal drive strength for all outputs is specified to be SSTL\_18. Programming bit E1 = 0 selects normal (full strength) drive strength for all outputs. Selecting a reduced drive strength option (E1 = 1) will reduce all outputs to approximately 45 to 60 percent of the SSTL\_18 drive strength. This option is intended for the support of lighter load and/or point-to-point environments.

## **DQS# Enable/Disable**

The DQS# ball is enabled by bit E10. When E10 = 0, DQS# is the complement of the differential data strobe pair DQS/DQS#. When disabled (E10 = 1), DQS is used in a single-ended mode and the DQS# ball is disabled. When disabled, DQS# should be left floating; however, it may be tied to ground via a 20 $\Omega$  to 10k $\Omega$  resistor. This function is also used to enable/disable RDQS#. If RDQS is enabled (E11 = 1) and DQS# is enabled (E10 = 0), then both DQS# and RDQS# will be enabled.

## **RDQS Enable/Disable**

The RDQS ball is enabled by bit E11, as shown in Figure 37. This feature is only applicable to the x8 configuration. When enabled (E11 = 1), RDQS is identical in function and timing to data strobe DQS during a READ. During a WRITE operation, RDQS is ignored by the DDR2 SDRAM.

## **Output Enable/Disable**

The OUTPUT ENABLE function is defined by bit E12, as shown in Figure 37. When enabled (E12 = 0), all outputs (DQ, DQS, DQS#, RDQS, RDQS#) function normally. When disabled (E12 = 1), all outputs (DQ, DQS, DQS#, RDQS, RDQS#) are disabled, thus removing output buffer current. The output disable feature is intended to be used during  $I_{DD}$  characterization of read current.

## On-Die Termination (ODT)

ODT effective resistance,  $R_{TT(EFF)}$ , is defined by bits E2 and E6 of the EMR, as shown in Figure 37 (page 77). The ODT feature is designed to improve signal integrity of the memory channel by allowing the DDR2 SDRAM controller to independently turn on/off ODT for any or all devices.  $R_{TT}$  effective resistance values of 50Ω, 75Ω, and 150Ω are selectable and apply to each DQ, DQS/DQS#, RDQS/RDQS#, UDQS/UDQS#, LDQS/LDQS#, DM, and UDM/LDM signals. Bits (E6, E2) determine what ODT resistance is enabled by turning on/off “sw1,” “sw2,” or “sw3.” The ODT effective resistance value is selected by enabling switch “sw1,” which enables all R1 values that are 150Ω each, enabling an effective resistance of 75Ω ( $R_{TT2[EFF]} = R2/2$ ). Similarly, if “sw2” is enabled, all R2 values that are 300Ω each, enable an effective ODT resistance of 150Ω ( $R_{TT2[EFF]} = R2/2$ ). Switch “sw3” enables R1 values of 100Ω, enabling effective resistance of 50Ω. Reserved states should not be used, as an unknown operation or incompatibility with future versions may result.

The ODT control ball is used to determine when  $R_{TT(EFF)}$  is turned on and off, assuming ODT has been enabled via bits E2 and E6 of the EMR. The ODT feature and ODT input ball are only used during active, active power-down (both fast-exit and slow-exit modes), and precharge power-down modes of operation.

ODT must be turned off prior to entering self refresh mode. During power-up and initialization of the DDR2 SDRAM, ODT should be disabled until the EMR command is issued. This will enable the ODT feature, at which point the ODT ball will determine the  $R_{TT(EFF)}$  value. Anytime the EMR enables the ODT function, ODT may not be driven HIGH until eight clocks after the EMR has been enabled (see Figure 80 (page 124) for ODT timing diagrams).

## Off-Chip Driver (OCD) Impedance Calibration

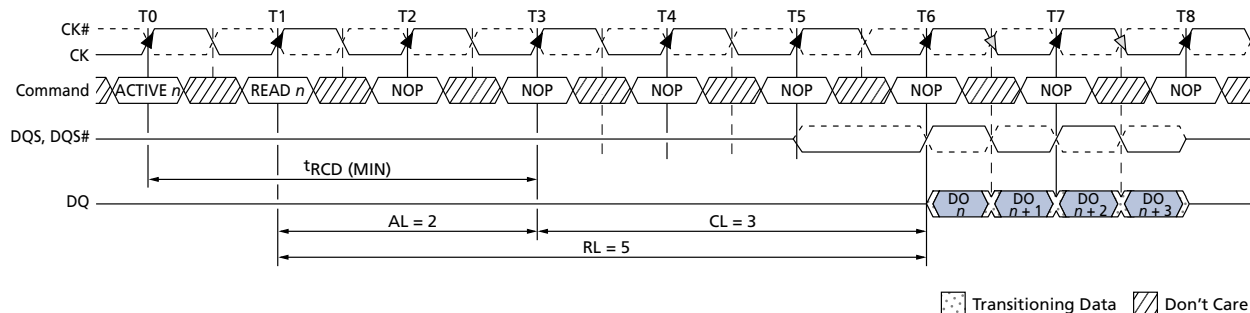
The OFF-CHIP DRIVER function is an optional DDR2 JEDEC feature not supported by Micron and thereby must be set to the default state. Enabling OCD beyond the default settings will alter the I/O drive characteristics and the timing and output I/O specifications will no longer be valid (see Initialization (page 83) for proper setting of OCD defaults).

## Posted CAS Additive Latency (AL)

Posted CAS additive latency (AL) is supported to make the command and data bus efficient for sustainable bandwidths in DDR2 SDRAM. Bits E3–E5 define the value of AL, as shown in Figure 37. Bits E3–E5 allow the user to program the DDR2 SDRAM with an AL of 0, 1, 2, 3, 4, 5, or 6 clocks. Reserved states should not be used as an unknown operation or incompatibility with future versions may result.

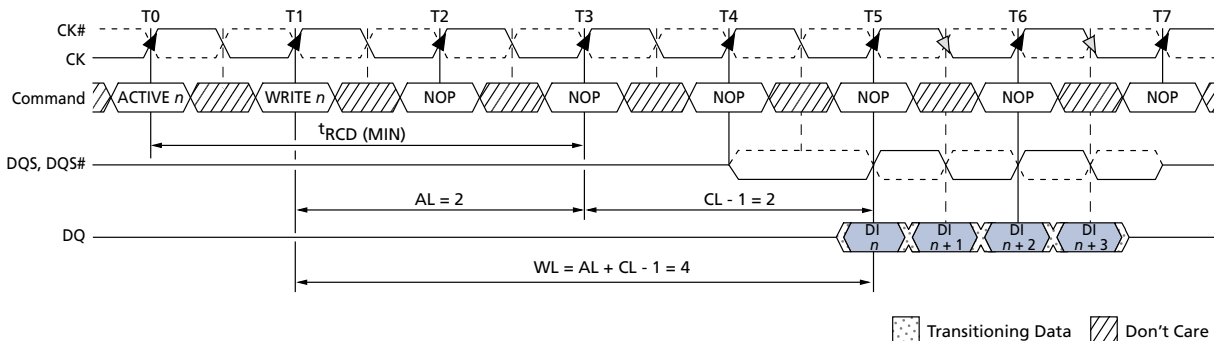
In this operation, the DDR2 SDRAM allows a READ or WRITE command to be issued prior to  $t_{RCD}$  (MIN) with the requirement that  $AL \leq t_{RCD}$  (MIN). A typical application using this feature would set  $AL = t_{RCD}$  (MIN) -  $1 \times t_{CK}$ . The READ or WRITE command is held for the time of the AL before it is issued internally to the DDR2 SDRAM device. RL is controlled by the sum of AL and CL;  $RL = AL + CL$ . WRITE latency (WL) is equal to RL minus one clock;  $WL = AL + CL - 1 \times t_{CK}$ . An example of RL is shown in Figure 38 (page 80). An example of a WL is shown in Figure 39 (page 80).

**Figure 38: READ Latency**



- Notes:
1.  $BL = 4$ .
  2. Shown with nominal  $t_{AC}$ ,  $t_{DQSCk}$ , and  $t_{DQSQ}$ .
  3.  $RL = AL + CL = 5$ .

**Figure 39: WRITE Latency**



- Notes:
1.  $BL = 4$ .
  2.  $CL = 3$ .
  3.  $WL = AL + CL - 1 = 4$ .

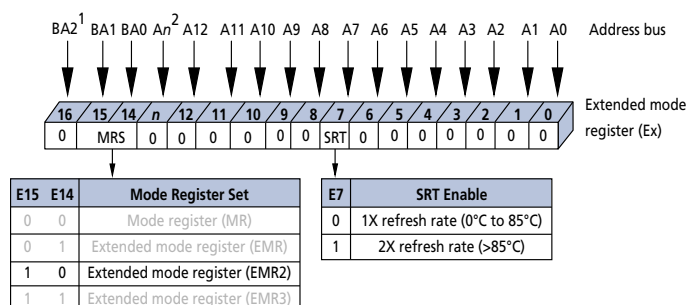
## Extended Mode Register 2 (EMR2)

The extended mode register 2 (EMR2) controls functions beyond those controlled by the mode register. Currently all bits in EMR2 are reserved, except for E7, which is used in commercial or high-temperature operations, as shown in Figure 40. The EMR2 is programmed via the LM command and will retain the stored information until it is programmed again or until the device loses power. Reprogramming the EMR will not alter the contents of the memory array, provided it is performed correctly.

Bit E7 (A7) must be programmed as “1” to provide a faster refresh rate on IT and AT devices if  $T_C$  exceeds 85°C.

EMR2 must be loaded when all banks are idle and no bursts are in progress, and the controller must wait the specified time  $t_{MRD}$  before initiating any subsequent operation. Violating either of these requirements could result in an unspecified operation.

**Figure 40: EMR2 Definition**



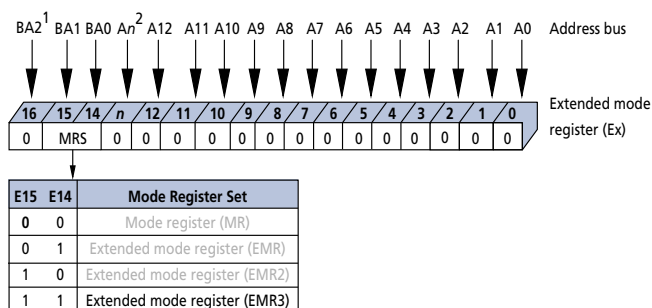
- Notes:
1. E16 (BA2) is only applicable for densities  $\geq 1\text{Gb}$ , reserved for future use, and must be programmed to “0.”
  2. Mode bits (E<sub>n</sub>) with corresponding address balls (A<sub>n</sub>) greater than E12 (A12) are reserved for future use and must be programmed to “0.”

## Extended Mode Register 3 (EMR3)

The extended mode register 3 (EMR3) controls functions beyond those controlled by the mode register. Currently all bits in EMR3 are reserved, as shown in Figure 41. The EMR3 is programmed via the LM command and will retain the stored information until it is programmed again or until the device loses power. Reprogramming the EMR will not alter the contents of the memory array, provided it is performed correctly.

EMR3 must be loaded when all banks are idle and no bursts are in progress, and the controller must wait the specified time  $t_{MRD}$  before initiating any subsequent operation. Violating either of these requirements could result in an unspecified operation.

**Figure 41: EMR3 Definition**

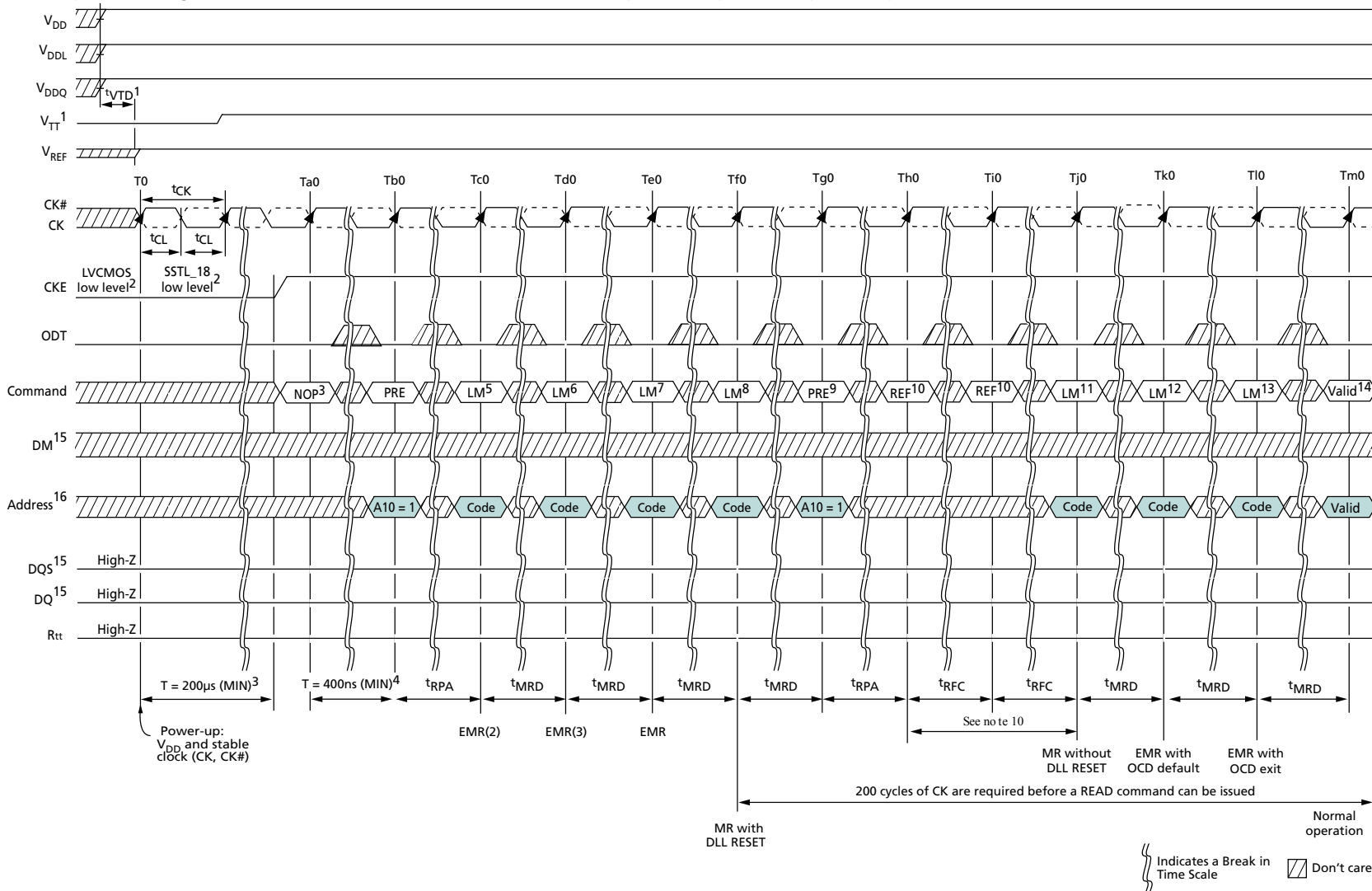


- Notes:
1. E16 (BA2) is only applicable for densities  $\geq 1\text{Gb}$ , is reserved for future use, and must be programmed to "0."
  2. Mode bits ( $E_n$ ) with corresponding address balls ( $A_n$ ) greater than E12 (A12) are reserved for future use and must be programmed to "0."

# Initialization

**Figure 42: DDR2 Power-Up and Initialization**

DDR2 SDRAM must be powered up and initialized in a predefined manner. Operational procedures other than those specified may result in undefined operation. Figure 42 illustrates, and the notes outline, the sequence required for power-up and initialization.



- Notes: 1. Applying power; if CKE is maintained below  $0.2 \times V_{DDQ}$ , outputs remain disabled. To guarantee  $R_{TT}$  (ODT resistance) is off,  $V_{REF}$  must be valid and a low level must be applied to the ODT ball (all other inputs may be undefined; I/Os and outputs must be less than  $V_{DDQ}$  during voltage ramp time to avoid DDR2 SDRAM device latch-up).  $V_{TT}$  is not applied directly to the device; however,  $t_{VTD}$  should be  $\geq 0$  to avoid device latch-up. At least one of the following two sets of conditions (A or B) must be met to obtain a stable supply state (stable supply defined as  $V_{DD}$ ,  $V_{DDL}$ ,  $V_{DDQ}$ ,  $V_{REF}$ , and  $V_{TT}$  are between their minimum and maximum values as stated in Table 12 (page 39)):

A. Single power source: The  $V_{DD}$  voltage ramp from 300mV to  $V_{DDmin}$  must take no longer than 200ms; during the  $V_{DD}$  voltage ramp,  $|V_{DD} - V_{DDQ}| \leq 0.3V$ . Once supply voltage ramping is complete (when  $V_{DDQ}$  crosses  $V_{DD[MIN]}$ ), Table 12 (page 39) specifications apply.

- $V_{DD}$ ,  $V_{DDL}$ , and  $V_{DDQ}$  are driven from a single power converter output
- $V_{TT}$  is limited to 0.95V MAX
- $V_{REF}$  tracks  $V_{DDQ}/2$ ;  $V_{REF}$  must be within  $\pm 0.3V$  with respect to  $V_{DDQ}/2$  during supply ramp time; does not need to be satisfied when ramping power down
- $V_{DDQ} \geq V_{REF}$  at all times

B. Multiple power sources:  $V_{DD} \geq V_{DDL} \geq V_{DDQ}$  must be maintained during supply voltage ramping, for both AC and DC levels, until supply voltage ramping completes ( $V_{DDQ}$  crosses  $V_{DD[MIN]}$ ). Once supply voltage ramping is complete, Table 12 (page 39) specifications apply.

- Apply  $V_{DD}$  and  $V_{DDL}$  before or at the same time as  $V_{DDQ}$ ;  $V_{DD}/V_{DDL}$  voltage ramp time must be  $\leq 200ms$  from when  $V_{DD}$  ramps from 300mV to  $V_{DDmin}$
  - Apply  $V_{DDQ}$  before or at the same time as  $V_{TT}$ ; the  $V_{DDQ}$  voltage ramp time from when  $V_{DDmin}$  is achieved to when  $V_{DDQmin}$  is achieved must be  $\leq 500ms$ ; while  $V_{DD}$  is ramping, current can be supplied from  $V_{DD}$  through the device to  $V_{DDQ}$
  - $V_{REF}$  must track  $V_{DDQ}/2$ ;  $V_{REF}$  must be within  $\pm 0.3V$  with respect to  $V_{DDQ}/2$  during supply ramp time;  $V_{DDQ} \geq V_{REF}$  must be met at all times; does not need to be satisfied when ramping power down
  - Apply  $V_{TT}$ ; the  $V_{TT}$  voltage ramp time from when  $V_{DDQmin}$  is achieved to when  $V_{TTmin}$  is achieved must be no greater than 500ms
2. CKE requires LVCMOS input levels prior to state T0 to ensure DQs are High-Z during device power-up prior to  $V_{REF}$  being stable. After state T0, CKE is required to have SSTL\_18 input levels. Once CKE transitions to a high level, it must stay HIGH for the duration of the initialization sequence.
  3. For a minimum of 200 $\mu s$  after stable power and clock (CK, CK#), apply NOP or DESELECT commands, then take CKE HIGH.
  4. Wait a minimum of 400ns then issue a PRECHARGE ALL command.
  5. Issue a LOAD MODE command to the EMR(2). To issue an EMR(2) command, provide LOW to BA0, and provide HIGH to BA1; set register E7 to "0" or "1" to select appropriate self refresh rate; remaining EMR(2) bits must be "0" (see Extended Mode Register 2 (EMR2) (page 81) for all EMR(2) requirements).
  6. Issue a LOAD MODE command to the EMR(3). To issue an EMR(3) command, provide HIGH to BA0 and BA1; remaining EMR(3) bits must be "0." Extended Mode Register 3 (EMR3) (page 82) for all EMR(3) requirements.
  7. Issue a LOAD MODE command to the EMR to enable DLL. To issue a DLL ENABLE command, provide LOW to BA1 and A0; provide HIGH to BA0; bits E7, E8, and E9 can be set to "0" or "1;" Micron recommends setting them to "0;" remaining EMR bits must be "0." (page 0 ) for all EMR requirements.
  8. Issue a LOAD MODE command to the MR for DLL RESET. 200 cycles of clock input is required to lock the DLL. To issue a DLL RESET, provide HIGH to A8 and provide LOW to BA1 and BA0; CKE must be HIGH the entire time the DLL is resetting; remaining MR bits must be "0." Mode Register (MR) (page 72) for all MR requirements.

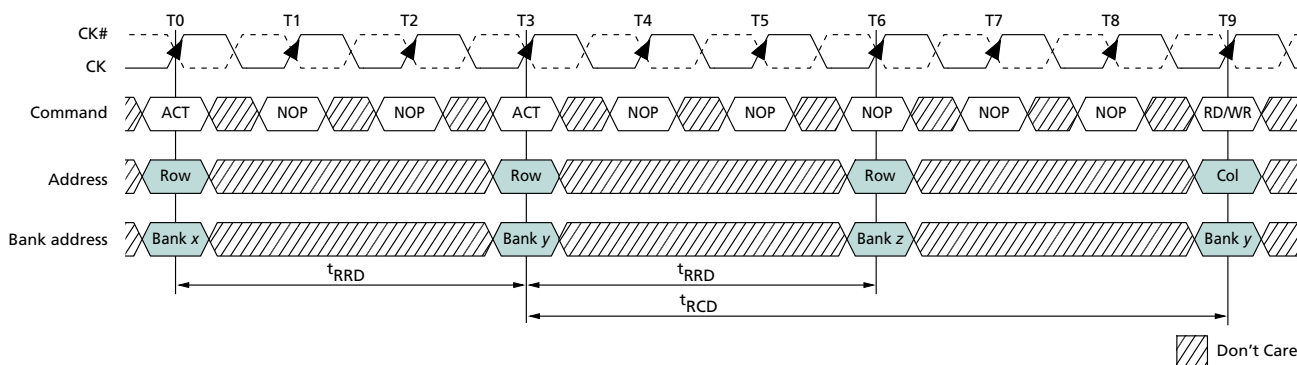
9. Issue PRECHARGE ALL command.
10. Issue two or more REFRESH commands.
11. Issue a LOAD MODE command to the MR with LOW to A8 to initialize device operation (that is, to program operating parameters without resetting the DLL). To access the MR, set BA0 and BA1 LOW; remaining MR bits must be set to desired settings. Mode Register (MR) (page 72) for all MR requirements.
12. Issue a LOAD MODE command to the EMR to enable OCD default by setting bits E7, E8, and E9 to "1," and then setting all other desired parameters. To access the EMR, set BA0 LOW and BA1 HIGH (see (page 0 ) for all EMR requirements.
13. Issue a LOAD MODE command to the EMR to enable OCD exit by setting bits E7, E8, and E9 to "0," and then setting all other desired parameters. To access the extended mode registers, EMR, set BA0 LOW and BA1 HIGH for all EMR requirements.
14. The DDR2 SDRAM is now initialized and ready for normal operation 200 clock cycles after the DLL RESET at Tf0.
15. DM represents DM for the x4, x8 configurations and UDM, LDM for the x16 configuration; DQS represents DQS, DQS#, UDQS, UDQS#, LDQS, LDQS#, RDQS, RDQS# for the appropriate configuration (x4, x8, x16); DQ represents DQ0–DQ3 for x4, DQ–DQ7 for x8 and DQ0–DQ15 for x16.
16. A10 = PRECHARGE ALL, CODE = desired values for mode registers (bank addresses are required to be decoded).

## ACTIVATE

Before any READ or WRITE commands can be issued to a bank within the DDR2 SDRAM, a row in that bank must be opened (activated), even when additive latency is used. This is accomplished via the ACTIVATE command, which selects both the bank and the row to be activated.

After a row is opened with an ACTIVATE command, a READ or WRITE command may be issued to that row subject to the  $t_{RCD}$  specification.  $t_{RCD}(\text{MIN})$  should be divided by the clock period and rounded up to the next whole number to determine the earliest clock edge after the ACTIVATE command on which a READ or WRITE command can be entered. The same procedure is used to convert other specification limits from time units to clock cycles. For example, a  $t_{RCD}(\text{MIN})$  specification of 20ns with a 266 MHz clock ( $t_{CK} = 3.75\text{ns}$ ) results in 5.3 clocks, rounded up to 6. This is shown in Figure 43, which covers any case where  $5 < t_{RCD}(\text{MIN})/t_{CK} \leq 6$ . Figure 43 also shows the case for  $t_{RRD}$  where  $2 < t_{RRD}(\text{MIN})/t_{CK} \leq 3$ .

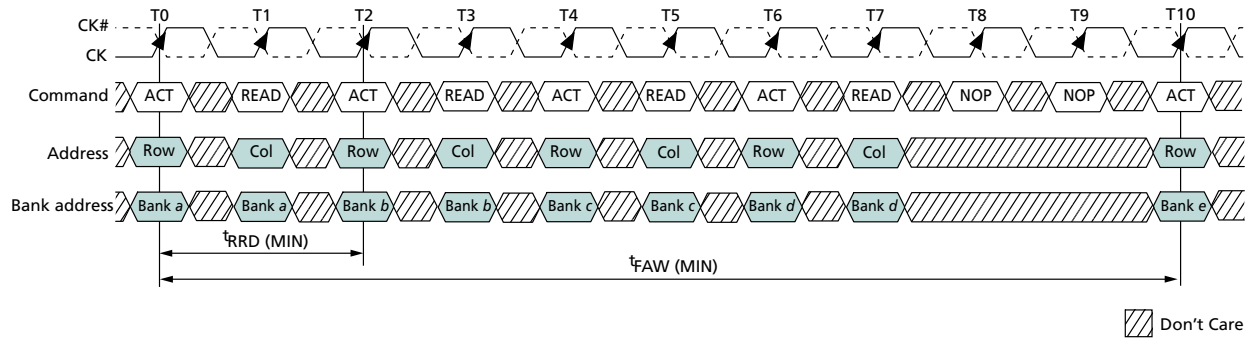
**Figure 43: Example: Meeting  $t_{RRD}(\text{MIN})$  and  $t_{RCD}(\text{MIN})$**



A subsequent ACTIVATE command to a different row in the same bank can only be issued after the previous active row has been closed (precharged). The minimum time interval between successive ACTIVATE commands to the same bank is defined by  $t_{RC}$ .

A subsequent ACTIVATE command to another bank can be issued while the first bank is being accessed, which results in a reduction of total row-access overhead. The minimum time interval between successive ACTIVATE commands to different banks is defined by  $t_{RRD}$ .

DDR2 devices with 8 banks (1Gb or larger) have an additional requirement:  $t_{FAW}$ . This requires no more than four ACTIVATE commands may be issued in any given  $t_{FAW}(\text{MIN})$  period, as shown in Figure 44 (page 87).

**Figure 44: Multibank Activate Restriction**


Note: 1. DDR2-533 (-37E, x4 or x8),  $t_{CK} = 3.75ns$ , BL = 4, AL = 3, CL = 4,  $t_{RRD} (MIN) = 7.5ns$ ,  $t_{FAW} (MIN) = 37.5ns$ .

## READ

READ bursts are initiated with a READ command. The starting column and bank addresses are provided with the READ command, and auto precharge is either enabled or disabled for that burst access. If auto precharge is enabled, the row being accessed is automatically precharged at the completion of the burst. If auto precharge is disabled, the row will be left open after the completion of the burst.

During READ bursts, the valid data-out element from the starting column address will be available READ latency (RL) clocks later. RL is defined as the sum of AL and CL:  $RL = AL + CL$ . The value for AL and CL are programmable via the MR and EMR commands, respectively. Each subsequent data-out element will be valid nominally at the next positive or negative clock edge (at the next crossing of CK and CK#). Figure 45 (page 89) shows examples of RL based on different AL and CL settings.

DQS/DQS# is driven by the DDR2 SDRAM along with output data. The initial LOW state on DQS and the HIGH state on DQS# are known as the read preamble ( $t_{RPRE}$ ). The LOW state on DQS and the HIGH state on DQS# coincident with the last data-out element are known as the read postamble ( $t_{RPST}$ ).

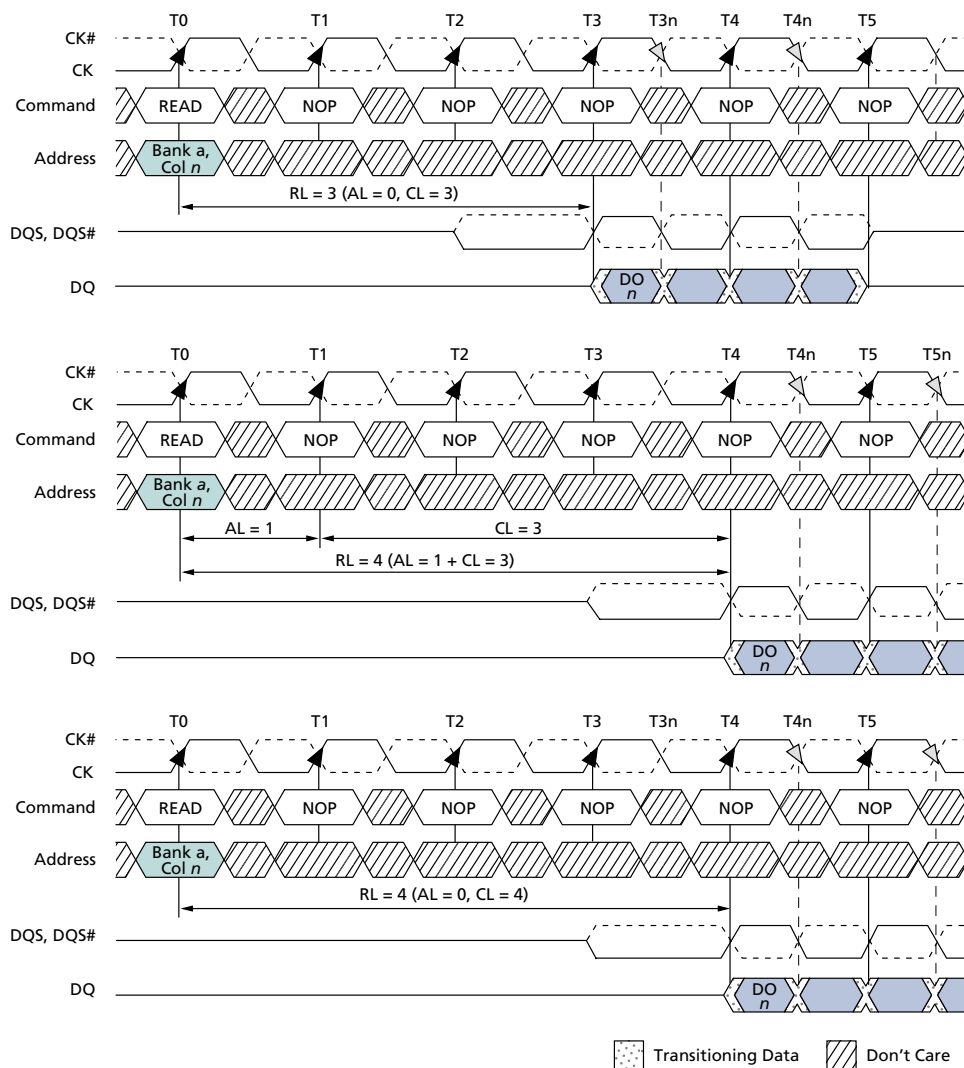
Upon completion of a burst, assuming no other commands have been initiated, the DQ will go High-Z. A detailed explanation of  $t_{DQSQ}$  (valid data-out skew),  $t_{QH}$  (data-out window hold), and the valid data window are depicted in Figure 54 (page 97) and Figure 55 (page 98). A detailed explanation of  $t_{DQSCK}$  (DQS transition skew to CK) and  $t_{AC}$  (data-out transition skew to CK) is shown in Figure 56 (page 99).

Data from any READ burst may be concatenated with data from a subsequent READ command to provide a continuous flow of data. The first data element from the new burst follows the last element of a completed burst. The new READ command should be issued  $x$  cycles after the first READ command, where  $x$  equals  $BL/2$  cycles (see Figure 46 (page 90)).

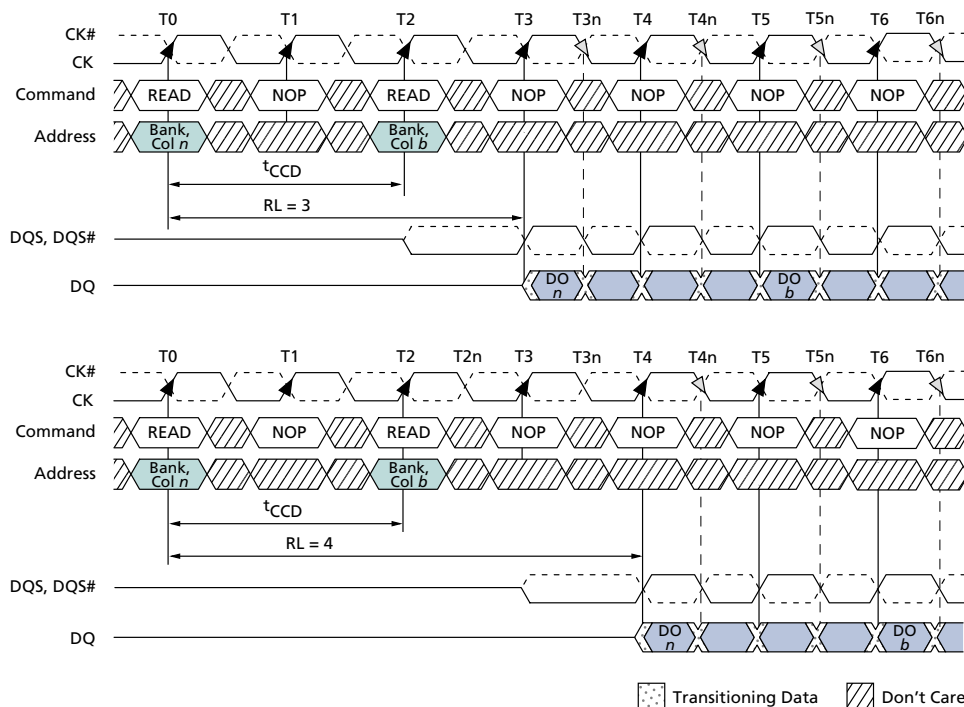
Nonconsecutive read data is illustrated in Figure 47 (page 91). Full-speed random read accesses within a page (or pages) can be performed. DDR2 SDRAM supports the use of concurrent auto precharge timing (see Table 41 (page 94)).

DDR2 SDRAM does not allow interrupting or truncating of any READ burst using  $BL = 4$  operations. Once the  $BL = 4$  READ command is registered, it must be allowed to complete the entire READ burst. However, a READ (with auto precharge disabled) using  $BL = 8$  operation may be interrupted and truncated *only* by another READ burst as long as the interruption occurs on a 4-bit boundary due to the  $4n$  prefetch architecture of DDR2 SDRAM. As shown in Figure 48 (page 92), READ burst  $BL = 8$  operations may not be interrupted or truncated with any other command except another READ command.

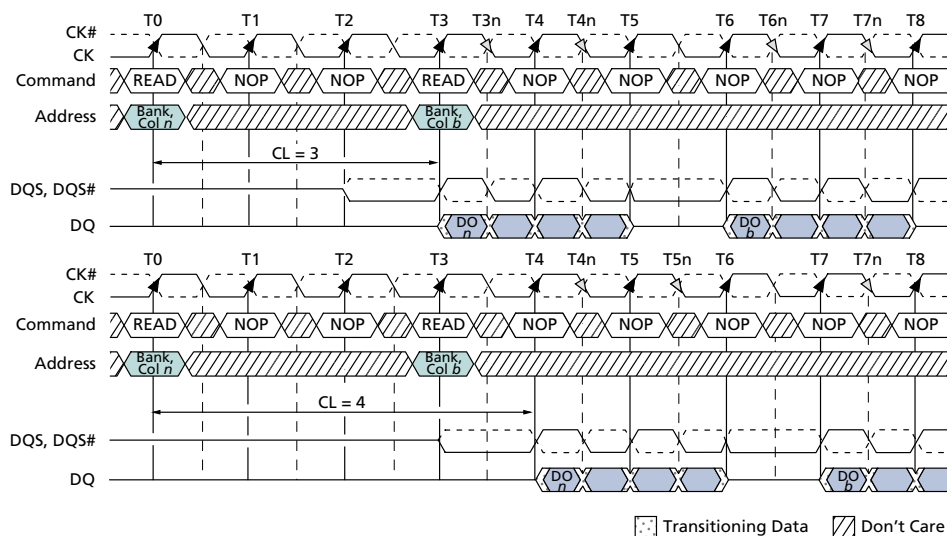
Data from any READ burst must be completed before a subsequent WRITE burst is allowed. An example of a READ burst followed by a WRITE burst is shown in Figure 49 (page 92). The  $t_{DQSS}$  (NOM) case is shown ( $t_{DQSS}$  [MIN] and  $t_{DQSS}$  [MAX] are defined in Figure 57 (page 101)).

**Figure 45: READ Latency**


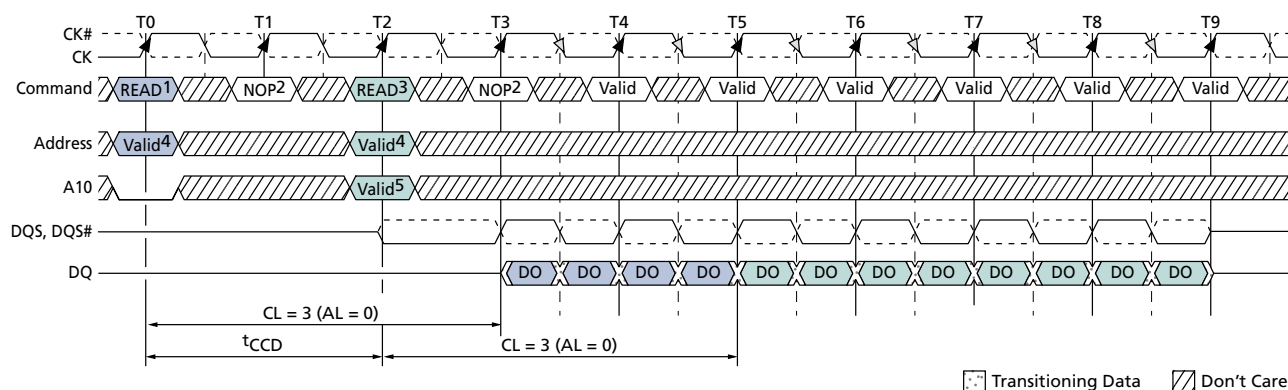
- Notes:
1.  $DO_n$  = data-out from column  $n$ .
  2.  $BL = 4$ .
  3. Three subsequent elements of data-out appear in the programmed order following  $DO_n$ .
  4. Shown with nominal  $t_{AC}$ ,  $t_{DQSCK}$ , and  $t_{DQSQ}$ .

**Figure 46: Consecutive READ Bursts**


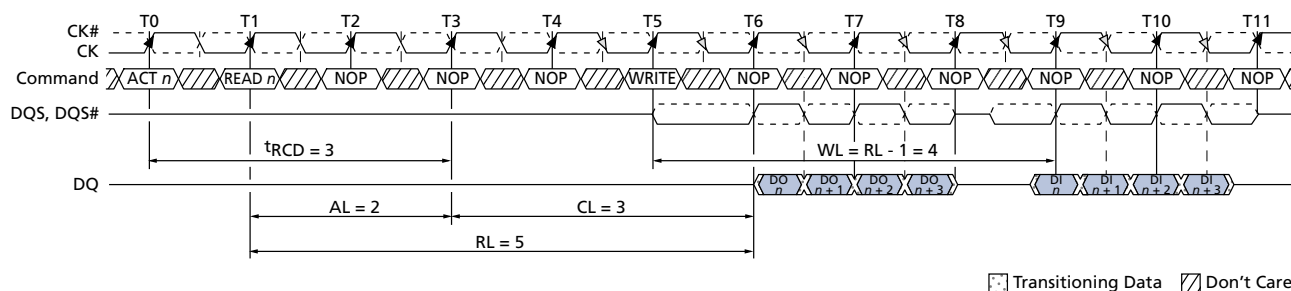
- Notes:
1. DO *n* (or *b*) = data-out from column *n* (or column *b*).
  2. BL = 4.
  3. Three subsequent elements of data-out appear in the programmed order following DO *n*.
  4. Three subsequent elements of data-out appear in the programmed order following DO *b*.
  5. Shown with nominal  $t_{AC}$ ,  $t_{DQSCK}$ , and  $t_{DQSQ}$ .
  6. Example applies only when READ commands are issued to same device.

**Figure 47: Nonconsecutive READ Bursts**


- Notes:
1. DO *n* (or *b*) = data-out from column *n* (or column *b*).
  2. BL = 4.
  3. Three subsequent elements of data-out appear in the programmed order following DO *n*.
  4. Three subsequent elements of data-out appear in the programmed order following DO *b*.
  5. Shown with nominal  $t_{AC}$ ,  $t_{DQSCK}$ , and  $t_{DQSQ}$ .
  6. Example applies when READ commands are issued to different devices or nonconsecutive READs.

**Figure 48: READ Interrupted by READ**


- Notes:
1. BL = 8 required; auto precharge must be disabled (A10 = LOW).
  2. NOP or COMMAND INHIBIT commands are valid. PRECHARGE command cannot be issued to banks used for READs at T0 and T2.
  3. Interrupting READ command must be issued exactly  $2 \times t_{CK}$  from previous READ.
  4. READ command can be issued to any valid bank and row address (READ command at T0 and T2 can be either same bank or different bank).
  5. Auto precharge can be either enabled (A10 = HIGH) or disabled (A10 = LOW) by the interrupting READ command.
  6. Example shown uses AL = 0; CL = 3, BL = 8, shown with nominal  $t_{AC}$ ,  $t_{DQSK}$ , and  $t_{DQSQ}$ .

**Figure 49: READ-to-WRITE**


- Notes:
1. BL = 4; CL = 3; AL = 2.
  2. Shown with nominal  $t_{AC}$ ,  $t_{DQSK}$ , and  $t_{DQSQ}$ .

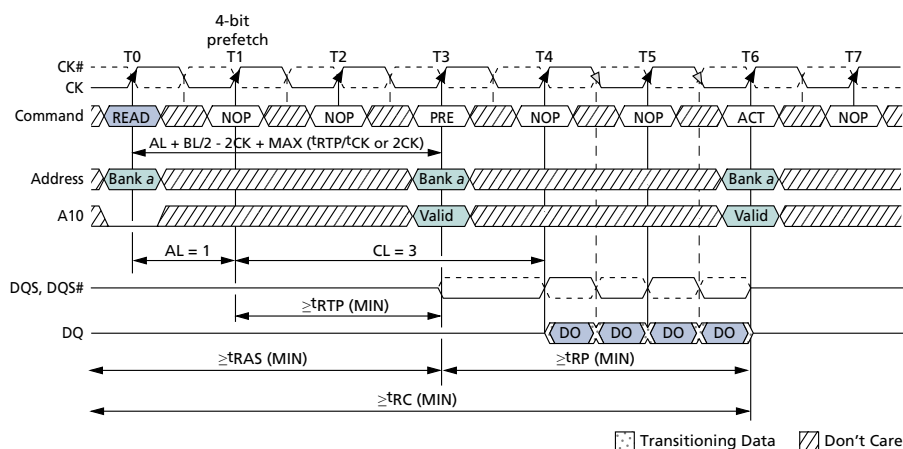
## READ with Precharge

A READ burst may be followed by a PRECHARGE command to the same bank, provided auto precharge is not activated. The minimum READ-to-PRECHARGE command spacing to the same bank has two requirements that must be satisfied:  $AL + BL/2$  clocks and  $t_{RTP}$ .  $t_{RTP}$  is the minimum time from the rising clock edge that initiates the last 4-bit prefetch of a READ command to the PRECHARGE command. For BL = 4, this is the time from the actual READ (AL after the READ command) to PRECHARGE command. For BL = 8, this is the time from AL +  $2 \times CK$  after the READ-to-PRECHARGE command. Following the PRECHARGE command, a subsequent command to the same bank can-

not be issued until  $t_{RP}$  is met. However, part of the row precharge time is hidden during the access of the last data elements.

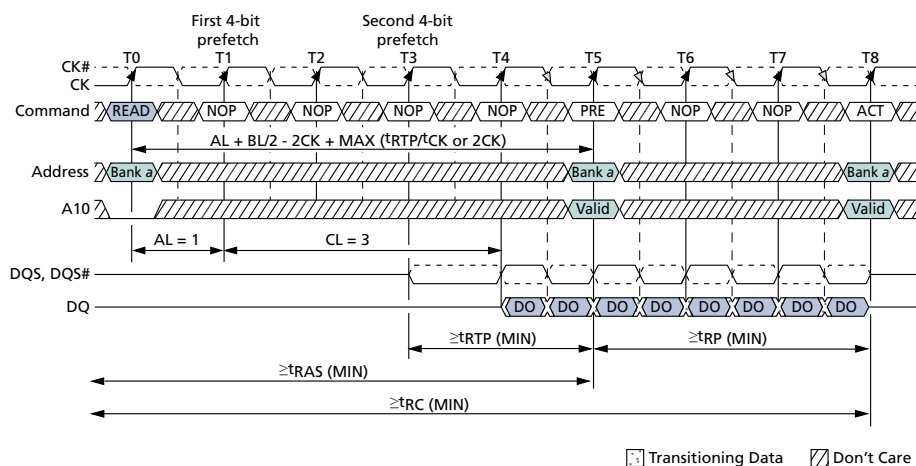
Examples of READ-to-PRECHARGE for BL = 4 are shown in Figure 50 and in Figure 51 for BL = 8. The delay from READ-to-PRECHARGE period to the same bank is  $AL + BL/2 - 2CK + \text{MAX}(t_{RTP}/t_{CK} \text{ or } 2CK)$  where MAX means the larger of the two.

**Figure 50: READ-to-PRECHARGE – BL = 4**



- Notes:
1. RL = 4 (AL = 1, CL = 3); BL = 4.
  2.  $t_{RTP} \geq 2$  clocks.
  3. Shown with nominal  $t_{AC}$ ,  $t_{DQSCK}$ , and  $t_{DQSQ}$ .

**Figure 51: READ-to-PRECHARGE – BL = 8**



- Notes:
1. RL = 4 (AL = 1, CL = 3); BL = 8.
  2.  $t_{RTP} \geq 2$  clocks.
  3. Shown with nominal  $t_{AC}$ ,  $t_{DQSCK}$ , and  $t_{DQSQ}$ .

## READ with Auto Precharge

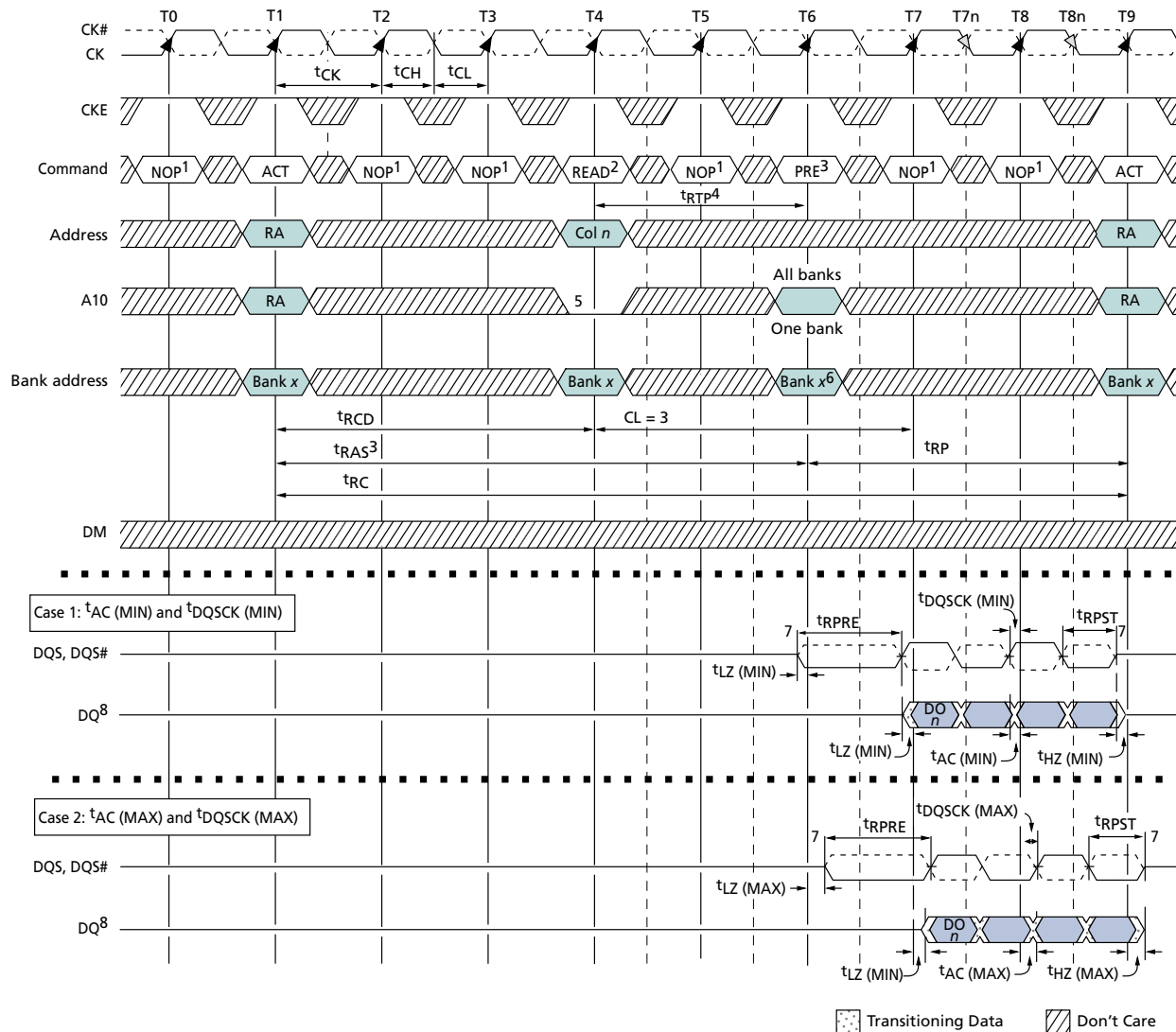
If A10 is high when a READ command is issued, the READ with auto precharge function is engaged. The DDR2 SDRAM starts an auto precharge operation on the rising clock edge that is  $AL + (BL/2)$  cycles later than the read with auto precharge command provided  $t_{RAS} (MIN)$  and  $t_{RTP}$  are satisfied. If  $t_{RAS} (MIN)$  is not satisfied at this rising clock edge, the start point of the auto precharge operation will be delayed until  $t_{RAS} (MIN)$  is satisfied. If  $t_{RTP} (MIN)$  is not satisfied at this rising clock edge, the start point of the auto precharge operation will be delayed until  $t_{RTP} (MIN)$  is satisfied. When the internal precharge is pushed out by  $t_{RTP}$ ,  $t_{RP}$  starts at the point where the internal precharge happens (not at the next rising clock edge after this event).

When  $BL = 4$ , the minimum time from READ with auto precharge to the next ACTIVATE command is  $AL + (t_{RTP} + t_{RP})/t_{CK}$ . When  $BL = 8$ , the minimum time from READ with auto precharge to the next ACTIVATE command is  $AL + 2 \text{ clocks} + (t_{RTP} + t_{RP})/t_{CK}$ . The term  $(t_{RTP} + t_{RP})/t_{CK}$  is always rounded up to the next integer. A general purpose equation can also be used:  $AL + BL/2 - 2CK + (t_{RTP} + t_{RP})/t_{CK}$ . In any event, the internal precharge does not start earlier than two clocks after the last 4-bit prefetch.

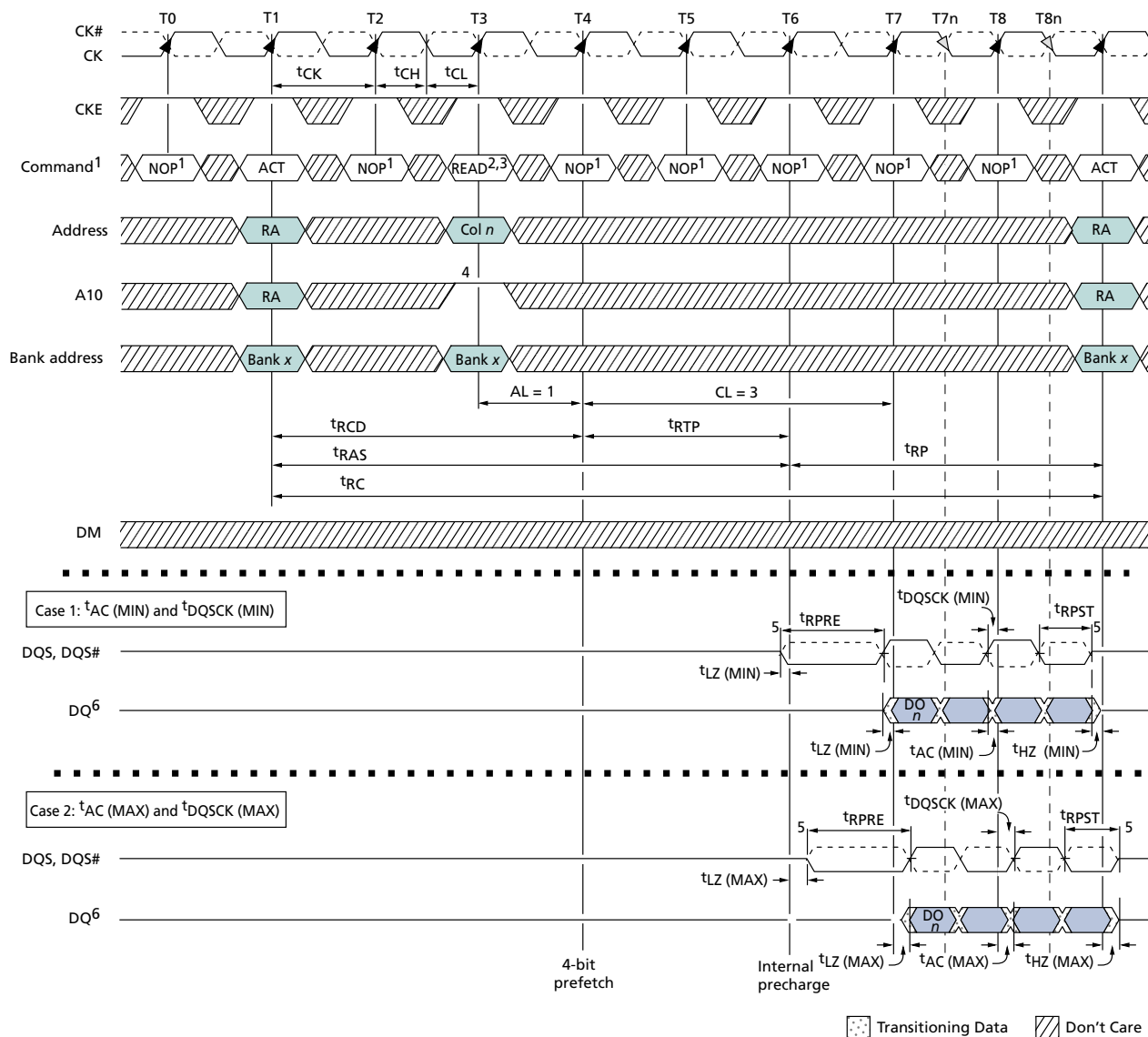
READ with auto precharge command may be applied to one bank while another bank is operational. This is referred to as concurrent auto precharge operation, as noted in Table 41. Examples of READ with precharge and READ with auto precharge with applicable timing requirements are shown in Figure 52 (page 95) and Figure 53 (page 96), respectively.

**Table 41: READ Using Concurrent Auto Precharge**

| From Command (Bank <i>n</i> ) | To Command (Bank <i>m</i> )        | Minimum Delay<br>(with Concurrent Auto Precharge) | Units    |
|-------------------------------|------------------------------------|---------------------------------------------------|----------|
| READ with auto precharge      | READ or READ with auto precharge   | $BL/2$                                            | $t_{CK}$ |
|                               | WRITE or WRITE with auto precharge | $(BL/2) + 2$                                      | $t_{CK}$ |
|                               | PRECHARGE or ACTIVATE              | 1                                                 | $t_{CK}$ |

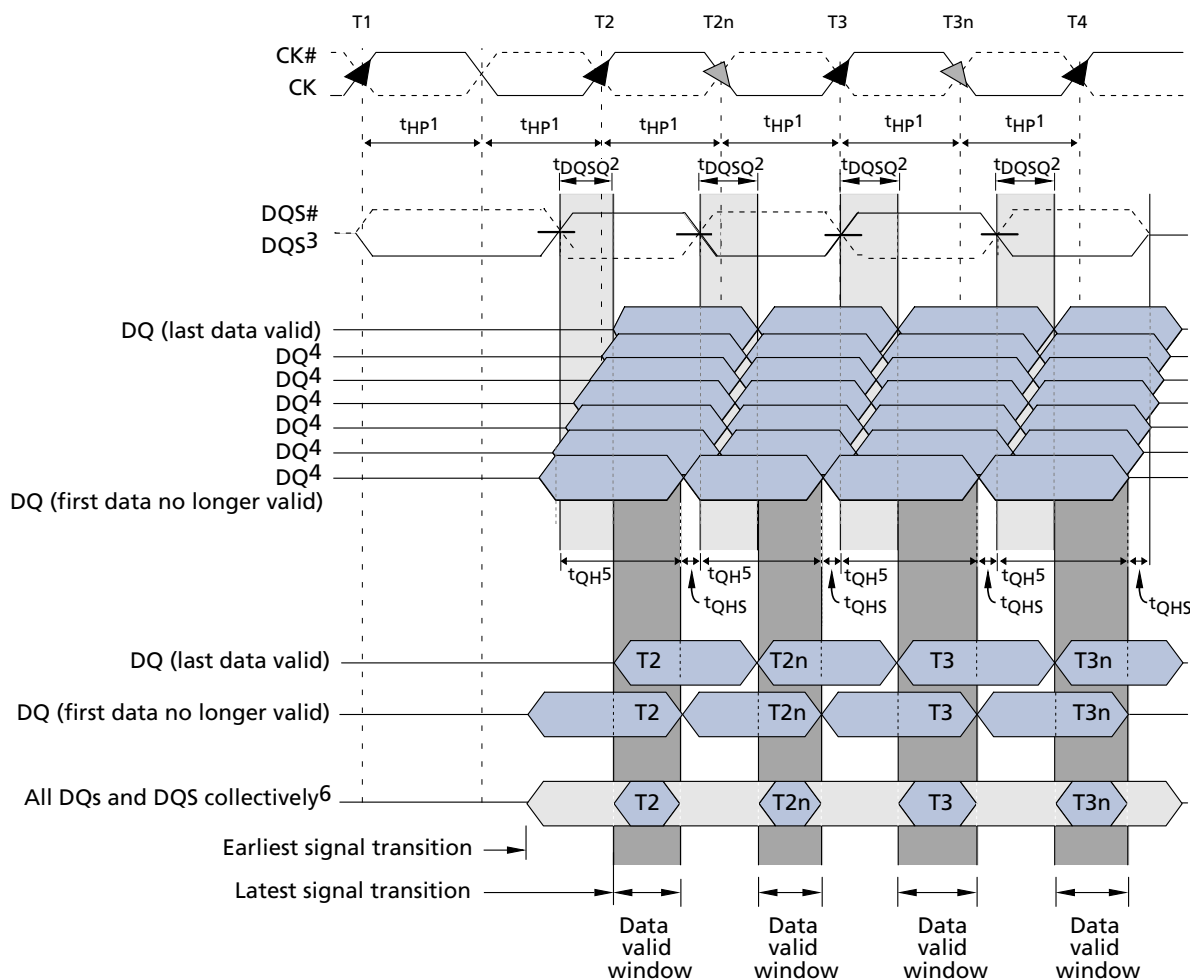
**Figure 52: Bank Read – Without Auto Precharge**


- Notes:
1. NOP commands are shown for ease of illustration; other commands may be valid at these times.
  2. BL = 4 and AL = 0 in the case shown.
  3. The PRECHARGE command can only be applied at T6 if  $t_{RAS}$  (MIN) is met.
  4. READ-to-PRECHARGE = AL + BL/2 - 2CK + MAX ( $t_{RTP}/t_{CK}$  or 2CK).
  5. Disable auto precharge.
  6. "Don't Care" if A10 is HIGH at T5.
  7. I/O balls, when entering or exiting High-Z, are not referenced to a specific voltage level, but to when the device begins to drive or no longer drives, respectively.
  8. DO  $n$  = data-out from column  $n$ ; subsequent elements are applied in the programmed order.

**Figure 53: Bank Read – with Auto Precharge**


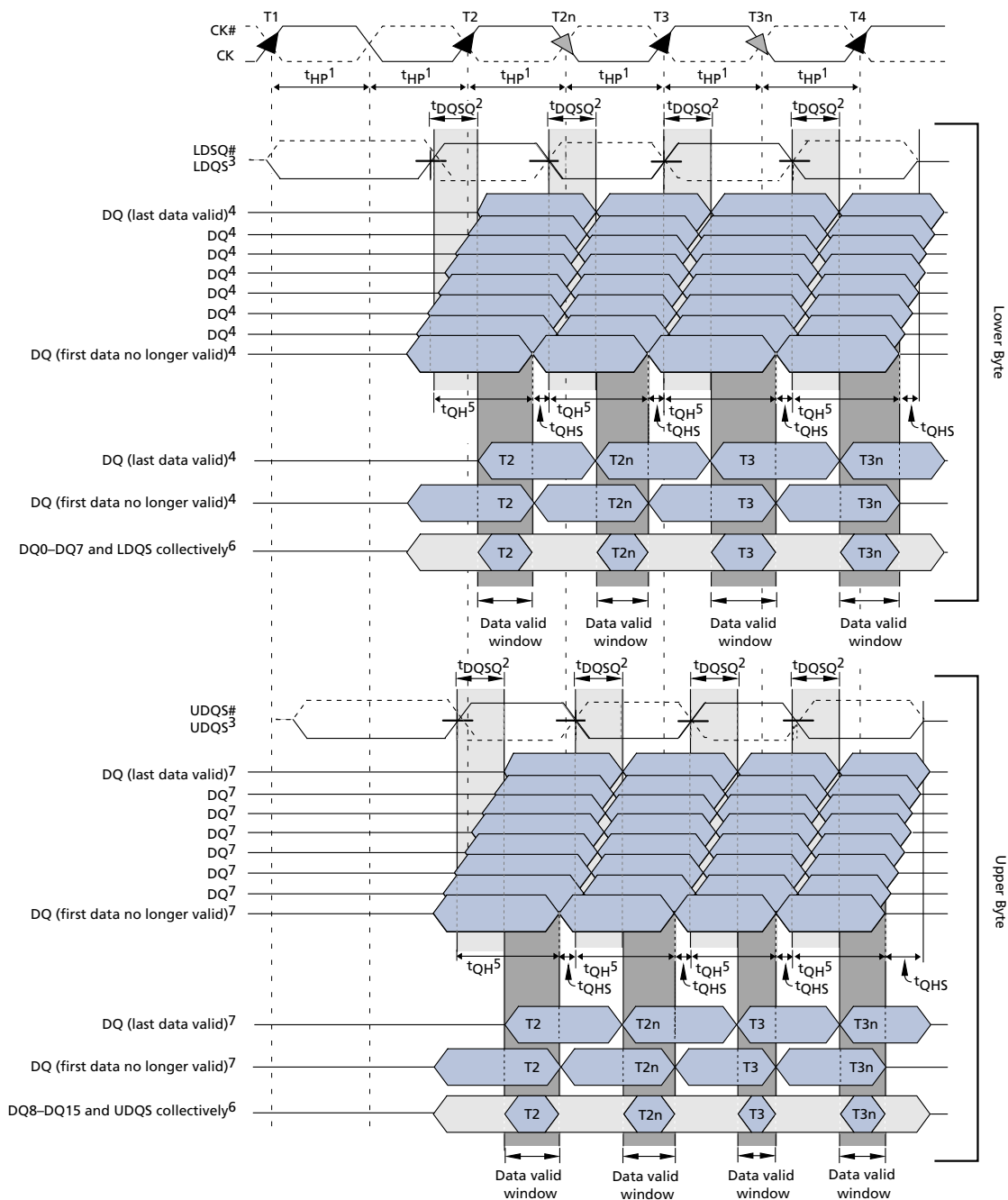
- Notes:
1. NOP commands are shown for ease of illustration; other commands may be valid at these times.
  2. BL = 4, RL = 4 (AL = 1, CL = 3) in the case shown.
  3. The DDR2 SDRAM internally delays auto precharge until both  $t_{RAS}$  (MIN) and  $t_{RTP}$  (MIN) have been satisfied.
  4. Enable auto precharge.
  5. I/O balls, when entering or exiting High-Z, are not referenced to a specific voltage level, but to when the device begins to drive or no longer drives, respectively.
  6. DO  $n$  = data-out from column  $n$ ; subsequent elements are applied in the programmed order.

Figure 54: x4, x8 Data Output Timing –  $t_{DQSQ}$ ,  $t_{QH}$ , and Data Valid Window



- Notes:
1.  $t_{HP}$  is the lesser of  $t_{CL}$  or  $t_{CH}$  clock transitions collectively when a bank is active.
  2.  $t_{DQSQ}$  is derived at each DQS clock edge, is not cumulative over time, begins with DQS transitions, and ends with the last valid transition of DQ.
  3. DQ transitioning after the DQS transition defines the  $t_{DQSQ}$  window. DQS transitions at T2 and at T2n are "early DQS," at T3 are "nominal DQS," and at T3n are "late DQS."
  4. DQ0, DQ1, DQ2, DQ3 for x4 or DQ0–DQ7 for x8.
  5.  $t_{QH}$  is derived from  $t_{HP}$ :  $t_{QH} = t_{HP} - t_{QHS}$ .
  6. The data valid window is derived for each DQS transition and is defined as  $t_{QH} - t_{DQSQ}$ .

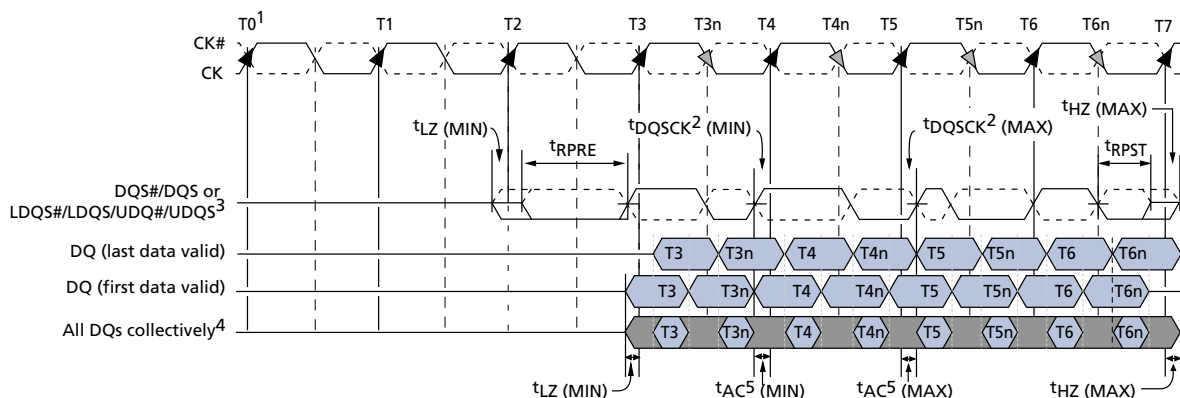
Figure 55: x16 Data Output Timing –  $t_{DQSQ}$ ,  $t_{QH}$ , and Data Valid Window



- Notes:
1.  $t_{HP}$  is the lesser of  $t_{CL}$  or  $t_{CH}$  clock transitions collectively when a bank is active.
  2.  $t_{DQSQ}$  is derived at each DQS clock edge, is not cumulative over time, begins with DQS transitions, and ends with the last valid transition of DQ.
  3. DQ transition after the DQS transitions define the  $t_{DQSQ}$  window. LDQS defines the lower byte, and UDQS defines the upper byte.
  4. DQ0, DQ1, DQ2, DQ3, DQ4, DQ5, DQ6, or DQ7.

5.  $t_{QH}$  is derived from  $t_{HP}$ :  $t_{QH} = t_{HP} - t_{QHS}$ .
6. The data valid window is derived for each DQS transition and is  $t_{QH} - t_{DQSQ}$ .
7. DQ8, DQ9, DQ10, DQ11, DQ12, DQ13, DQ14, or DQ15.

**Figure 56: Data Output Timing –  $t_{AC}$  and  $t_{DQSCK}$**



- Notes:
1. READ command with CL = 3, AL = 0 issued at T0.
  2.  $t_{DQSCK}$  is the DQS output window relative to CK and is the long-term component of DQS skew.
  3. DQ transitioning after DQS transitions define  $t_{DQSQ}$  window.
  4. All DQ must transition by  $t_{DQSQ}$  after DQS transitions, regardless of  $t_{AC}$ .
  5.  $t_{AC}$  is the DQ output window relative to CK and is the "long term" component of DQ skew.
  6.  $t_{LZ} (MIN)$  and  $t_{AC} (MIN)$  are the first valid signal transitions.
  7.  $t_{HZ} (MAX)$  and  $t_{AC} (MAX)$  are the latest valid signal transitions.
  8. I/O balls, when entering or exiting High-Z, are not referenced to a specific voltage level, but to when the device begins to drive or no longer drives, respectively.

## WRITE

WRITE bursts are initiated with a WRITE command. DDR2 SDRAM uses WL equal to RL minus one clock cycle ( $WL = RL - 1CK$ ) (see READ (page 71)). The starting column and bank addresses are provided with the WRITE command, and auto precharge is either enabled or disabled for that access. If auto precharge is enabled, the row being accessed is precharged at the completion of the burst.

### Note:

For the WRITE commands used in the following illustrations, auto precharge is disabled.

During WRITE bursts, the first valid data-in element will be registered on the first rising edge of DQS following the WRITE command, and subsequent data elements will be registered on successive edges of DQS. The LOW state on DQS between the WRITE command and the first rising edge is known as the write preamble; the LOW state on DQS following the last data-in element is known as the write postamble.

The time between the WRITE command and the first rising DQS edge is  $WL \pm t_{DQSS}$ . Subsequent DQS positive rising edges are timed, relative to the associated clock edge, as  $\pm t_{DQSS}$ .  $t_{DQSS}$  is specified with a relatively wide range (25% of one clock cycle). All of

the WRITE diagrams show the nominal case, and where the two extreme cases ( $t_{DQSS}$  [MIN] and  $t_{DQSS}$  [MAX]) might not be intuitive, they have also been included. Figure 57 (page 101) shows the nominal case and the extremes of  $t_{DQSS}$  for BL = 4. Upon completion of a burst, assuming no other commands have been initiated, the DQ will remain High-Z and any additional input data will be ignored.

Data for any WRITE burst may be concatenated with a subsequent WRITE command to provide continuous flow of input data. The first data element from the new burst is applied after the last element of a completed burst. The new WRITE command should be issued  $x$  cycles after the first WRITE command, where  $x$  equals BL/2.

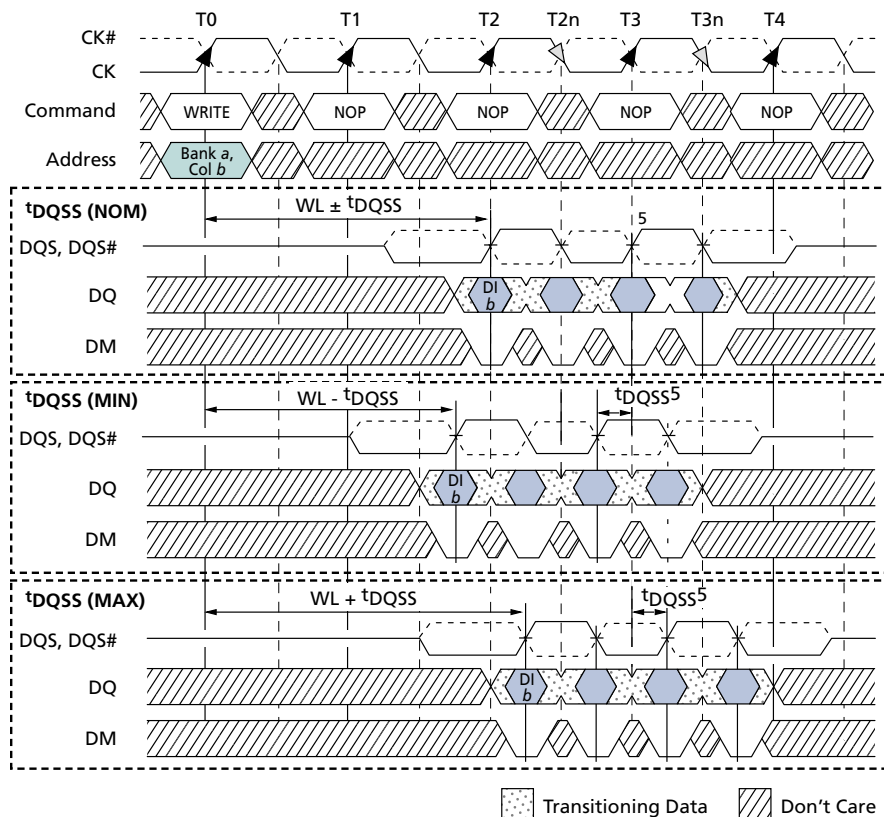
Figure 58 (page 102) shows concatenated bursts of BL = 4 and how full-speed random write accesses within a page or pages can be performed. An example of nonconsecutive WRITES is shown in Figure 59 (page 102). DDR2 SDRAM supports concurrent auto precharge options, as shown in Table 42.

DDR2 SDRAM does not allow interrupting or truncating any WRITE burst using BL = 4 operation. Once the BL = 4 WRITE command is registered, it must be allowed to complete the entire WRITE burst cycle. However, a WRITE BL = 8 operation (with auto precharge disabled) might be interrupted and truncated *only* by another WRITE burst as long as the interruption occurs on a 4-bit boundary due to the  $4n$ -prefetch architecture of DDR2 SDRAM. WRITE burst BL = 8 operations may *not* be interrupted or truncated with any command except another WRITE command, as shown in Figure 60 (page 103).

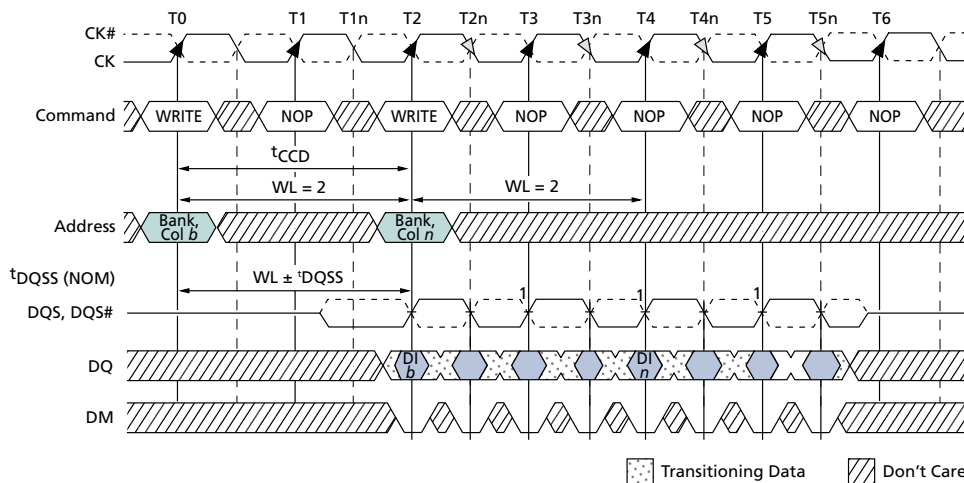
Data for any WRITE burst may be followed by a subsequent READ command. To follow a WRITE,  $t_{WTR}$  should be met, as shown in Figure 61 (page 104). The number of clock cycles required to meet  $t_{WTR}$  is either 2 or  $t_{WTR}/t_{CK}$ , whichever is greater. Data for any WRITE burst may be followed by a subsequent PRECHARGE command.  $t_{WR}$  must be met, as shown in Figure 62 (page 105).  $t_{WR}$  starts at the end of the data burst, regardless of the data mask condition.

**Table 42: WRITE Using Concurrent Auto Precharge**

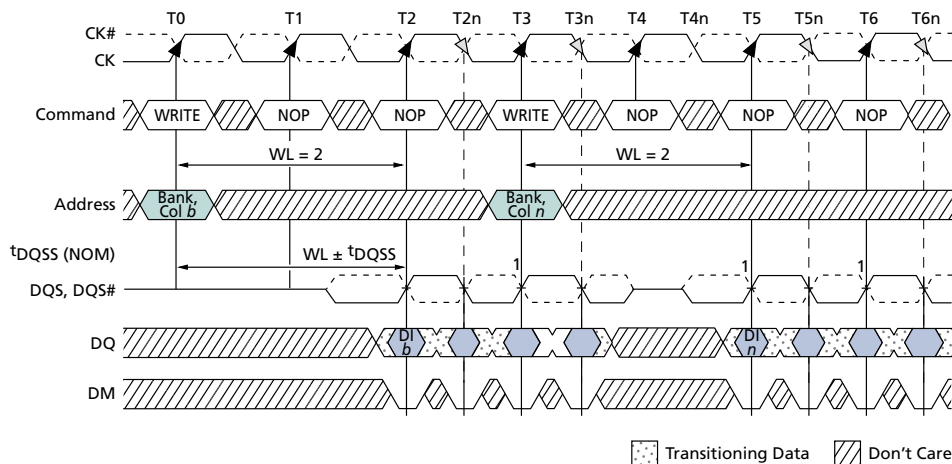
| From Command<br>(Bank $n$ ) | To Command<br>(Bank $m$ )          | Minimum Delay<br>(with Concurrent Auto Precharge) | Units    |
|-----------------------------|------------------------------------|---------------------------------------------------|----------|
| WRITE with auto precharge   | READ or READ with auto precharge   | $(CL - 1) + (BL/2) + t_{WTR}$                     | $t_{CK}$ |
|                             | WRITE or WRITE with auto precharge | $(BL/2)$                                          | $t_{CK}$ |
|                             | PRECHARGE or ACTIVATE              | 1                                                 | $t_{CK}$ |

**Figure 57: Write Burst**


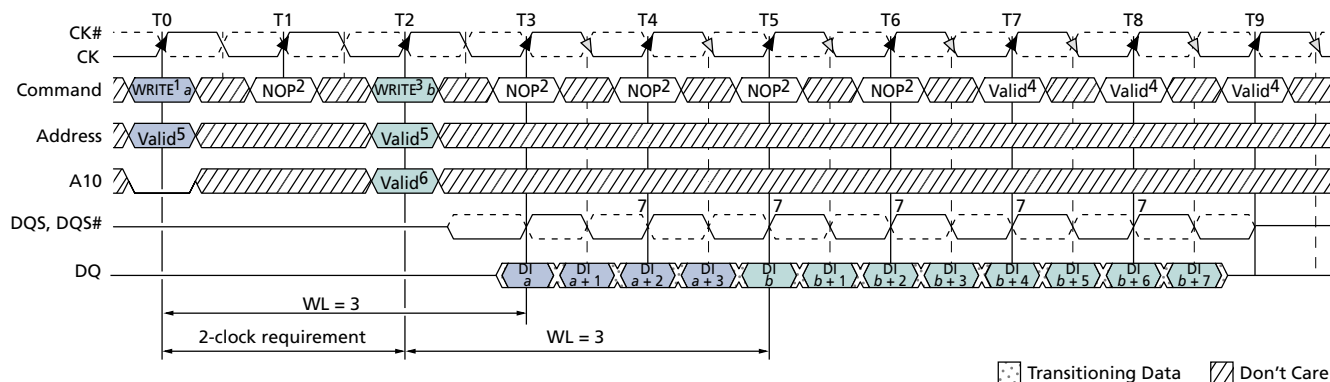
- Notes:
1. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  2. DI  $b$  = data-in for column  $b$ .
  3. Three subsequent elements of data-in are applied in the programmed order following DI  $b$ .
  4. Shown with BL = 4, AL = 0, CL = 3; thus, WL = 2.
  5. A10 is LOW with the WRITE command (auto precharge is disabled).

**Figure 58: Consecutive WRITE-to-WRITE**


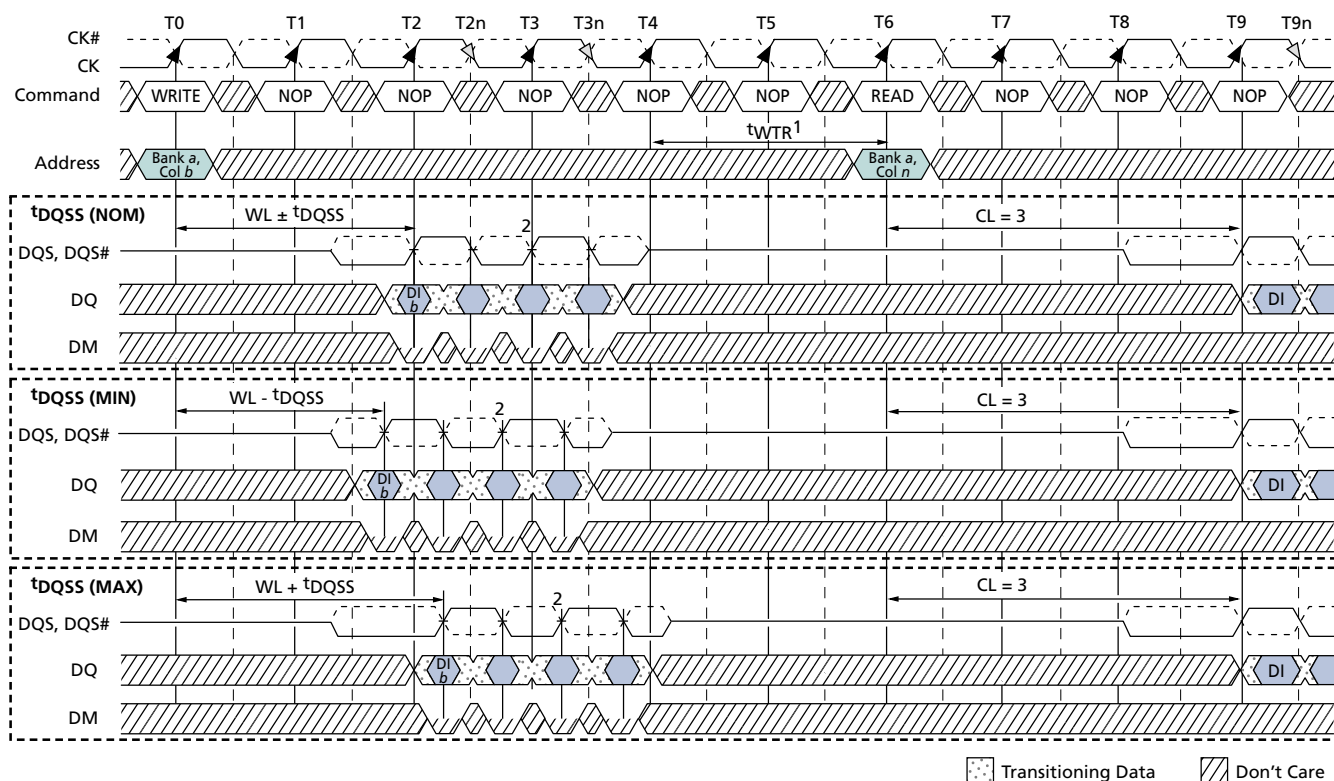
- Notes:
1. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  2. DI  $b$ , etc. = data-in for column  $b$ , etc.
  3. Three subsequent elements of data-in are applied in the programmed order following DI  $b$ .
  4. Three subsequent elements of data-in are applied in the programmed order following DI  $n$ .
  5. Shown with BL = 4, AL = 0, CL = 3; thus, WL = 2.
  6. Each WRITE command may be to any bank.

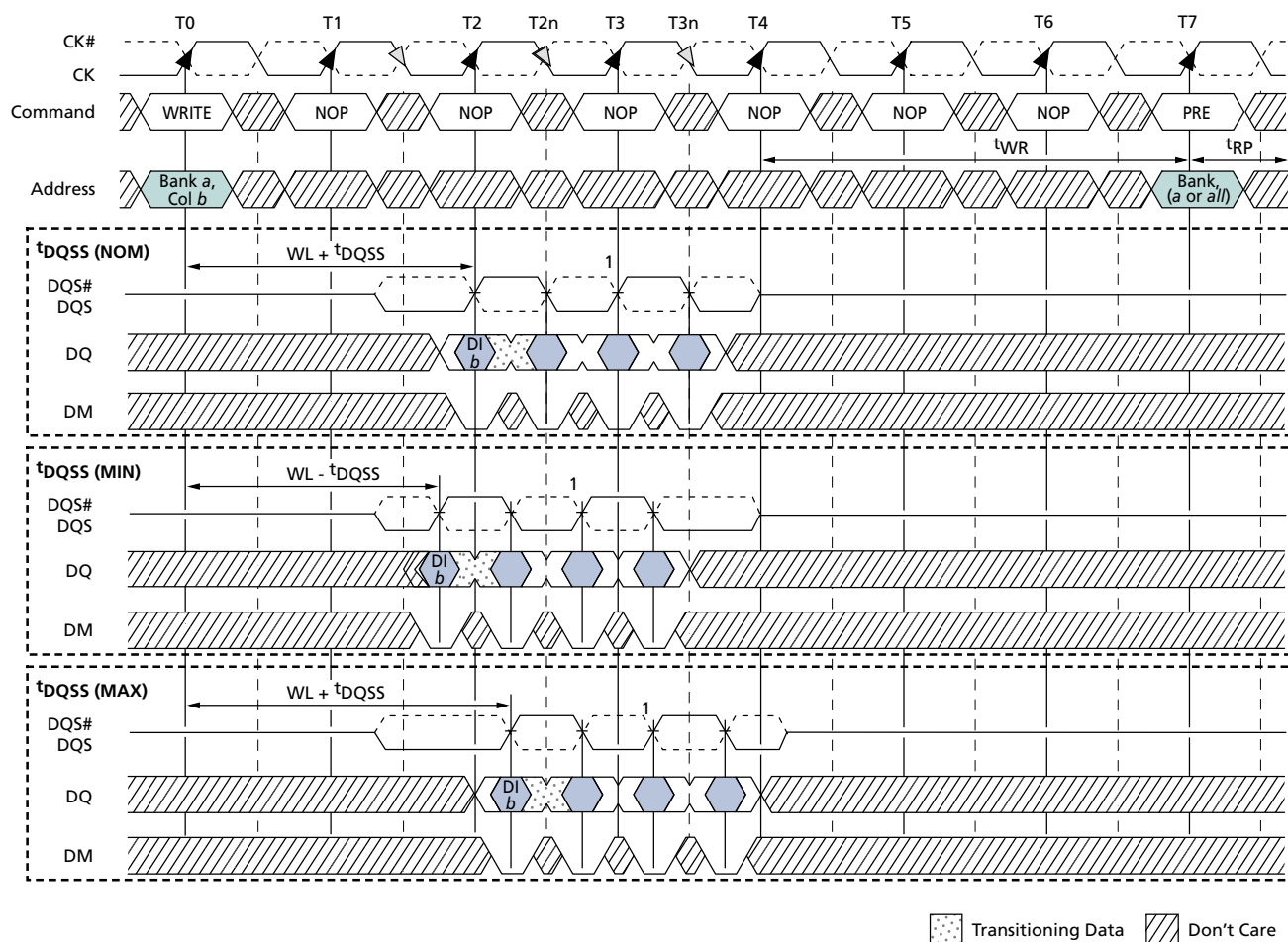
**Figure 59: Nonconsecutive WRITE-to-WRITE**


- Notes:
1. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  2. DI  $b$  (or  $n$ ), etc. = data-in for column  $b$  (or column  $n$ ).
  3. Three subsequent elements of data-in are applied in the programmed order following DI  $b$ .
  4. Three subsequent elements of data-in are applied in the programmed order following DI  $n$ .
  5. Shown with BL = 4, AL = 0, CL = 3; thus, WL = 2.
  6. Each WRITE command may be to any bank.

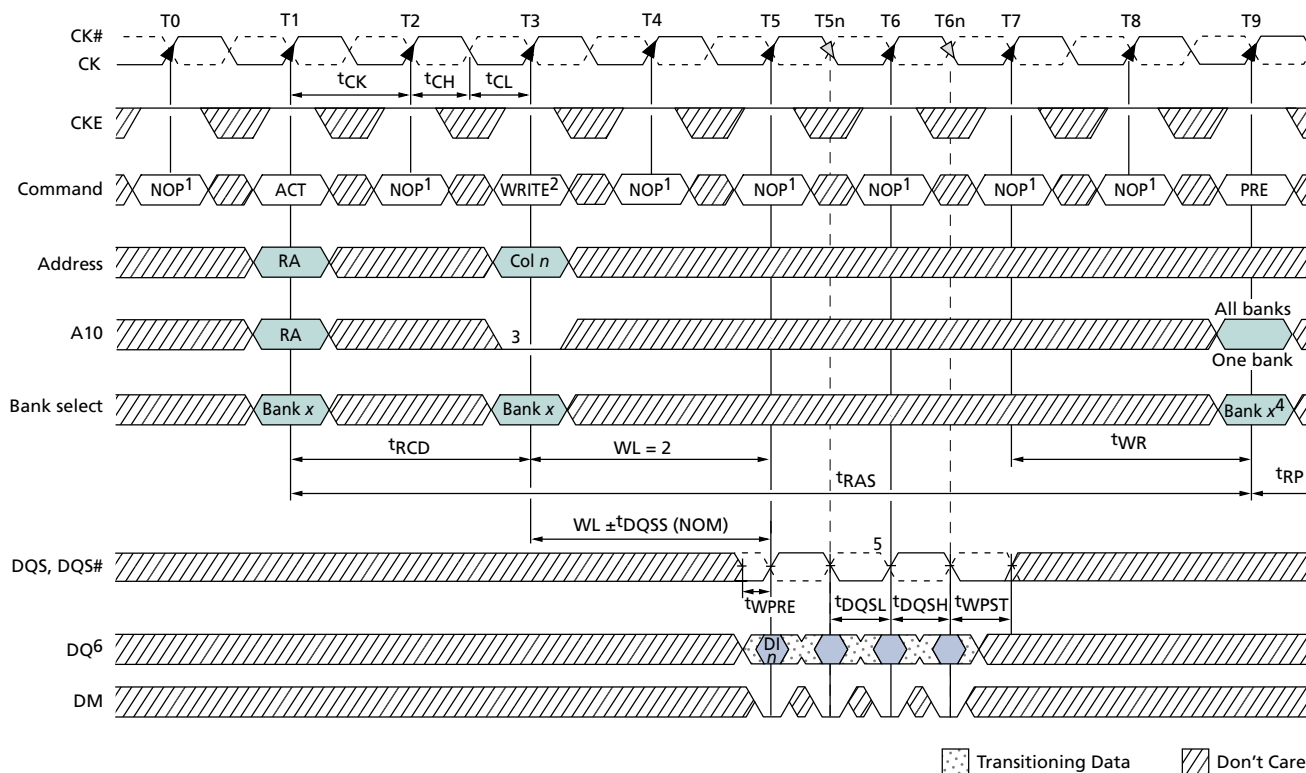
**Figure 60: WRITE Interrupted by WRITE**


- Notes:
1. BL = 8 required and auto precharge must be disabled (A10 = LOW).
  2. The NOP or COMMAND INHIBIT commands are valid. The PRECHARGE command cannot be issued to banks used for WRITES at T0 and T2.
  3. The interrupting WRITE command must be issued exactly  $2 \times t_{CK}$  from previous WRITE.
  4. The earliest WRITE-to-PRECHARGE timing for WRITE at T0 is  $WL + BL/2 + t_{WR}$  where  $t_{WR}$  starts with T7 and not T5 (because BL = 8 from MR and not the truncated length).
  5. The WRITE command can be issued to any valid bank and row address (WRITE command at T0 and T2 can be either same bank or different bank).
  6. Auto precharge can be either enabled (A10 = HIGH) or disabled (A10 = LOW) by the interrupting WRITE command.
  7. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  8. Example shown uses AL = 0; CL = 4, BL = 8.

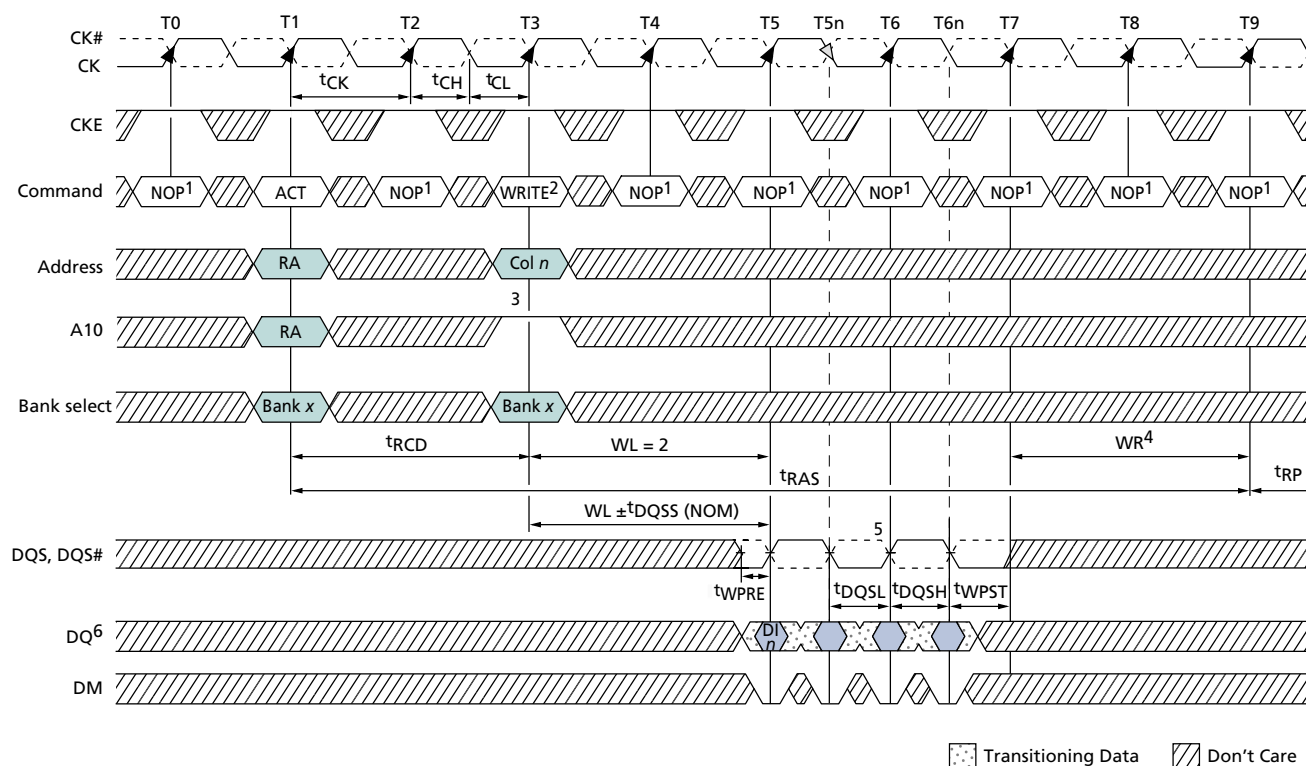
**Figure 61: WRITE-to-READ**


**Figure 62: WRITE-to-PRECHARGE**


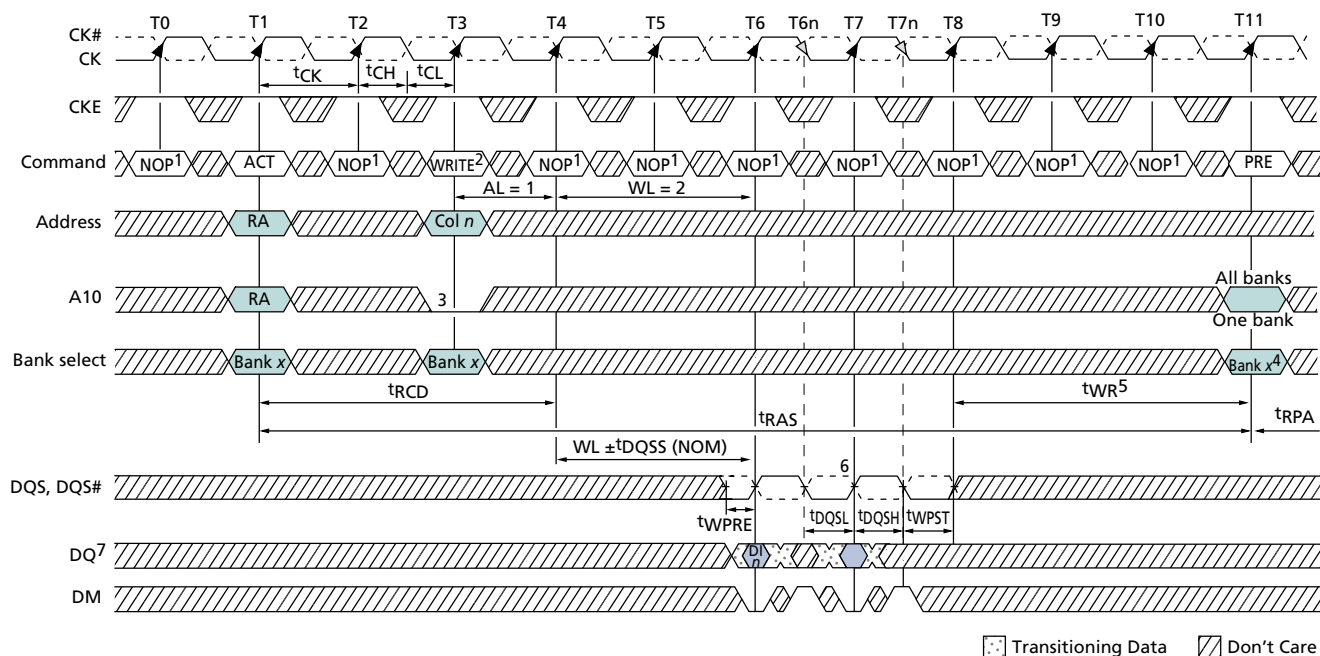
- Notes:
1. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  2. DI  $b$  = data-in for column  $b$ .
  3. Three subsequent elements of data-in are applied in the programmed order following DI  $b$ .
  4. BL = 4, CL = 3, AL = 0; thus, WL = 2.
  5.  $t_{WR}$  is referenced from the first positive CK edge after the last data-in pair.
  6. The PRECHARGE and WRITE commands are to the same bank. However, the PRECHARGE and WRITE commands may be to different banks, in which case  $t_{WR}$  is not required and the PRECHARGE command could be applied earlier.
  7. A10 is LOW with the WRITE command (auto precharge is disabled).

**Figure 63: Bank Write – Without Auto Precharge**


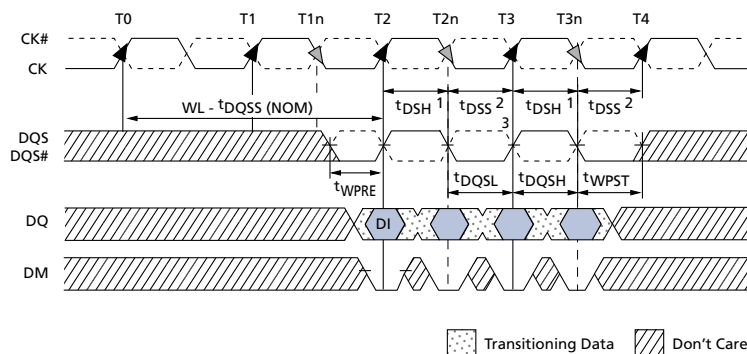
- Notes:
1. NOP commands are shown for ease of illustration; other commands may be valid at these times.
  2. BL = 4 and AL = 0 in the case shown.
  3. Disable auto precharge.
  4. "Don't Care" if A10 is HIGH at T9.
  5. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  6. DI  $n$  = data-in for column  $n$ ; subsequent elements are applied in the programmed order.
  7.  $t_{DSH}$  is applicable during  $t_{DQSS}$  (MIN) and is referenced from CK T5 or T6.
  8.  $t_{DSS}$  is applicable during  $t_{DQSS}$  (MAX) and is referenced from CK T6 or T7.

**Figure 64: Bank Write – with Auto Precharge**


- Notes:
1. NOP commands are shown for ease of illustration; other commands may be valid at these times.
  2.  $BL = 4$  and  $AL = 0$  in the case shown.
  3. Enable auto precharge.
  4.  $WR$  is programmed via MR9–MR11 and is calculated by dividing  $t_{WR}$  (in ns) by  $t_{CK}$  and rounding up to the next integer value.
  5. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  6.  $DI_n$  = data-in from column  $n$ ; subsequent elements are applied in the programmed order.
  7.  $t_{DSH}$  is applicable during  $t_{DQSS}$  (MIN) and is referenced from CK T5 or T6.
  8.  $t_{DSS}$  is applicable during  $t_{DQSS}$  (MAX) and is referenced from CK T6 or T7.

**Figure 65: WRITE – DM Operation**


- Notes:
1. NOP commands are shown for ease of illustration; other commands may be valid at these times.
  2. BL = 4, AL = 1, and WL = 2 in the case shown.
  3. Disable auto precharge.
  4. "Don't Care" if A10 is HIGH at T11.
  5.  $t_{WR}$  starts at the end of the data burst regardless of the data mask condition.
  6. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  7. DI  $n$  = data-in for column  $n$ ; subsequent elements are applied in the programmed order.
  8.  $t_{DSH}$  is applicable during  $t_{DQSS}$  (MIN) and is referenced from CK T6 or T7.
  9.  $t_{DSS}$  is applicable during  $t_{DQSS}$  (MAX) and is referenced from CK T7 or T8.

**Figure 66: Data Input Timing**


- Notes:
1.  $t_{DSH}$  (MIN) generally occurs during  $t_{DQSS}$  (MIN).
  2.  $t_{DSS}$  (MIN) generally occurs during  $t_{DQSS}$  (MAX).
  3. Subsequent rising DQS signals must align to the clock within  $t_{DQSS}$ .
  4. WRITE command issued at T0.
  5. For x16, LDQS controls the lower byte and UDQS controls the upper byte.
  6. WRITE command with  $WL = 2$  ( $CL = 3$ ,  $AL = 0$ ) issued at T0.

## PRECHARGE

Precharge can be initiated by either a manual PRECHARGE command or by an autoprecharge in conjunction with either a READ or WRITE command. Precharge will deactivate the open row in a particular bank or the open row in all banks. The PRECHARGE operation is shown in the previous READ and WRITE operation sections.

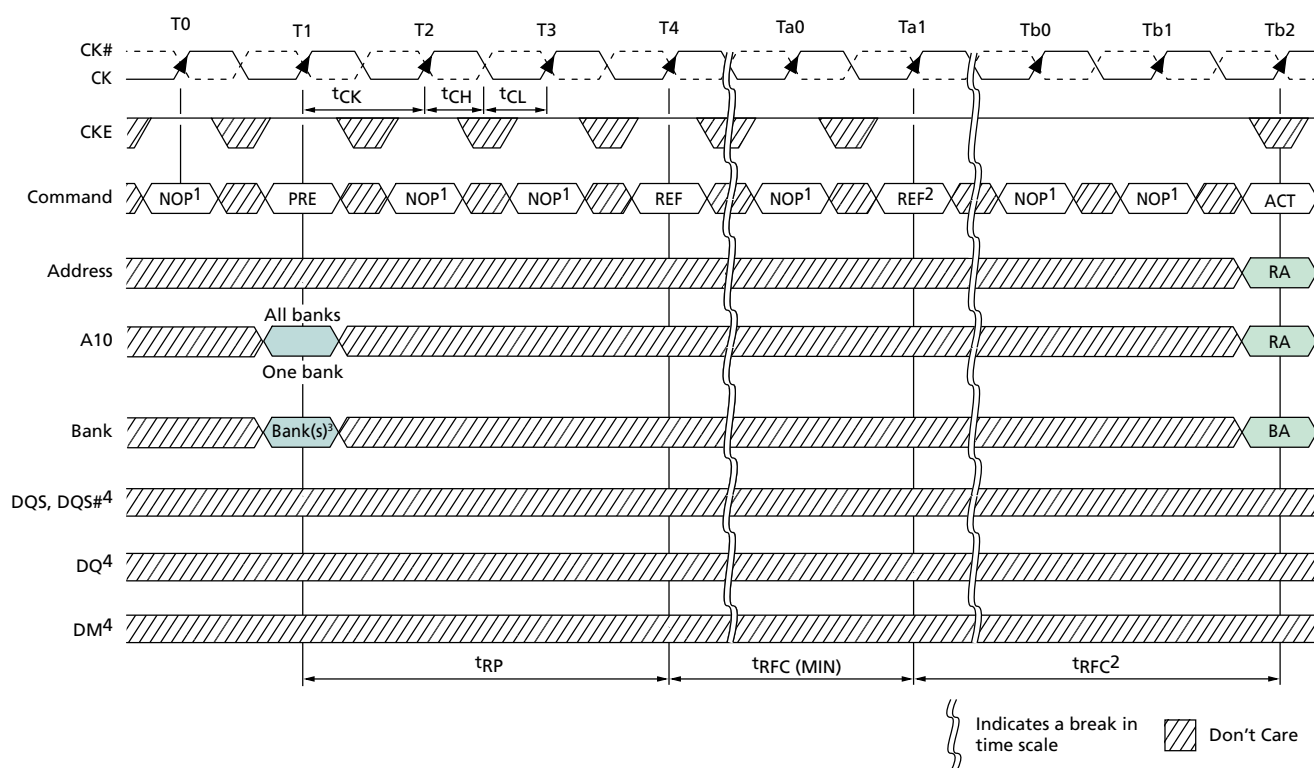
During a manual PRECHARGE command, the A10 input determines whether one or all banks are to be precharged. In the case where only one bank is to be precharged, bank address inputs determine the bank to be precharged. When all banks are to be precharged, the bank address inputs are treated as "Don't Care."

Once a bank has been precharged, it is in the idle state and must be activated prior to any READ or WRITE commands being issued to that bank. When a single-bank PRECHARGE command is issued,  $t_{RP}$  timing applies. When the PRECHARGE (ALL) command is issued,  $t_{RPA}$  timing applies, regardless of the number of banks opened.

## REFRESH

The commercial temperature DDR2 SDRAM requires REFRESH cycles at an average interval of 7.8125 $\mu$ s (MAX) and all rows in all banks must be refreshed at least once every 64ms. The refresh period begins when the REFRESH command is registered and ends  $t_{RFC}$  (MIN) later. The average interval must be reduced to 3.9 $\mu$ s (MAX) when  $T_C$  exceeds +85°C.

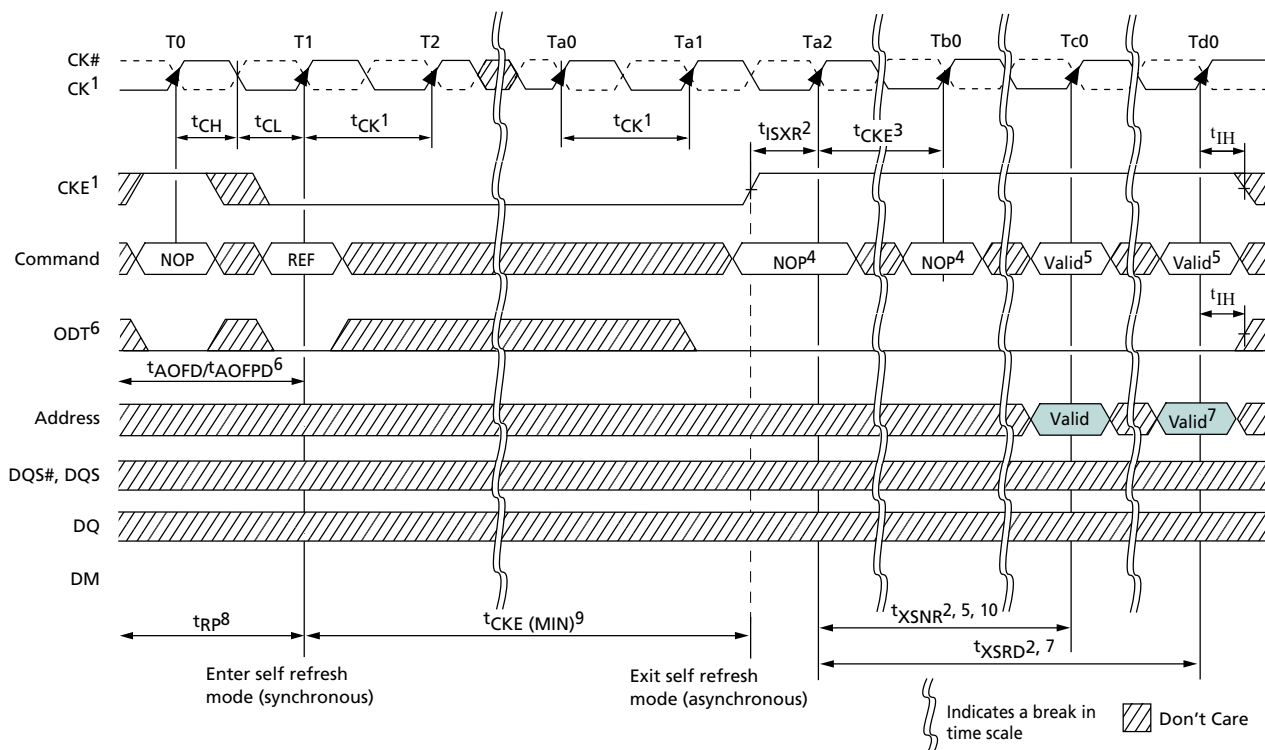
**Figure 67: Refresh Mode**



- Notes:
1. NOP commands are shown for ease of illustration; other valid commands may be possible at these times. CKE must be active during clock positive transitions.
  2. The second REFRESH is not required and is only shown as an example of two back-to-back REFRESH commands.
  3. "Don't Care" if A10 is HIGH at this point; A10 must be HIGH if more than one bank is active (must precharge all active banks).
  4. DM, DQ, and DQS signals are all "Don't Care"/High-Z for operations shown.

## **SELF REFRESH**

The SELF REFRESH command is initiated when CKE is LOW. The differential clock should remain stable and meet  $t_{CKE}$  specifications at least  $1 \times t_{CK}$  after entering self refresh mode. The procedure for exiting self refresh requires a sequence of commands. First, the differential clock must be stable and meet  $t_{CK}$  specifications at least  $1 \times t_{CK}$  prior to CKE going back to HIGH. Once CKE is HIGH ( $t_{CKE} [MIN]$  has been satisfied with three clock registrations), the DDR2 SDRAM must have NOP or DESELECT commands issued for  $t_{XSNR}$ . A simple algorithm for meeting both refresh and DLL requirements is used to apply NOP or DESELECT commands for 200 clock cycles before applying any other command.

**Figure 68: Self Refresh**


- Notes:
1. Clock must be stable and meeting  $t_{CK}$  specifications at least  $1 \times t_{CK}$  after entering self refresh mode and at least  $1 \times t_{CK}$  prior to exiting self refresh mode.
  2. Self refresh exit is asynchronous; however,  $t_{XSNR}$  and  $t_{XSRD}$  timing starts at the first rising clock edge where CKE HIGH satisfies  $t_{ISXR}$ .
  3. CKE must stay HIGH until  $t_{XSRD}$  is met; however, if self refresh is being re-entered, CKE may go back LOW after  $t_{XSNR}$  is satisfied.
  4. NOP or DESELECT commands are required prior to exiting self refresh until state Tc0, which allows any nonREAD command.
  5.  $t_{XSNR}$  is required before any nonREAD command can be applied.
  6. ODT must be disabled and  $R_{TT}$  off ( $t_{AOFD}$  and  $t_{AOFDP}$  have been satisfied) prior to entering self refresh at state T1.
  7.  $t_{XSRD}$  (200 cycles of CK) is required before a READ command can be applied at state Td0.
  8. Device must be in the all banks idle state prior to entering self refresh mode.
  9. After self refresh has been entered,  $t_{CKE (MIN)}$  must be satisfied prior to exiting self refresh.
  10. Upon exiting SELF REFRESH, ODT must remain LOW until  $t_{XSRD}$  is satisfied.

## Power-Down Mode

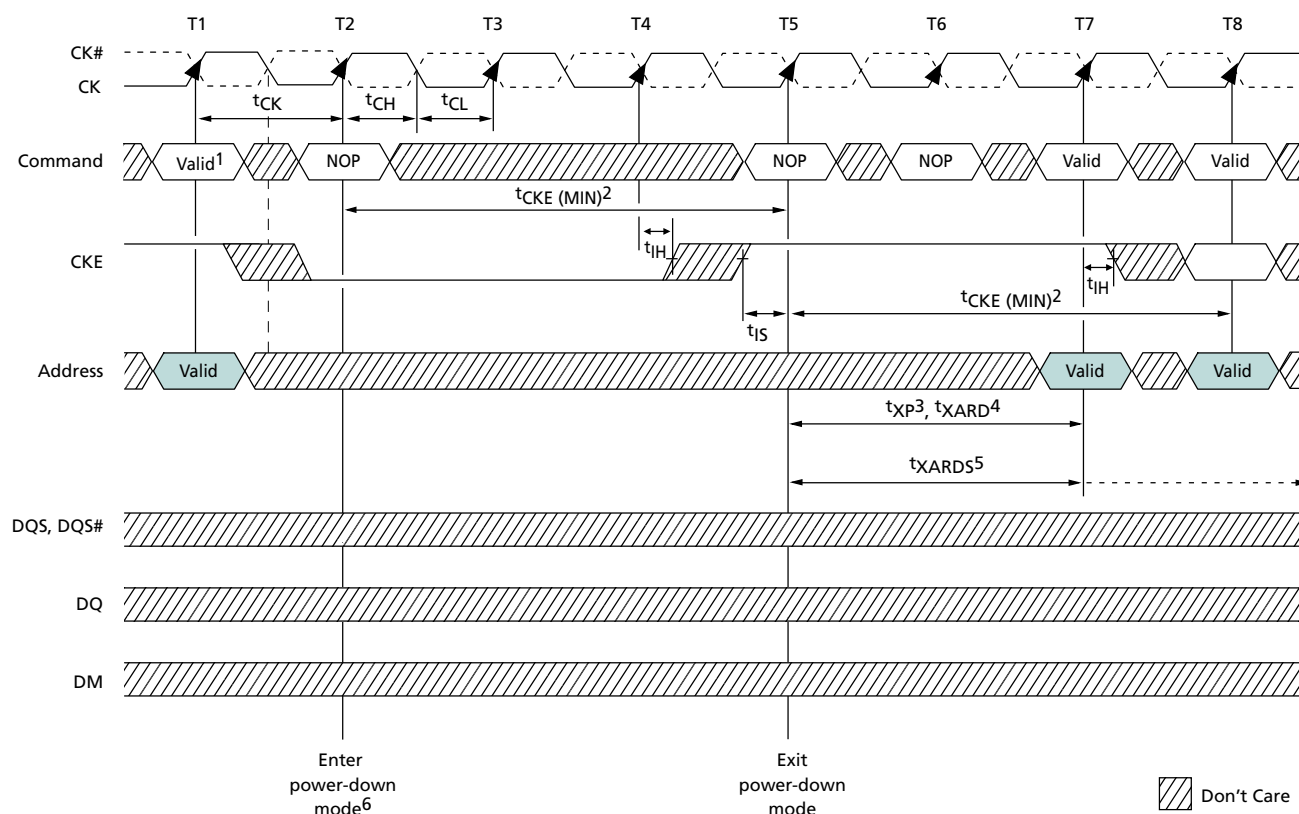
DDR2 SDRAM supports multiple power-down modes that allow significant power savings over normal operating modes. CKE is used to enter and exit different power-down modes. Power-down entry and exit timings are shown in Figure 69 (page 114). Detailed power-down entry conditions are shown in Figure 70 (page 116)–Figure 77 (page 119). Table 43 (page 115) is the CKE Truth Table.

DDR2 SDRAM requires CKE to be registered HIGH (active) at all times that an access is in progress—from the issuing of a READ or WRITE command until completion of the burst. Thus, a clock suspend is not supported. For READs, a burst completion is defined when the read postamble is satisfied; for WRITEs, a burst completion is defined when the write postamble and  $t_{WR}$  (WRITE-to-PRECHARGE command) or  $t_{WTR}$  (WRITE-to-READ command) are satisfied, as shown in Figure 72 (page 117) and Figure 73 (page 117) on Figure 73 (page 117). The number of clock cycles required to meet  $t_{WTR}$  is either two or  $t_{WTR}/t_{CK}$ , whichever is greater.

Power-down mode (see Figure 69 (page 114)) is entered when CKE is registered low coincident with an NOP or DESELECT command. CKE is not allowed to go LOW during a mode register or extended mode register command time, or while a READ or WRITE operation is in progress. If power-down occurs when all banks are idle, this mode is referred to as precharge power-down. If power-down occurs when there is a row active in any bank, this mode is referred to as active power-down. Entering power-down deactivates the input and output buffers, excluding CK, CK#, ODT, and CKE. For maximum power savings, the DLL is frozen during precharge power-down. Exiting active power-down requires the device to be at the same voltage and frequency as when it entered power-down. Exiting precharge power-down requires the device to be at the same voltage as when it entered power-down; however, the clock frequency is allowed to change (see Precharge Power-Down Clock Frequency Change (page 120)).

The maximum duration for either active or precharge power-down is limited by the refresh requirements of the device  $t_{RFC}$  (MAX). The minimum duration for power-down entry and exit is limited by the  $t_{CKE}$  (MIN) parameter. The following must be maintained while in power-down mode: CKE LOW, a stable clock signal, and stable power supply signals at the inputs of the DDR2 SDRAM. All other input signals are “Don’t Care” except ODT. Detailed ODT timing diagrams for different power-down modes are shown in Figure 82 (page 125)–Figure 87 (page 129).

The power-down state is synchronously exited when CKE is registered HIGH (in conjunction with a NOP or DESELECT command), as shown in Figure 69 (page 114).

**Figure 69: Power-Down**


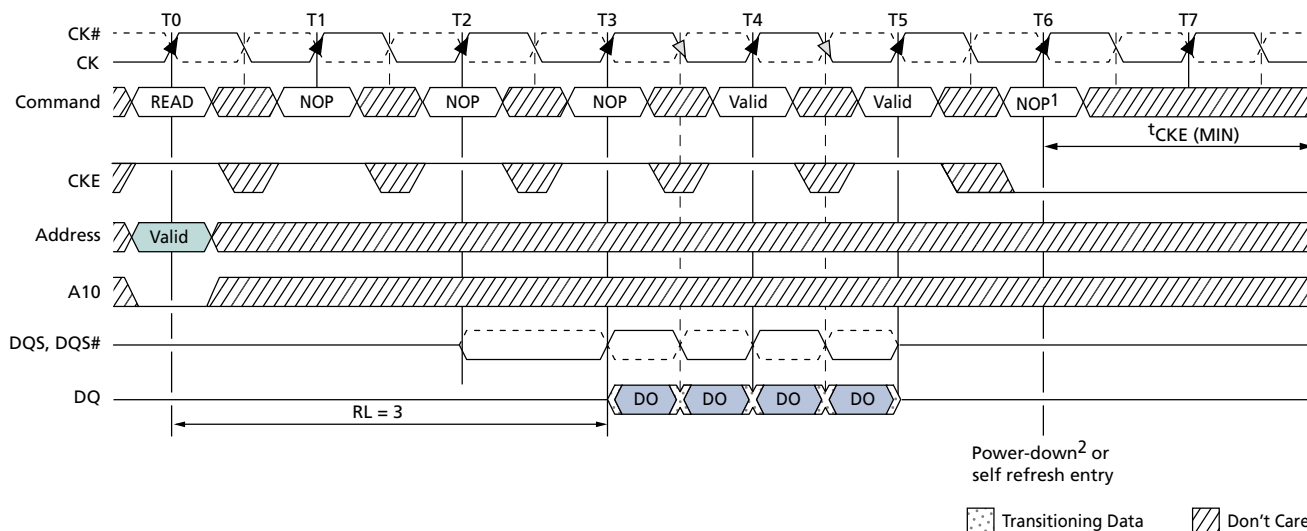
- Notes:
1. If this command is a PRECHARGE (or if the device is already in the idle state), then the power-down mode shown is precharge power-down. If this command is an ACTIVATE (or if at least one row is already active), then the power-down mode shown is active power-down.
  2.  $t_{CKE (MIN)}$  of three clocks means CKE must be registered on three consecutive positive clock edges. CKE must remain at the valid input level the entire time it takes to achieve the three clocks of registration. Thus, after any CKE transition, CKE may not transition from its valid level during the time period of  $t_{IS} + 2 \times t_{CK} + t_{IH}$ . CKE must not transition during its  $t_{IS}$  and  $t_{IH}$  window.
  3.  $t_{XP}$  timing is used for exit precharge power-down and active power-down to any non-READ command.
  4.  $t_{XARD}$  timing is used for exit active power-down to READ command if fast exit is selected via MR (bit 12 = 0).
  5.  $t_{XARDS}$  timing is used for exit active power-down to READ command if slow exit is selected via MR (bit 12 = 1).
  6. No column accesses are allowed to be in progress at the time power-down is entered. If the DLL was not in a locked state when CKE went LOW, the DLL must be reset after exiting power-down mode for proper READ operation.

**Table 43: Truth Table – CKE**

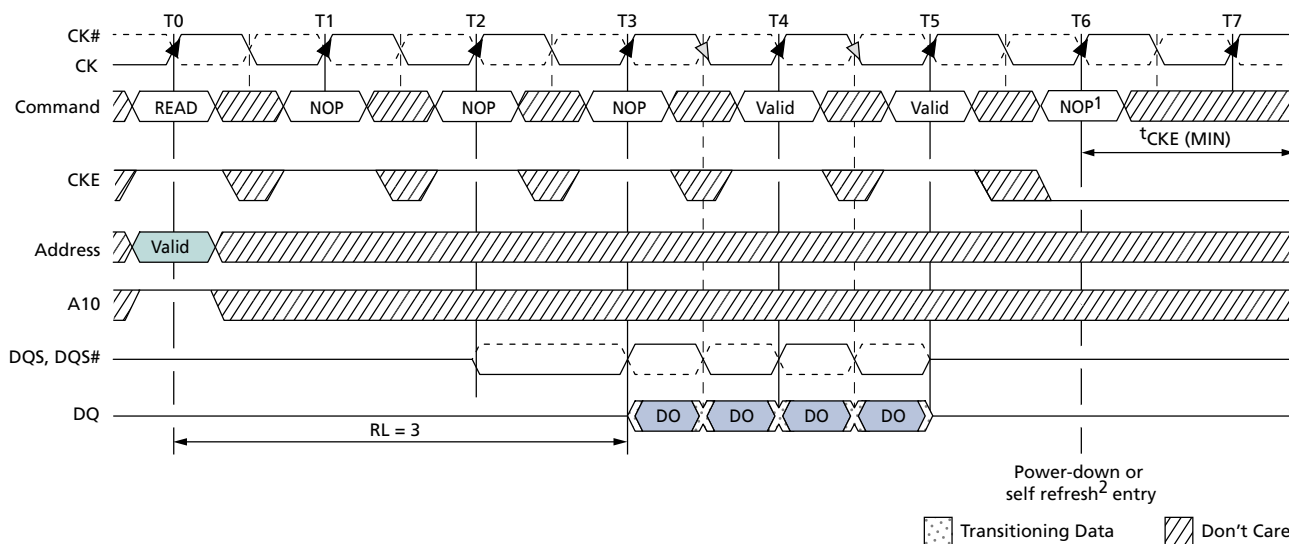
Notes 1–4 apply to the entire table

| Current State  | CKE                    |                   | Command (n)<br>CS#, RAS#, CAS#, WE# | Action (n)                 | Notes        |
|----------------|------------------------|-------------------|-------------------------------------|----------------------------|--------------|
|                | Previous Cycle (n - 1) | Current Cycle (n) |                                     |                            |              |
| Power-down     | L                      | L                 | X                                   | Maintain power-down        | 5, 6         |
|                | L                      | H                 | DESELECT or NOP                     | Power-down exit            | 7, 8         |
| Self refresh   | L                      | L                 | X                                   | Maintain self refresh      | 6            |
|                | L                      | H                 | DESELECT or NOP                     | Self refresh exit          | 7, 9, 10     |
| Bank(s) active | H                      | L                 | DESELECT or NOP                     | Active power-down entry    | 7, 8, 11, 12 |
| All banks idle | H                      | L                 | DESELECT or NOP                     | Precharge power-down entry | 7, 8, 11     |
|                | H                      | L                 | Refresh                             | Self refresh entry         | 10, 12, 13   |
|                | H                      | H                 | Shown in Table 36 (page 66)         |                            | 14           |

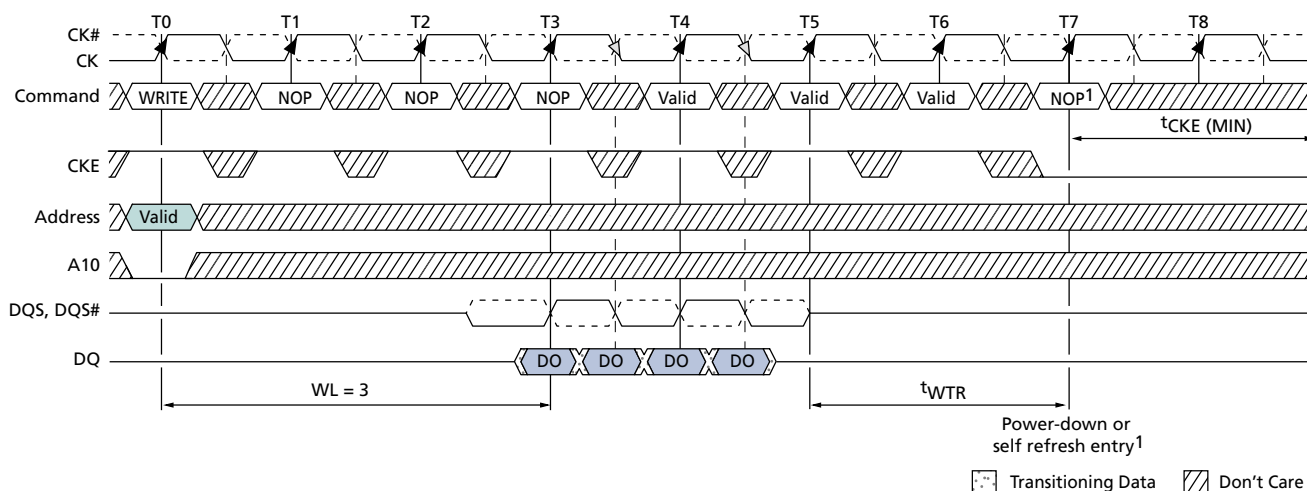
- Notes:
1. CKE (n) is the logic state of CKE at clock edge n; CKE (n - 1) was the state of CKE at the previous clock edge.
  2. Current state is the state of the DDR2 SDRAM immediately prior to clock edge n.
  3. Command (n) is the command registered at clock edge n, and action (n) is a result of command (n).
  4. The state of ODT does not affect the states described in this table. The ODT function is not available during self refresh (see ODT Timing (page 123) for more details and specific restrictions).
  5. Power-down modes do not perform any REFRESH operations. The duration of power-down mode is therefore limited by the refresh requirements.
  6. "X" means "Don't Care" (including floating around V<sub>REF</sub>) in self refresh and power-down. However, ODT must be driven high or low in power-down if the ODT function is enabled via EMR.
  7. All states and sequences not shown are illegal or reserved unless explicitly described elsewhere in this document.
  8. Valid commands for power-down entry and exit are NOP and DESELECT only.
  9. On self refresh exit, DESELECT or NOP commands must be issued on every clock edge occurring during the t<sub>XSNR</sub> period. READ commands may be issued only after t<sub>XSRD</sub> (200 clocks) is satisfied.
  10. Valid commands for self refresh exit are NOP and DESELECT only.
  11. Power-down and self refresh can not be entered while READ or WRITE operations, LOAD MODE operations, or PRECHARGE operations are in progress. See SELF REFRESH (page 111) and SELF REFRESH (page 72) for a list of detailed restrictions.
  12. Minimum CKE high time is t<sub>CKE</sub> = 3 × t<sub>CK</sub>. Minimum CKE LOW time is t<sub>CKE</sub> = 3 × t<sub>CK</sub>. This requires a minimum of 3 clock cycles of registration.
  13. Self refresh mode can only be entered from the all banks idle state.
  14. Must be a legal command, as defined in Table 36 (page 66).

**Figure 70: READ-to-Power-Down or Self Refresh Entry**


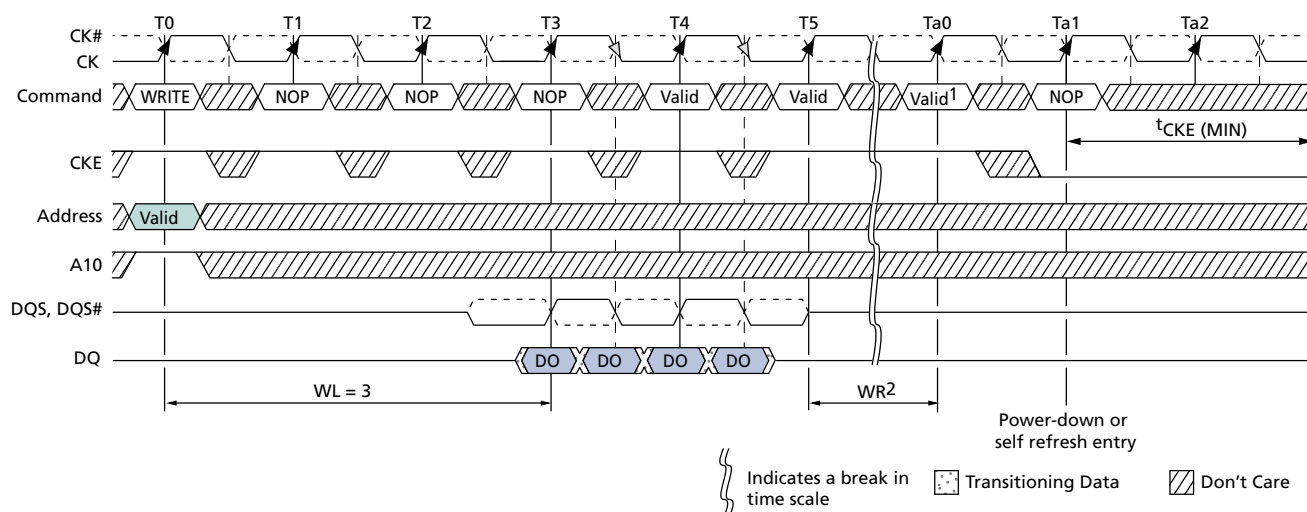
- Notes:
1. In the example shown, READ burst completes at T5; earliest power-down or self refresh entry is at T6.
  2. Power-down or self refresh entry may occur after the READ burst completes.

**Figure 71: READ with Auto Precharge-to-Power-Down or Self Refresh Entry**


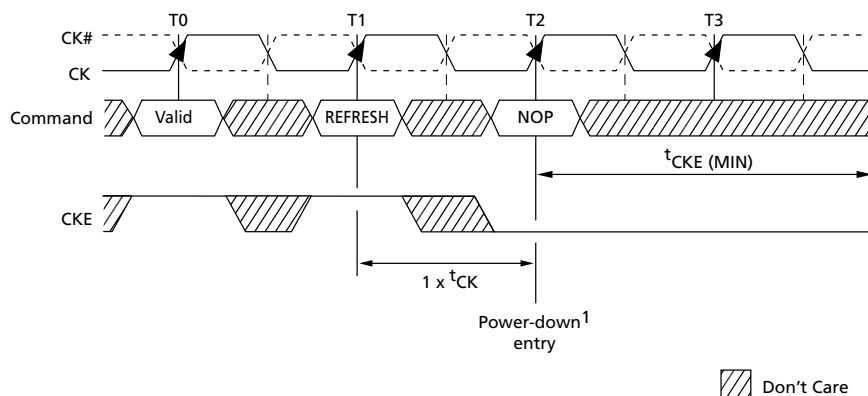
- Notes:
1. In the example shown, READ burst completes at T5; earliest power-down or self refresh entry is at T6.
  2. Power-down or self refresh entry may occur after the READ burst completes.

**Figure 72: WRITE-to-Power-Down or Self Refresh Entry**


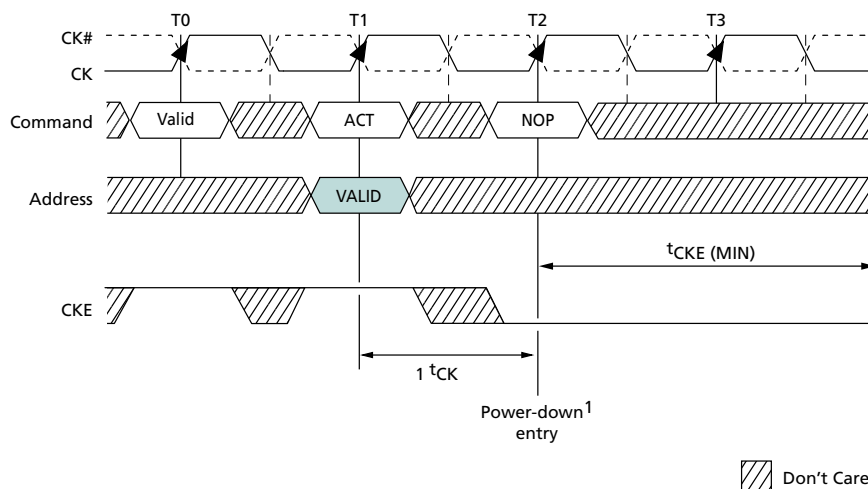
Note: 1. Power-down or self refresh entry may occur after the WRITE burst completes.

**Figure 73: WRITE with Auto Precharge-to-Power-Down or Self Refresh Entry**


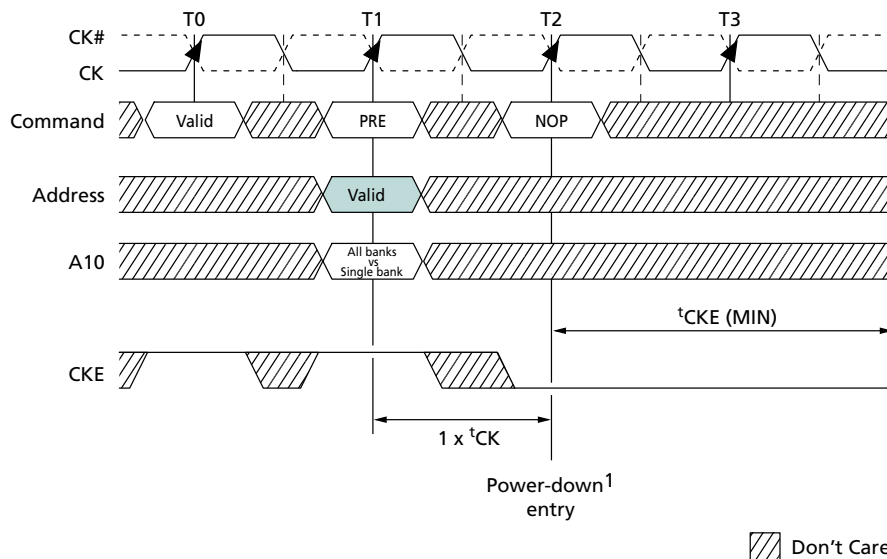
- Notes:
1. Internal PRECHARGE occurs at Ta0 when WR has completed; power-down entry may occur  $1 \times t_{CK}$  later at Ta1, prior to  $t_{RP}$  being satisfied.
  2. WR is programmed through MR9–MR11 and represents  $(t_{WR} \text{ [MIN]} \text{ ns}/t_{CK})$  rounded up to next integer  $t_{CK}$ .

**Figure 74: REFRESH Command-to-Power-Down Entry**


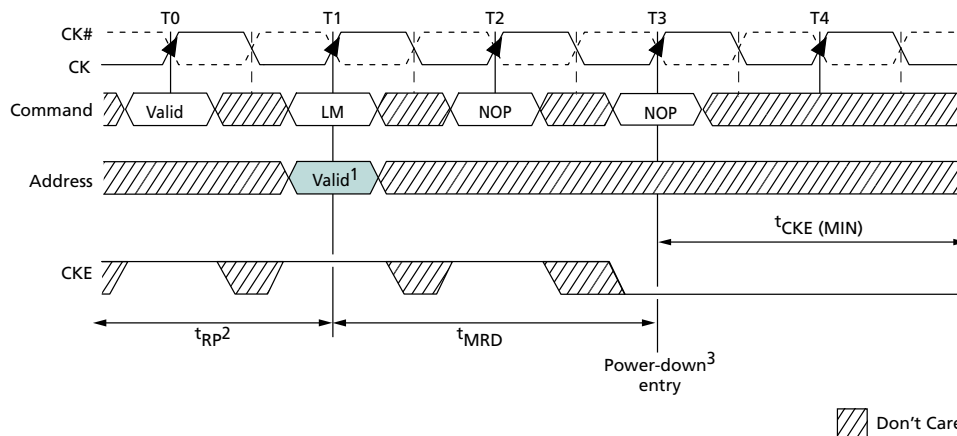
Note: 1. The earliest precharge power-down entry may occur is at T2, which is 1 x t<sub>CK</sub> after the REFRESH command. Precharge power-down entry occurs prior to t<sub>RFC</sub> (MIN) being satisfied.

**Figure 75: ACTIVATE Command-to-Power-Down Entry**


Note: 1. The earliest active power-down entry may occur is at T2, which is 1 x t<sub>CK</sub> after the ACTIVATE command. Active power-down entry occurs prior to t<sub>RCD</sub> (MIN) being satisfied.

**Figure 76: PRECHARGE Command-to-Power-Down Entry**


Note: 1. The earliest precharge power-down entry may occur is at T2, which is  $1 \times t_{CK}$  after the PRECHARGE command. Precharge power-down entry occurs prior to  $t_{RP} (MIN)$  being satisfied.

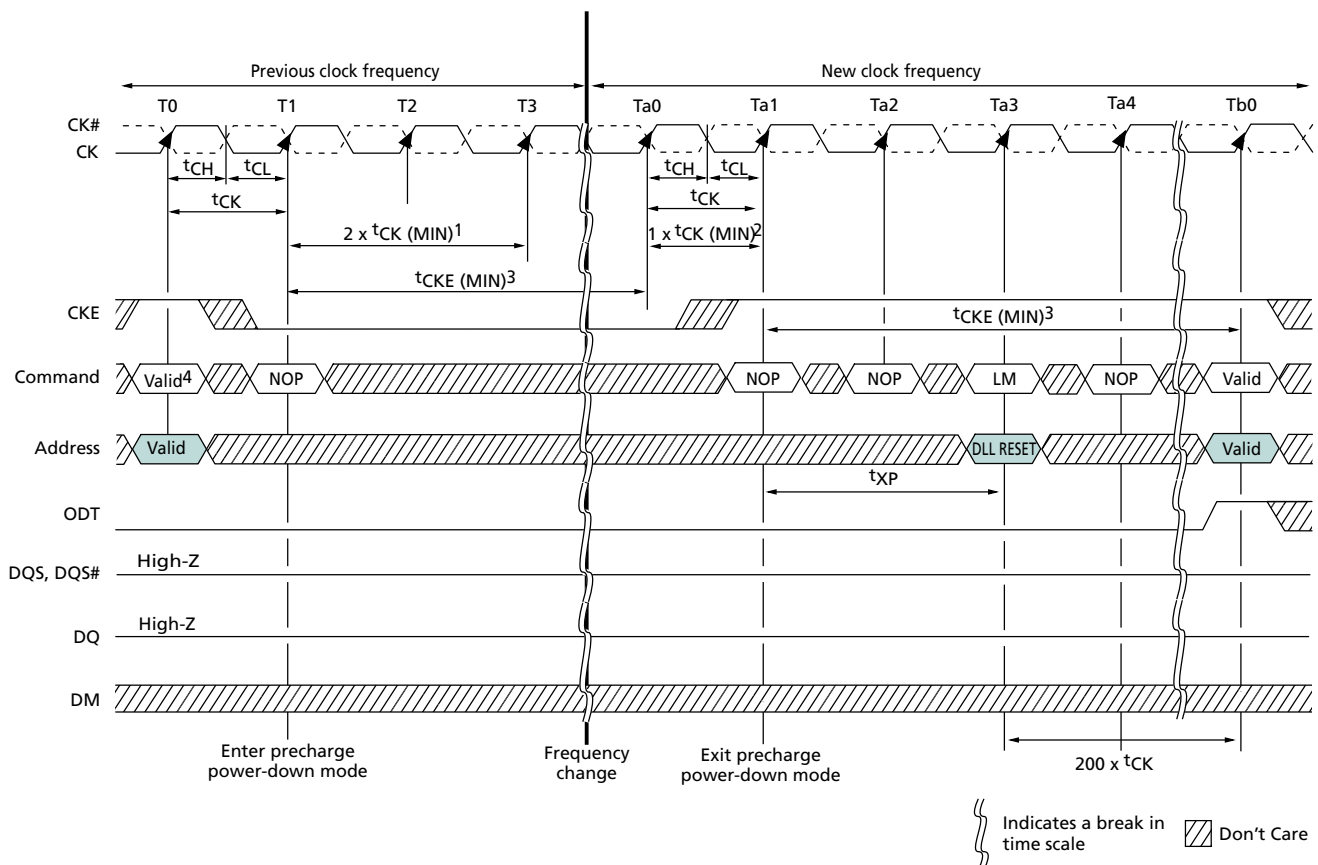
**Figure 77: LOAD MODE Command-to-Power-Down Entry**


- Notes:
1. Valid address for LM command includes MR, EMR, EMR(2), and EMR(3) registers.
  2. All banks must be in the precharged state and  $t_{RP}$  met prior to issuing LM command.
  3. The earliest precharge power-down entry is at T3, which is after  $t_{MRD}$  is satisfied.

## Precharge Power-Down Clock Frequency Change

When the DDR2 SDRAM is in precharge power-down mode, ODT must be turned off and CKE must be at a logic LOW level. A minimum of two differential clock cycles must pass after CKE goes LOW before clock frequency may change. The device input clock frequency is allowed to change only within minimum and maximum operating frequencies specified for the particular speed grade. During input clock frequency change, ODT and CKE must be held at stable LOW levels. When the input clock frequency is changed, new stable clocks must be provided to the device before precharge power-down may be exited, and DLL must be reset via MR after precharge power-down exit. Depending on the new clock frequency, additional LM commands might be required to adjust the CL, WR, AL, and so forth. Depending on the new clock frequency, an additional LM command might be required to appropriately set the WR MR9, MR10, MR11. During the DLL relock period of 200 cycles, ODT must remain off. After the DLL lock time, the DRAM is ready to operate with a new clock frequency.

**Figure 78: Input Clock Frequency Change During Precharge Power-Down Mode**



- Notes:
1. A minimum of  $2 \times t_{CK}$  is required after entering precharge power-down prior to changing clock frequencies.
  2. When the new clock frequency has changed and is stable, a minimum of  $1 \times t_{CK}$  is required prior to exiting precharge power-down.

3. Minimum CKE high time is  $t_{CKE} = 3 \times t_{CK}$ . Minimum CKE LOW time is  $t_{CKE} = 3 \times t_{CK}$ . This requires a minimum of three clock cycles of registration.
4. If this command is a PRECHARGE (or if the device is already in the idle state), then the power-down mode shown is precharge power-down, which is required prior to the clock frequency change.

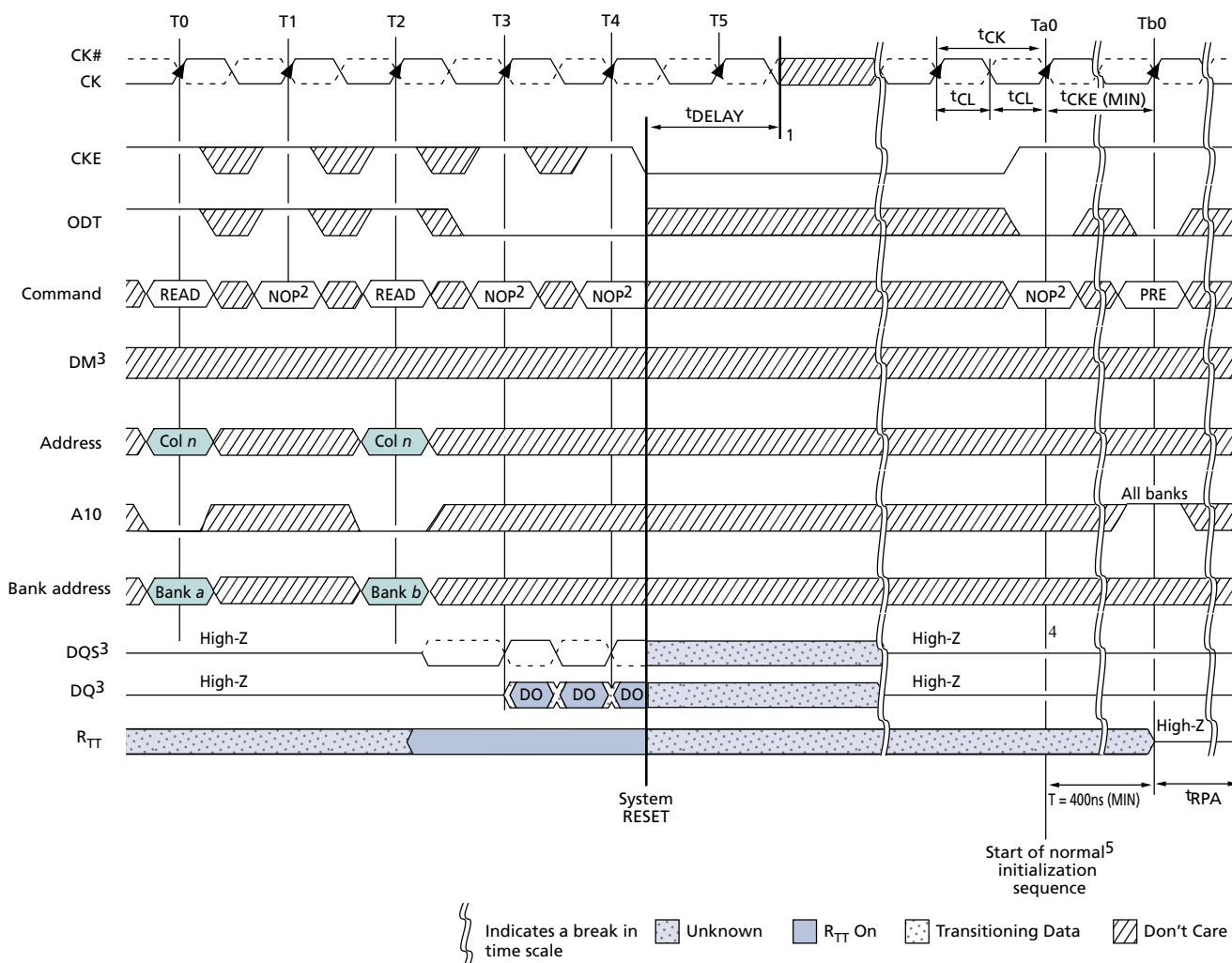
## Reset

### CKE Low Anytime

DDR2 SDRAM applications may go into a reset state anytime during normal operation. If an application enters a reset condition, CKE is used to ensure the DDR2 SDRAM device resumes normal operation after reinitializing. All data will be lost during a reset condition; however, the DDR2 SDRAM device will continue to operate properly if the following conditions outlined in this section are satisfied.

The reset condition defined here assumes all supply voltages ( $V_{DD}$ ,  $V_{DDQ}$ ,  $V_{DDL}$ , and  $V_{REF}$ ) are stable and meet all DC specifications prior to, during, and after the RESET operation. All other input balls of the DDR2 SDRAM device are a “Don’t Care” during RESET with the exception of CKE.

If CKE asynchronously drops LOW during any valid operation (including a READ or WRITE burst), the memory controller must satisfy the timing parameter  $t_{DELAY}$  before turning off the clocks. Stable clocks must exist at the CK, CK# inputs of the DRAM before CKE is raised HIGH, at which time the normal initialization sequence must occur (see Initialization). The DDR2 SDRAM device is now ready for normal operation after the initialization sequence. Figure 79 (page 122) shows the proper sequence for a RESET operation.

**Figure 79: RESET Function**


- Notes:
1.  $V_{DD}$ ,  $V_{DDL}$ ,  $V_{DDQ}$ ,  $V_{TT}$ , and  $V_{REF}$  must be valid at all times.
  2. Either NOP or DESELECT command may be applied.
  3. DM represents DM for x4/x8 configuration and UDM, LDM for x16 configuration. DQS represents DQS, DQS#, UDQS, UDQS#, LDQS, LDQS#, RDQS, and RDQS# for the appropriate configuration (x4, x8, x16).
  4. In certain cases where a READ cycle is interrupted, CKE going HIGH may result in the completion of the burst.
  5. Initialization timing is shown in Figure 42 (page 83).

## ODT Timing

Once a 12ns delay ( $t_{MOD}$ ) has been satisfied, and after the ODT function has been enabled via the EMR LOAD MODE command, ODT can be accessed under two timing categories. ODT will operate either in synchronous mode or asynchronous mode, depending on the state of CKE. ODT can switch anytime except during self refresh mode and a few clocks after being enabled via EMR, as shown in Figure 80 (page 124).

There are two timing categories for ODT—turn-on and turn-off. During active mode (CKE HIGH) and fast-exit power-down mode (any row of any bank open, CKE LOW, MR[12 = 0]),  $t_{AOND}$ ,  $t_{AON}$ ,  $t_{AOFD}$ , and  $t_{AOF}$  timing parameters are applied, as shown in Figure 82 (page 125).

During slow-exit power-down mode (any row of any bank open, CKE LOW, MR[12] = 1) and precharge power-down mode (all banks/rows precharged and idle, CKE LOW),  $t_{AONPD}$  and  $t_{AOFPD}$  timing parameters are applied, as shown in Figure 83 (page 126).

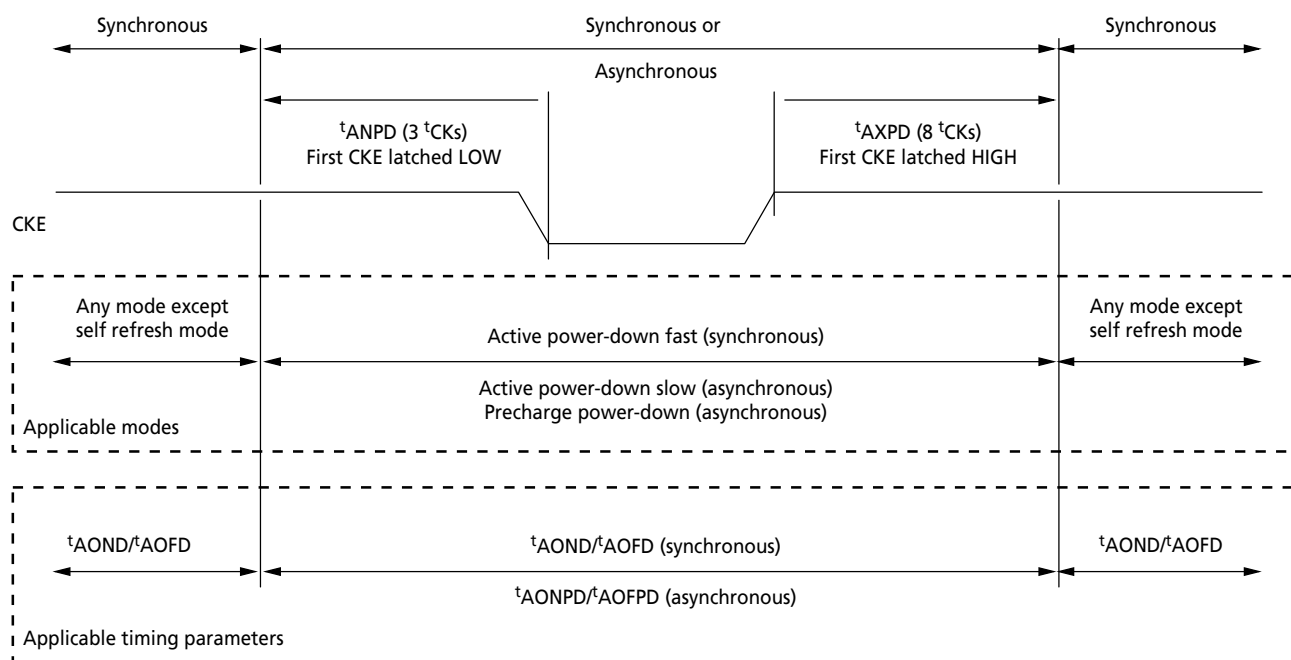
ODT turn-off timing, prior to entering any power-down mode, is determined by the parameter  $t_{ANPD}$  (MIN), as shown in Figure 84 (page 126). At state T2, the ODT HIGH signal satisfies  $t_{ANPD}$  (MIN) prior to entering power-down mode at T5. When  $t_{ANPD}$  (MIN) is satisfied,  $t_{AOFD}$  and  $t_{AOF}$  timing parameters apply. Figure 84 (page 126) also shows the example where  $t_{ANPD}$  (MIN) is **not** satisfied because ODT HIGH does not occur until state T3. When  $t_{ANPD}$  (MIN) is **not** satisfied,  $t_{AOFPD}$  timing parameters apply.

ODT turn-on timing prior to entering any power-down mode is determined by the parameter  $t_{ANPD}$ , as shown in Figure 85 (page 127). At state T2, the ODT HIGH signal satisfies  $t_{ANPD}$  (MIN) prior to entering power-down mode at T5. When  $t_{ANPD}$  (MIN) is satisfied,  $t_{AOND}$  and  $t_{AON}$  timing parameters apply. Figure 85 (page 127) also shows the example where  $t_{ANPD}$  (MIN) is **not** satisfied because ODT HIGH does not occur until state T3. When  $t_{ANPD}$  (MIN) is **not** satisfied,  $t_{AONPD}$  timing parameters apply.

ODT turn-off timing after exiting any power-down mode is determined by the parameter  $t_{AXPD}$  (MIN), as shown in Figure 86 (page 128). At state Ta1, the ODT LOW signal satisfies  $t_{AXPD}$  (MIN) after exiting power-down mode at state T1. When  $t_{AXPD}$  (MIN) is satisfied,  $t_{AOFD}$  and  $t_{AOF}$  timing parameters apply. Figure 86 (page 128) also shows the example where  $t_{AXPD}$  (MIN) is **not** satisfied because ODT LOW occurs at state Ta0. When  $t_{AXPD}$  (MIN) is not satisfied,  $t_{AOFPD}$  timing parameters apply.

ODT turn-on timing after exiting either slow-exit power-down mode or precharge power-down mode is determined by the parameter  $t_{AXPD}$  (MIN), as shown in Figure 87 (page 129). At state Ta1, the ODT HIGH signal satisfies  $t_{AXPD}$  (MIN) after exiting power-down mode at state T1. When  $t_{AXPD}$  (MIN) is satisfied,  $t_{AOND}$  and  $t_{AON}$  timing parameters apply. Figure 87 (page 129) also shows the example where  $t_{AXPD}$  (MIN) is not satisfied because ODT HIGH occurs at state Ta0. When  $t_{AXPD}$  (MIN) is not satisfied,  $t_{AONPD}$  timing parameters apply.

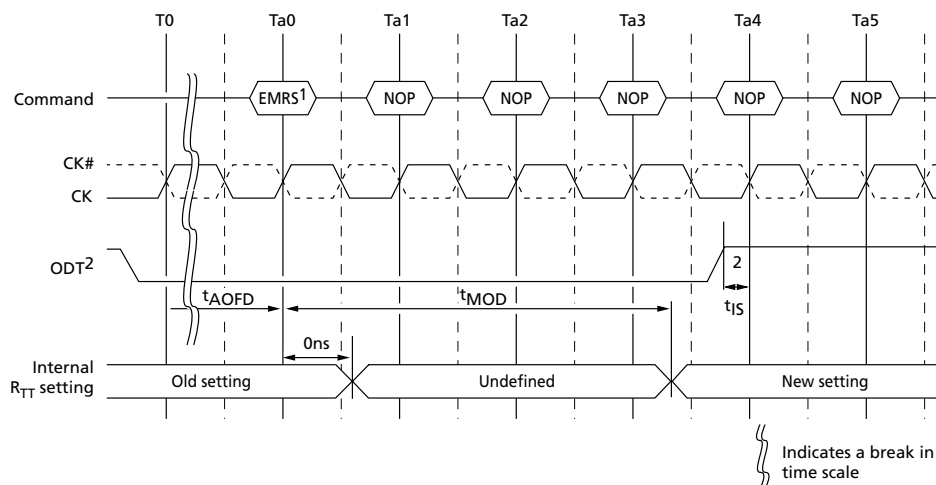
**Figure 80: ODT Timing for Entering and Exiting Power-Down Mode**



## MRS Command to ODT Update Delay

During normal operation, the value of the effective termination resistance can be changed with an EMRS set command.  $t_{MOD}$  (MAX) updates the  $R_{TT}$  setting.

**Figure 81: Timing for MRS Command to ODT Update Delay**



- Notes:
1. The LM command is directed to the mode register, which updates the information in EMR (A6, A2), that is,  $R_{TT}$  (nominal).
  2. To prevent any impedance glitch on the channel, the following conditions must be met:  $t_{AOFD}$  must be met before issuing the LM command; ODT must remain LOW for the entire duration of the  $t_{MOD}$  window until  $t_{MOD}$  is met.

**Figure 82: ODT Timing for Active or Fast-Exit Power-Down Mode**

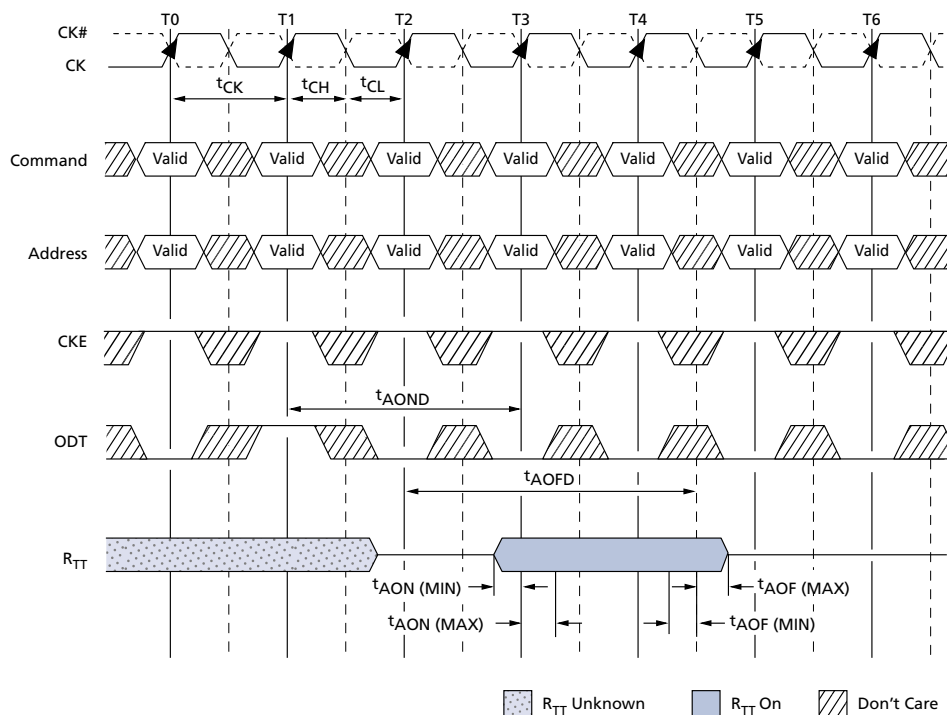


Figure 83: ODT Timing for Slow-Exit or Precharge Power-Down Modes

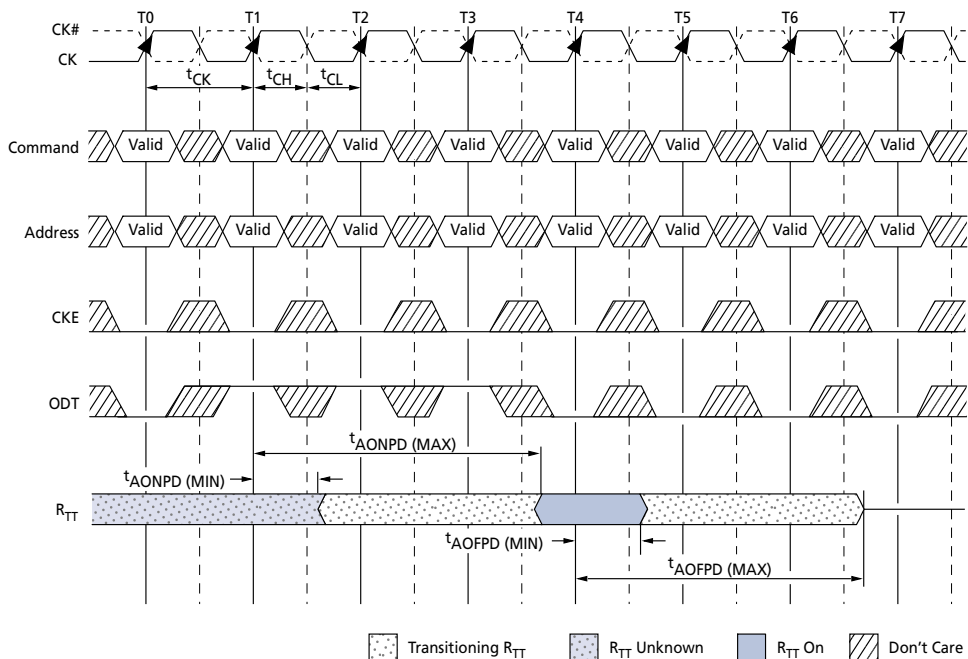
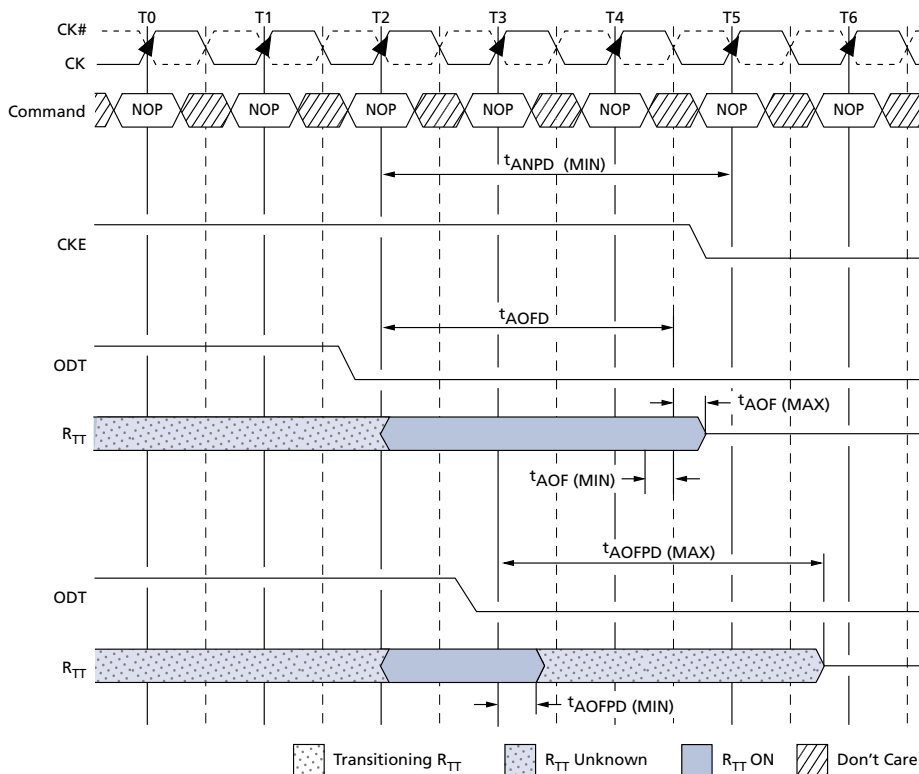
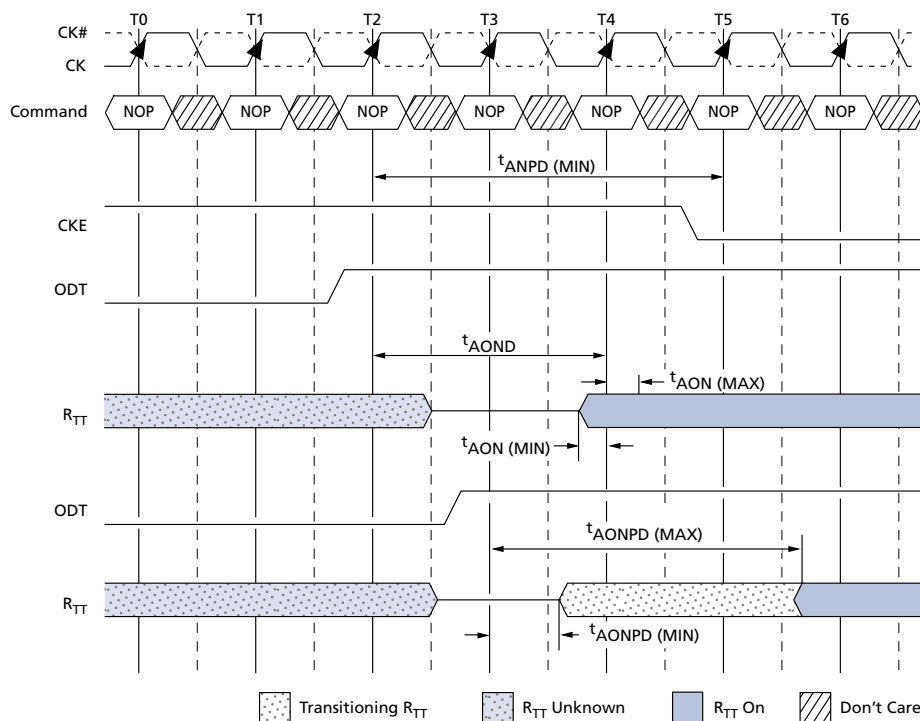


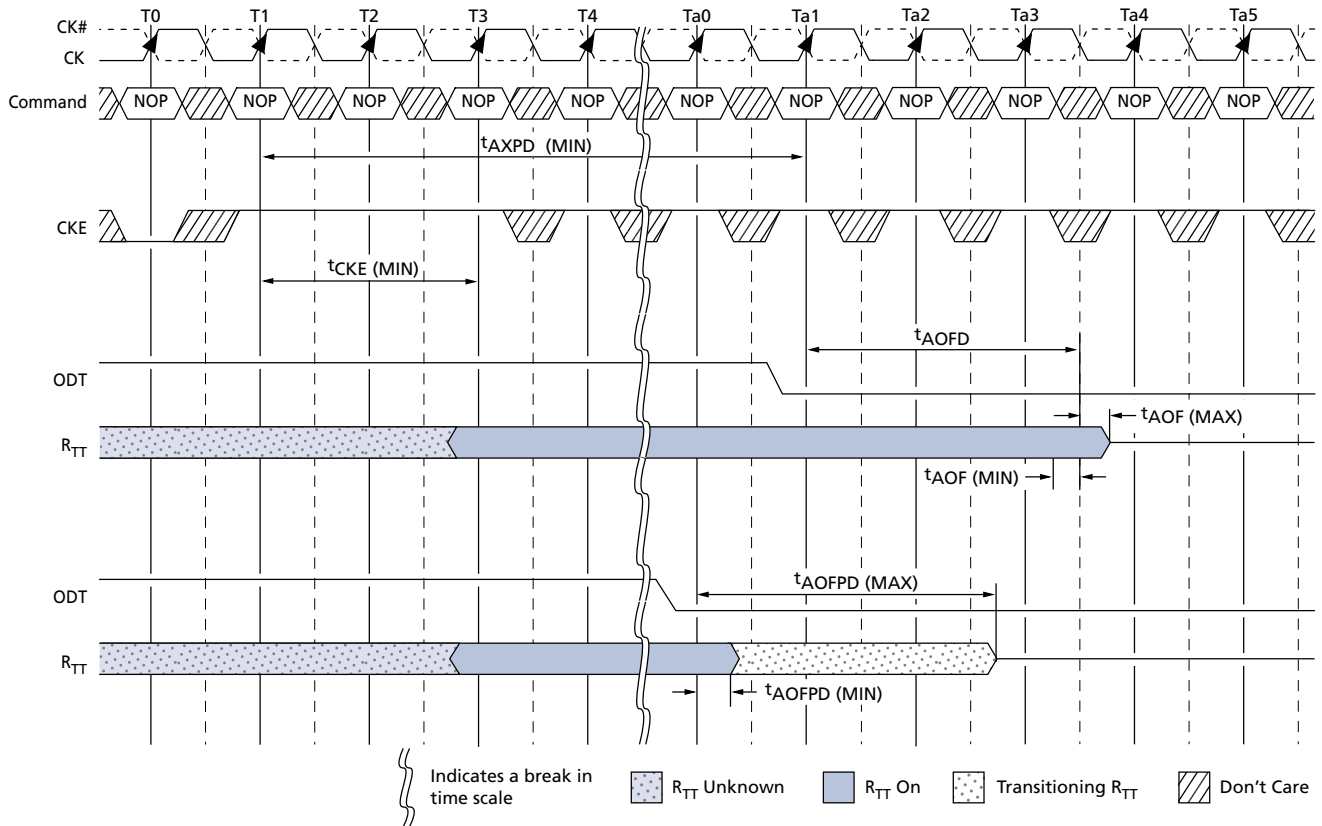
Figure 84: ODT Turn-Off Timings When Entering Power-Down Mode



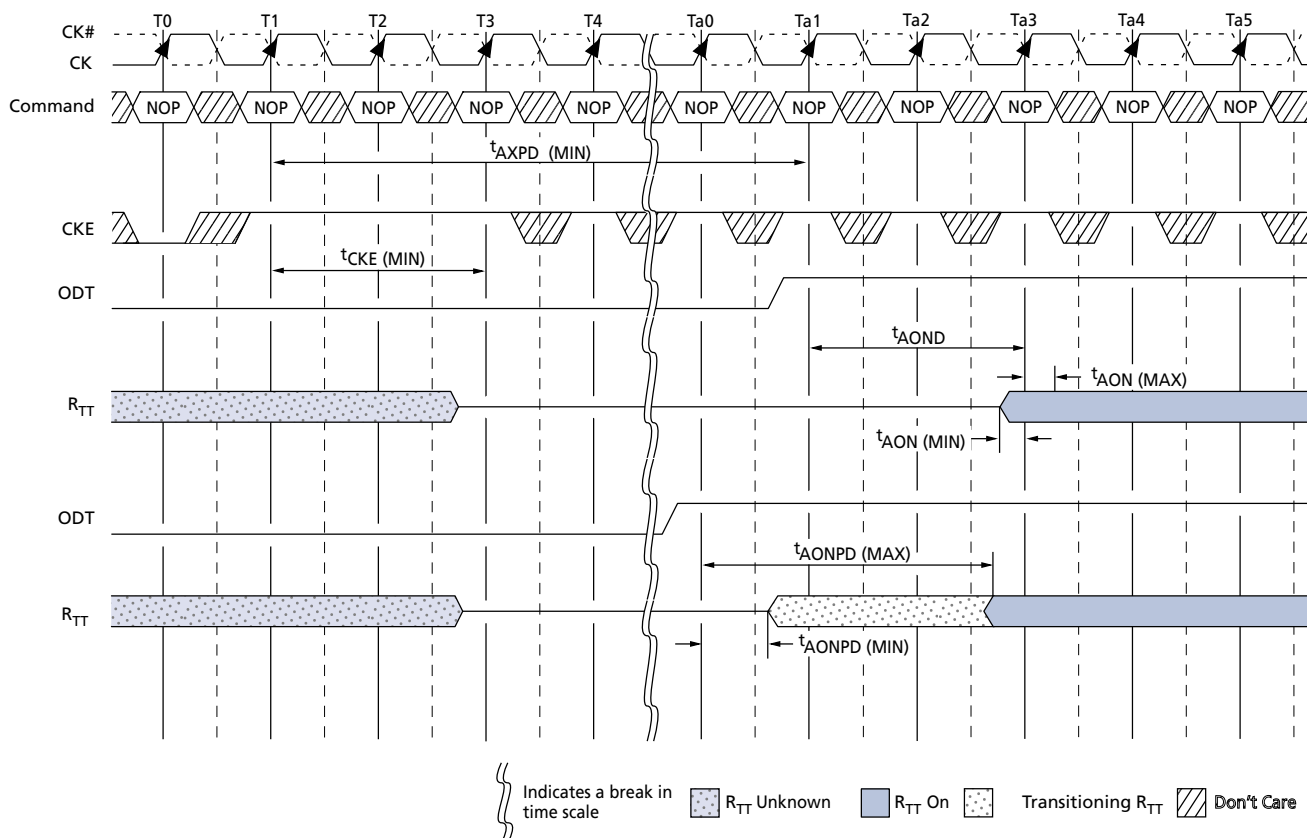
**Figure 85: ODT Turn-On Timing When Entering Power-Down Mode**



**Figure 86: ODT Turn-Off Timing When Exiting Power-Down Mode**



**Figure 87: ODT Turn-On Timing When Exiting Power-Down Mode**



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